Introduction

minimal power consumption using the most advanced techniques for power saving (DPTC, DVFS, power gating, clock gating). With 90 nm technology and dual-Vt transistors (two threshold voltages), the MCIMX31 provides the optimal performance versus leakage current balance.

The performance of the MCIMX31 is boosted by a multi-level cache system, and features peripheral devices such as an MPEG-4 Hardware Encoder (VGA, 30 fps), an Autonomous Image Processing Unit, a Vector Floating Point (VFP11) co-processor, and a RISC-based SDMA controller.

The MCIMX31 supports connections to various types of external memories, such as DDR, NAND Flash, NOR Flash, SDRAM, and SRAM. The MCIMX31 can be connected to a variety of external devices using technology, such as high-speed USB2.0 OTG, ATA, MMC/SDIO, and compact flash.

1.1 Features

The MCIMX31 is designed for the high-tier, mid-tier smartphone markets, and portable media players. They provide low-power solutions for high-performance demanding multimedia and graphics applications.

The MCIMX31 is built around the ARM11 MCU core and implemented in the 90 nm technology.

The systems include the following features:

- Multimedia and floating-point hardware acceleration supporting:
 - MPEG-4 real-time encode of up to VGA at 30 fps
 - MPEG-4 real-time video post-processing of up to VGA at 30 fps
 - Video conference call of up to QCIF-30 fps (decoder in software), 128 kbps
 - Video streaming (playback) of up to VGA-30 fps, 384 kbps
 - 3D graphics and other applications acceleration with the ARM[®] tightly-coupled Vector Floating Point co-processor
 - On-the-fly video processing that reduces system memory load (for example, the power-efficient viewfinder application with no involvement of either the memory system or the ARM CPU)
- Advanced power management
 - Dynamic voltage and frequency scaling
 - Multiple clock and power domains
 - Independent gating of power domains
- Multiple communication and expansion ports including a fast parallel interface to an external graphic accelerator (supporting major graphic accelerator vendors)
- Security

1.2 Ordering Information

Table 1 provides the ordering information for the MCIMX31.

Table 1. Ordering Information

Part Number	Silicon Revision ^{1, 2, 3,4}	Device Mask	Operating Temperature Range (°C)	Package ⁵
MCIMX31VKN5	1.15	2L38W and 3L38W	0 to 70	
MCIMX31LVKN5	1.15	2L38W and 3L38W	0 to 70	14 x 14 mm, 0.5 mm pitch,
MCIMX31VKN5B	1.2	M45G	0 to 70	MAPBGA-457, Case 1581
MCIMX31LVKN5B	1.2	M45G	0 to 70	Odse 1501
MCIMX31VKN5C	2.0	M91E	0 to 70	
MCIMX31LVKN5C	2.0	M91E	0 to 70	14 x 14 mm, 0.5 mm pitch,
MCIMX31CVKN5C	2.0	M91E	-40 to 85	MAPBGA-457, Case 1581
MCIMX31LCVKN5C	2.0	M91E	-40 to 85	Odse 1501
MCIMX31VMN5C	2.0	M91E	0 to 70	19 x 19 mm,
MCIMX31LVMN5C	2.0	M91E	0 to 70	0.8 mm pitch, Case 1931

Information on reading the silicon revision register can be found in the IC Identification (IIM) chapter of the Reference Manual, see Section 7, "Product Documentation."

1.2.1 Feature Differences Between Mask Sets

The following is a summary of differences between silicon Revision 2.0, mask set M91E, and previous revisions of silicon. A complete list of these differences is given in Table 72.

- Extended operating temperature range is available: –40°C to 85°C
- Supply current information changes, as shown in Table 13 and Table 14
- FUSE_VDD supply voltage is floated or grounded during read operation
- No restriction on PLL versus core supply voltage
- Operating frequency as shown in Table 8.

² Errata and fix information of the various mask sets can be found in the standard MCIMX31 Chip Errata, see Section 7, "Product Documentation."

Changes in output buffer characteristics can be found in the I/O Setting Exceptions and Special Pad Descriptions table in the Reference Manual, see Section 7, "Product Documentation."

⁴ JTAG functionality is not tested nor guaranteed at -40°C.

⁵ Case 1581 and 1931 are RoHS compliant, lead-free, MSL = 3, and solders at 260° C.

1.3 Block Diagram

Figure 1 shows the MCIMX31 simplified interface block diagram.

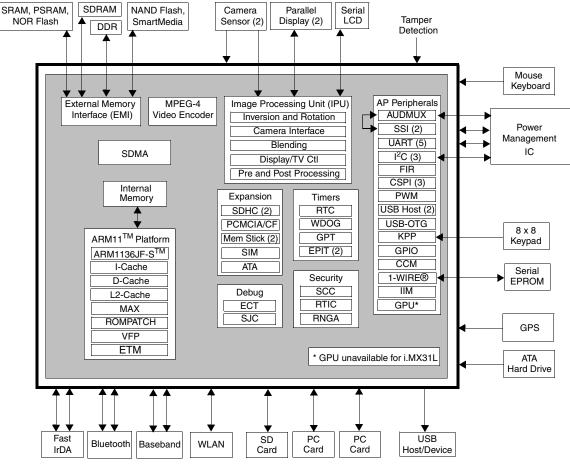


Figure 1. MCIMX31 Simplified Interface Block Diagram

2 Functional Description and Application Information

2.1 ARM11 Microprocessor Core

The CPU of the MCIMX31 is the ARM1136JF-S core based on the ARM v6 architecture. It supports the ARM Thumb[®] instruction sets, features Jazelle[®] technology (which enables direct execution of Java byte codes), and a range of SIMD DSP instructions that operate on 16-bit or 8-bit data values in 32-bit registers.

The ARM1136JF-S processor core features:

- Integer unit with integral EmbeddedICE[™] logic
- Eight-stage pipeline
- Branch prediction with return stack
- Low-interrupt latency

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- Instruction and data memory management units (MMUs), managed using micro TLB structures backed by a unified main TLB
- Instruction and data L1 caches, including a non-blocking data cache with Hit-Under-Miss
- Virtually indexed/physically addressed L1 caches
- 64-bit interface to both L1 caches
- Write buffer (bypassable)
- High-speed Advanced Micro Bus Architecture (AMBA)TM L2 interface
- Vector Floating Point co-processor (VFP) for 3D graphics and other floating-point applications hardware acceleration
- ETM[™] and JTAG-based debug support

2.1.1 Memory System

The ARM1136JF-S complex includes 16 KB Instruction and 16 KB Data L1 caches. It connects to the MCIMX31 L2 unified cache through 64-bit instruction (read-only), 64-bit data read/write (bi-directional), and 64-bit data write interfaces.

The embedded 16K SRAM can be used for audio streaming data to avoid external memory accesses for the low-power audio playback, for security, or for other applications. There is also a 32-KB ROM for bootstrap code and other frequently-used code and data.

A ROM patch module provides the ability to patch the internal ROM. It can also initiate an external boot by overriding the boot reset sequence by a jump to a configurable address.

Table 2 shows information about the MCIMX31 core in tabular form.

Table 2. MCIMX31 Core

Core	Core	Brief Description	Integrated Memory
Acronym	Name		Includes
ARM11 or ARM1136	ARM1136 Platform	The ARM1136™ Platform consists of the ARM1136JF-S core, the ETM real-time debug modules, a 6 x 5 multi-layer AHB crossbar switch (MAX), and a Vector Floating Processor (VFP). The MCIMX31 provides a high-performance ARM11 microprocessor core and highly integrated system functions. The ARM Application Processor (AP) and other subsystems address the needs of the personal, wireless, and portable product market with integrated peripherals, advanced processor core, and power management capabilities.	 16 Kbyte Instruction Cache 16 Kbyte Data Cache 128 Kbyte L2 Cache 32 Kbyte ROM 16 Kbyte RAM

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2.2 Module Inventory

Table 3 shows an alphabetical listing of the modules in the multimedia applications processor. For extended descriptions of the modules, see the reference manual. A cross-reference is provided to the electrical specifications and timing information for each module with external signal connections.

Table 3. Digital and Analog Modules

Block Mnemonic	Block Name	Functional Grouping	Brief Description	Section/ Page
1-Wire®	1-Wire Interface	Connectivity Peripheral	The 1-Wire module provides bi-directional communication between the ARM11 core and external 1-Wire devices.	4.3.4/26
ATA	Advanced Technology (AT) Attachment	Connectivity Peripheral	The ATA block is an AT attachment host interface. It is designed to interface with IDE hard disc drives and ATAPI optical disc drives.	4.3.5/27
AUDMUX	Digital Audio Multiplexer	Multimedia Peripheral	The AUDMUX interconnections allow multiple, simultaneous audio/voice/data flows between the ports in point-to-point or point-to-multipoint configurations.	
CAMP	Clock Amplifier Module	Clock	The CAMP converts a square wave/sinusoidal input into a rail-to-rail square wave. The output of CAMP feeds the predivider.	4.3.3/25
ССМ	Clock Control Module	Clock	The CCM provides clock, reset, and power management control for the MCIMX31.	_
CSPI	Configurable Serial Peripheral Interface (x 3)	Connectivity Peripheral	The CSPI is equipped with data FIFOs and is a master/slave configurable serial peripheral interface module, capable of interfacing to both SPI master and slave devices.	
DPLL	Digital Phase Lock Loop	Clock	The DPLLs produce high-frequency on-chip clocks with low frequency and phase jitters. Note: External clock sources provide the reference frequencies.	
ECT	Embedded Cross Trigger	Debug	The ECT is composed of three CTIs (Cross Trigger Interface) and one CTM (Cross Trigger Matrix—key in the multi-core and multi-peripheral debug strategy.	_
EMI	External Memory Interface	Memory Interface (EMI)	The EMI includes • Multi-Master Memory Interface (M3IF) • Enhanced SDRAM Controller (ESDCTL) • NAND Flash Controller (NFC) • Wireless External Interface Module (WEIM)	4.3.9.3/46, 4.3.9.1/38, 4.3.9.2/41
EPIT	Enhanced Periodic Interrupt Timer	Timer Peripheral	The EPIT is a 32-bit "set and forget" timer which starts counting after the EPIT is enabled by software. It is capable of providing precise interrupts at regular intervals with minimal processor intervention.	_
ETM	Embedded Trace Macrocell	Debug/Trace	The ETM (from ARM, Ltd.) supports real-time instruction and data tracing by way of ETM auxiliary I/O port.	4.3.10/54
FIR	Fast InfraRed Interface	Connectivity Peripheral	This FIR is capable of establishing a 0.576 Mbit/s, 1.152 Mbit/s or 4 Mbit/s half duplex link via a LED and IR detector. It supports 0.576 Mbit/s, 1.152 Mbit/s medium infrared (MIR) physical layer protocol and 4Mbit/s fast infrared (FIR) physical layer protocol defined by IrDA, Rev. 1.4.	4.3.11/55

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Table 3. Digital and Analog Modules (continued)

Block Mnemonic	Block Name	Functional Grouping	Brief Description	Section/ Page
Fusebox	Fusebox	ROM	The Fusebox is a ROM that is factory configured by Freescale.	4.3.12/55 See also Table 11
GPIO	General Purpose I/O Module	Pins	The GPIO provides several groups of 32-bit bidirectional, general purpose I/O. This peripheral provides dedicated general-purpose signals that can be configured as either inputs or outputs.	_
GPT	General Purpose Timer	Timer Peripheral	The GPT is a multipurpose module used to measure intervals or generate periodic output.	
GPU	Graphics Processing Unit	Multimedia Peripheral	The GPU provides hardware acceleration for 2D and 3D graphics algorithms.	_
I ² C	Inter IC Communication	Connectivity Peripheral	The I ² C provides serial interface for controlling the Sensor Interface and other external devices. Data rates of up to 100 Kbits/s are supported.	4.3.13/56
IIM	IC Identification Module	ID	The IIM provides an interface for reading device identification.	_
IPU	Image Processing Unit	Multimedia Peripheral	The IPU processes video and graphics functions in the MCIMX31 and interfaces to video, still image sensors, and displays.	4.3.14/57, 4.3.15/59
KPP	Keypad Port	Connectivity Peripheral	The KPP is used for keypad matrix scanning or as a general purpose I/O. This peripheral simplifies the software task of scanning a keypad matrix.	_
MPEG-4	MPEG-4 Video Encoder	Multimedia Peripherals	The MPEG-4 encoder accelerates video compression, following the MPEG-4 standard	_
MSHC	Memory Stick Host Controller	Connectivity Peripheral	The MSHC is placed in between the AIPS and the customer memory stick to support data transfer from the MCIMX31 to the customer memory stick.	4.3.16/84
PADIO	Pads I/O	Buffers and Drivers	The PADIO serves as the interface between the internal modules and the device's external connections.	4.3.1/22
PCMCIA	PCM	Connectivity Peripheral	The PCMCIA Host Adapter provides the control logic for PCMCIA socket interfaces.	4.3.17/86
PWM	Pulse-Width Modulator	Timer Peripheral	The PWM has a 16-bit counter and is optimized to generate sound from stored sample audio images. It can also generate tones.	4.3.18/88
RNGA	Random Number Generator Accelerator	Security	The RNGA module is a digital integrated circuit capable of generating 32-bit random numbers. It is designed to comply with FIPS-140 standards for randomness and non-determinism.	_
RTC	Real Time Clock	Timer Peripheral	The RTC module provides a current stamp of seconds, minutes, hours, and days. Alarm and timer functions are also available for programming. The RTC supports dates from the year 1980 to 2050.	_
RTIC	Run-Time Integrity Checkers	Security	The RTIC ensures the integrity of the peripheral memory contents and assists with boot authentication.	_

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Functional Description and Application Information

Table 3. Digital and Analog Modules (continued)

Block Mnemonic	Block Name	Functional Grouping	Brief Description	Section/ Page
SCC	Security Controller Module	Security	The SCC is a hardware component composed of two blocks—the Secure RAM module, and the Security Monitor. The Secure RAM provides a way of securely storing sensitive information.	_
SDHC	Secured Digital Host Controller	Connectivity Peripheral	The SDHC controls the MMC (MultiMediaCard), SD (Secure Digital) memory, and I/O cards by sending commands to cards and performing data accesses to and from the cards.	4.3.19/89
SDMA	Smart Direct Memory Access	System Control Peripheral	The SDMA controller maximizes the system's performance by relieving the ARM core of the task of bulk data transfer from memory to memory or between memory and on-chip peripherals.	_
SIM	Subscriber Identification Module	Connectivity Peripheral	The SIM interfaces to an external Subscriber Identification Card. It is an asynchronous serial interface adapted for Smart Card communication for e-commerce applications.	4.3.20/90
SJC	Secure JTAG Controller	Debug	The SJC provides debug and test control with maximum security and provides a flexible architecture for future derivatives or future multi-cores architecture.	4.3.21/94
SSI	Synchronous Serial Interface	Multimedia Peripheral	The SSI is a full-duplex, serial port that allows the device to communicate with a variety of serial devices, such as standard codecs, Digital Signal Processors (DSPs), microprocessors, peripherals, and popular industry audio codecs that implement the inter-IC sound bus standard (I2S) and Intel AC97 standard.	4.3.22/96
UART	Universal Asynchronous Receiver/Trans mitter	Connectivity Peripheral	The UART provides serial communication capability with external devices through an RS-232 cable or through use of external circuitry that converts infrared signals to electrical signals (for reception) or transforms electrical signals to signals that drive an infrared LED (for transmission) to provide low speed IrDA compatibility.	_
USB	Universal Serial Bus— 2 Host Controllers and 1 OTG (On-The-Go)	Connectivity Peripherals	 USB Host 1 is designed to support transceiverless connection to the on-board peripherals in Low Speed and Full Speed mode, and connection to the ULPI (UTMI+ Low-Pin Count) and Legacy Full Speed transceivers. USB Host 2 is designed to support transceiverless connection to the Cellular Modem Baseband Processor. The USB-OTG controller offers HS/FS/LS capabilities in Host mode and HS/FS in device mode. In Host mode, the controller supports direct connection of a FS/LS device (without external hub). In device (bypass) mode, the OTG port functions as gateway between the Host 1 Port and the OTG transceiver. 	4.3.23/104
WDOG	Watchdog Timer Module	Timer Peripheral	The WDOG module protects against system failures by providing a method for the system to recover from unexpected events or programming errors.	_

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3 Signal Descriptions

Signal descriptions are in the reference manual. Special signal considerations are listed following this paragraph. The BGA ball assignment is in Section 5, "Package Information and Pinout."

Special Signal Considerations:

• Tamper detect (GPIO1_6)

Tamper detect logic is used to issue a security violation. This logic is activated if the tamper detect input is asserted.

The tamper detect logic is disabled after reset. After enabling the logic, it is impossible to disable it until the next reset. The GPR[16] bit functions as the tamper detect enable bit.

GPIO1_6 functions similarly to other I/O with GPIO capabilities regardless of the status of the tamper detect enable bit. (For example, the GPIO1_6 can function as an input with GPIO capabilities, such as sampling through PSR or generating interrupts.)

• Power ready (GPIO1_5)

The power ready input, GPIO1_5, should be connected to an external power management IC power ready output signal. If not used, GPIO1_5 must either be (a) externally pulled-up to NVCC1 or (b) a no connect, internally pulled-up by enabling the on-chip pull-up resistor. GPIO1_5 is a dedicated input and cannot be used as a general-purpose input/output.

SJC MOD

SJC_MOD must be externally connected to GND for normal operation. Termination to GND through an external pull-down resistor (such as 1 k Ω) is allowed, but the value should be much smaller than the on-chip 100 k Ω pull-up.

CE CONTROL

CE_CONTROL is a reserved input and must be externally tied to GND through a 1 k Ω resistor.

TTM_PAD

TTM_PAD is for Freescale factory use only. Control bits indicate pull-up/down disabled. However, TTM_PAD is actually connected to an on-chip pull-down device. Users must either float this signal or tie it to GND.

M_REQUEST and M_GRANT

These two signals are not utilized internally. The user should make no connection to these signals.

• Clock Source Select (CLKSS)

The CLKSS is the input that selects the default reference clock source providing input to the DPLL. To select CKIH, tie CLKSS to NVCC1. To select CKIL, tie CLKSS to ground. After initialization, the reference clock source can be changed (initial setting is overwritten) by programming the PRCS bits in the CCMR.

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This section provides the device-level and module-level electrical characteristics for the MCIMX31.

4.1 Chip-Level Conditions

This section provides the device-level electrical characteristics for the IC. See Table 4 for a quick reference to the individual tables and sections.

Table 4. MCIMX31 Chip-Level Conditions

For these characteristics,	Topic appears
Table 5, "Absolute Maximum Ratings"	on page 10
Table 7, "Thermal Resistance Data—19 × 19 mm Package"	on page 11
Table 8, "Operating Ranges"	on page 13
Table 9, "Specific Operating Ranges for Silicon Revision 2.0"	on page 14
Table 10, "Interface Frequency"	on page 14
Section 4.1.1, "Supply Current Specifications"	on page 16
Section 4.2, "Supply Power-Up/Power-Down Requirements and Restrictions"	on page 19

CAUTION

Stresses beyond those listed under Table 5 may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under Table 8, "Operating Ranges," on page 13 is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Table 5. Absolute Maximum Ratings

Parameter	Symbol	Min	Max	Units
Supply Voltage (Core)	QVCC _{max}	-0.5	1.65	٧
Supply Voltage (I/O)	NVCC _{max}	-0.5	3.3	V
Input Voltage Range	V _{Imax}	-0.5	NVCC +0.3	V
Storage Temperature	T _{storage}	-40	125	°C
ESD Damage Immunity:				
Human Body Model (HBM)		_	1500	V
Machine Model (MM)	V _{esd}	_	200	V
Charge Device Model (CDM)		_	500	
Offset voltage allowed in run mode between core supplies.	V _{core_offset} ¹	_	15	mV

¹ The offset is the difference between all core voltage pair combinations of QVCC, QVCC1, and QVCC4.

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Table 6 provides the thermal resistance data for the 14×14 mm, 0.5 mm pitch package.

Table 6. Thermal Resistance Data—14 \times 14 mm Package

Rating	Board	Symbol	Value	Unit	Notes
Junction to Ambient (natural convection)	Single layer board (1s)	$R_{\theta JA}$	56	°C/W	1, 2, 3
Junction to Ambient (natural convection)	Four layer board (2s2p)	$R_{\theta JA}$	30	°C/W	1, 3
Junction to Ambient (@200 ft/min)	Single layer board (1s)	$R_{\theta JMA}$	46	°C/W	1, 2, 3
Junction to Ambient (@200 ft/min)	Four layer board (2s2p)	$R_{\theta JMA}$	26	°C/W	1, 3
Junction to Board	_	$R_{\theta JB}$	17	°C/W	1, 4
Junction to Case	_	$R_{ hetaJC}$	10	°C/W	1, 5
Junction to Package Top (natural convection)	_	Ψ_{JT}	2	°C/W	1, 6

NOTES

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per JEDEC JESD51-2 with the single layer board horizontal. Board meets JESD51-9 specification.
- 3. Per JEDEC JESD51-6 with the board horizontal.
- 4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 7 provides the thermal resistance data for the 19×19 mm, 0.8 mm pitch package.

Table 7. Thermal Resistance Data—19 × 19 mm Package

Rating	Board	Symbol	Value	Unit	Notes
Junction to Ambient (natural convection)	Single layer board (1s)	R_{\thetaJA}	46	°C/W	1, 2, 3
Junction to Ambient (natural convection)	Four layer board (2s2p)	$R_{ hetaJA}$	29	°C/W	1, 2, 3
Junction to Ambient (@200 ft/min)	Single layer board (1s)	$R_{\theta JMA}$	38	°C/W	1, 2, 3
Junction to Ambient (@200 ft/min)	Four layer board (2s2p)	$R_{ heta JMA}$	25	°C/W	1, 2, 3
Junction to Board	_	$R_{\theta JB}$	19	°C/W	1, 3
Junction to Case (Top)	_	$R_{\theta JCtop}$	10	°C/W	1, 4
Junction to Package Top (natural convection)	_	Ψ_{JT}	2	°C/W	1, 5

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NOTES

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.
- 3. Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.
- 4. Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
- 5. Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

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Table 8 provides the operating ranges.

NOTE

The term NVCC in this section refers to the associated supply rail of an input or output. The association is shown in the Signal Multiplexing chapter of the reference manual.

CAUTION

NVCC6 and NVCC9 must be at the same voltage potential. These supplies are connected together on-chip to optimize ESD damage immunity.

Table 8. Operating Ranges

Symbol	Parameter	Min	Max	Units
QVCC,	Core Operating Voltage ^{1,2,3}			
QVCC1, QVCC4	Silicon rev 1.15, 1.2, and 2.0 $0 \le f_{ARM} \le 400 \text{ MHz}$, non-overdrive	1.22	1.47	.,
Q V O O +	$0 \le f_{ARM} \le 400 \text{ MHz}, \text{ overdrive}^4$ $0 \le f_{ARM} \le 532 \text{ MHz}, \text{ overdrive}^4$	>1.47 1.55	1.65 1.65	V
	State Retention Voltage ⁵	0.95		-
NVCC1,	I/O Supply Voltage, except DDR ⁶ non-overdrive	1.75	3.1	V
NVCC3-10	overdrive ⁷	>3.1	3.3	
NVCC2, NVCC21, NVCC22	I/O Supply Voltage, DDR only	1.75	1.95	V
FVCC, MVCC,	PLL (Phase-Locked Loop) and FPM (Frequency Pre-multiplier) Supply Voltage ⁸			V
SVCC, UVCC	non-overdrive	1.3	1.47	
	overdrive ⁴	>1.47	1.6	
IOQVDD	On-device Level Shifter Supply Voltage	1.6	1.9	V
FUSE_VDD	Fusebox read Supply Voltage ^{9, 10}	1.65	1.95	V
1032_000	Fusebox write (program) Supply Voltage ¹¹	3.0	3.3	V
T _A	Operating Ambient Temperature Range ¹²	0	70	°C

¹ Measured at package balls, including peripherals, ARM, and L2 cache supplies (QVCC, QVCC1, QVCC4, respectively).

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The core voltage must be higher than 1.38V to avoid corrupted data during transfers from the USB HS. Please refer to Errata file ENGcm02610 ID.

³ If the Core voltage is supplied by the MC13738, it will be 1.6 ± 0.05 V during the power-up sequence. This is allowed. After power-up the voltage should be reduced to avoid operation in overdrive mode.

Supply voltage is considered "overdrive" for voltages above 1.47 V. Operation time in overdrive—whether switching or not—must be limited to a cumulative duration of 1.25 years (10,950 hours) or less to sustain the maximum operating voltage without significant device degradation—for example, 25% (average 6 hours out of 24 yours per day) duty cycle for 5-year rated equipment. To tolerate the maximum operating overdrive voltage for 10 years, the device must have a duty cycle of 12.5% or less in overdrive (for example 3 out of 24 hours per day). Below 1.47V, duty cycle restrictions may apply for equipment rated above 5 years.

⁵ The SR voltage is applied to QVCC, QVCC1, and QVCC4 after the device is placed in SR mode. The Real-Time Clock (RTC) is operational in State Retention (SR) mode.

Overshoot and undershoot conditions (transitions above NVCC and below GND) on I/O must be held below 0.6 V, and the duration of the overshoot/undershoot must not exceed 10% of the system clock cycle. Overshoot/undershoot must be controlled through printed circuit board layout, transmission line impedance matching, signal line termination, or other methods. Non-compliance to this specification may affect device reliability or cause permanent damage to the device.

- ⁷ Supply voltage is considered "overdrive" for voltages above 3.1 V. Operation time in overdrive—whether switching or not—must be limited to a cumulative duration of 1 year (8,760 hours) or less to sustain the maximum operating voltage without significant device degradation—for example, 20% (average 4.8 hours out of 24 hours per day) duty cycle for 5-year rated equipment. Operation at 3.3 V that exceeds a cumulative 3,504 hours may cause non-operation whenever supply voltage is reduced to 1.8 V; degradation may render the device too slow or inoperable. Below 3.1 V, duty cycle restrictions may apply for equipment rated above 5 years.
- For normal operating conditions, PLLs' and core supplies must maintain the following relation: PLL ≥ Core 100 mV. In other words, for a 1.6 V core supply, PLL supplies must be set to 1.5 V or higher. This restriction is no longer necessary on mask set M91E. PLL supplies may be set independently of core supply. PLL voltage must not be altered after power up, otherwise the PLL will be unstable and lose lock. To minimize inducing noise on the PLL supply line, source the voltage from a low-noise, dedicated supply. PLL parameters in Table 31, "DPLL Specifications," on page 37, are guaranteed over the entire specified voltage range.
- ⁹ Fusebox read supply voltage applies to silicon Revisions 1.2 and previous.
- ¹⁰ In read mode, FUSE_VDD can be floated or grounded for mask set M91E (silicon Revision 2.0).
- ¹¹ Fuses might be inadvertently blown if written to while the voltage is below this minimum.
- ¹² The temperature range given is for the consumer version. Please refer to Table 1 for extended temperature range offerings and the associated part numbers.

Table 9. Specific Operating Ranges for Silicon Revision 2.0

Symbol	Parameter	Min	Max	Units
FUSE_VDD	Fusebox read Supply Voltage ¹		_	V
103L_VDD	Fusebox write (program) Supply Voltage ²	3.0	3.3	V

¹ In read mode, FUSE VDD should be floated or grounded.

Table 10 provides information for interface frequency limits. For more details about clocks characteristics, see Section 4.3.8, "DPLL Electrical Specifications," and Section 4.3.3, "Clock Amplifier Module (CAMP) Electrical Characteristics."

Table 10. Interface Frequency

ID	Parameter	Symbol	Min	Тур	Max	Units
1	JTAG TCK Frequency	f _{JTAG}	DC	5	10	MHz
2	CKIL Frequency ¹	f _{CKIL}	32	32.768	38.4	kHz
3	CKIH Frequency ²	f _{CKIH}	15	26	75	MHz

¹ CKIL must be driven by an external clock source to ensure proper start-up and operation of the device. CKIL is needed to clock the internal reset synchronizer, the watchdog, and the real-time clock.

Table 11 shows the fusebox supply current parameters.

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² Fuses might be inadvertently blown if written to while the voltage is below the minimum.

DPTC functionality, specifically the voltage/frequency relation table, is dependent on CKIH frequency. At the time of publication, standard tables used by Freescale OSs provided for a CKIH frequency of 26 MHz only. Any deviation from this frequency requires an update to the OS. For more details, refer to the particular OS user's guide documentation.

Table 11. Fusebox Supply Current Parameters

Ref. Num	Description	Symbol	Minimum	Typical	Maximum	Units
1	eFuse Program Current. ¹ Current to program one eFuse bit: efuse_pgm = 3.0 V	I _{program}	_	35	60	mA
2	eFuse Read Current ² Current to read an 8-bit eFuse word vdd_fusebox = 1.875 V	I _{read}	_	5	8	mA

¹ The current I_{program} is during program time (t_{program}).

² The current I_{read} is present for approximately 50 ns of the read access to the 8-bit word, and only applies to Silicon Rev. 1.2 and previous.

4.1.1 Supply Current Specifications

Table 12 shows the core current consumption for 0°C to 70°C for Silicon Revision 1.2 and previous for the MCIMX31.

Table 12. Current Consumption for 0°C to 70°C^{1, 2} for Silicon Revision 1.2 and Previous

Mode	Conditions	QVCC (Peripheral)		QVCC1 (ARM)		QVCC4 (L2)		FVCC + MVCC + SVCC + UVCC (PLL)		Unit
		Тур	Max	Тур	Max	Тур	Max	Тур	Max	
State Retention	 QVCC and QVCC1 = 0.95 V L2 caches are power gated (QVCC4 = 0 V) All PLLs are off, VCC = 1.4 V ARM is in well bias FPM is off 32 kHz input is on CKIH input is off CAMP is off TCK input is off All modules are off No external resistive loads RNGA oscillator is off 	0.80	_	0.50	_		_	0.04		mA
Wait	 QVCC,QVCC1, and QVCC4 = 1.22 V ARM is in wait for interrupt mode MAX is active L2 cache is stopped but powered MCU PLL is on (532 MHz), VCC = 1.4 V USB PLL and SPLL are off, VCC = 1.4 V FPM is on CKIH input is on CAMP is on 32 kHz input is on All clocks are gated off All modules are off (by programming CGR[2:0] registers) RNGA oscillator is off No external resistive loads 	6.00	_	3.00	_	0.04	_	3.50		mA

¹ Typical column: TA = 25°C

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² Maximum column: TA = 70°C

Table 13 shows the core current consumption for –40°C to 85°C for Silicon Revision 2.0 for the MCIMX31.

Table 13. Current Consumption for -40°C to 85°C^{1, 2} for Silicon Revision 2.0

Mode	Conditions		/CC oheral)	QVCC1 (ARM)		QVCC4 (L2)		FVCC + MVCC + SVCC + UVCC (PLL)		Unit
		Тур	Max	Тур	Max	Тур	Max	Тур	Max	
Deep Sleep	 QVCC = 0.95 V ARM and L2 caches are power gated (QVCC1 = QVCC4 = 0 V) All PLLs are off, VCC = 1.4 V ARM is in well bias FPM is off 32 kHz input is on CKIH input is off CAMP is off TCK input is off All modules are off No external resistive loads RNGA oscillator is off 	0.16	5.50	_	_	_	_	0.02	0.10	mA
State Retention	 QVCC and QVCC1 = 0.95 V L2 caches are power gated (QVCC4 = 0 V) All PLLs are off, VCC = 1.4 V ARM is in well bias FPM is off 32 kHz input is on CKIH input is off CAMP is off TCK input is off All modules are off No external resistive loads RNGA oscillator is off 	0.16	5.50	0.07	2.20	_	_	0.02	0.10	mA
Wait	 QVCC, QVCC1, and QVCC4 = 1.22 V ARM is in wait for interrupt mode MAX is active L2 cache is stopped but powered MCU PLL is on (532 MHz), VCC = 1.4 V USB PLL and SPLL are off, VCC = 1.4 V FPM is on CKIH input is on CAMP is on 32 kHz input is on All clocks are gated off All modules are off (by programming CGR[2:0] registers) RNGA oscillator is off No external resistive loads 	6.00	15.00	2.20	25.00	0.03	0.29	3.60	4.40	mA

¹ Typical column: TA = 25°C

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² Maximum column: TA = 85°C

Table 14 shows the core current consumption for 0°C to 70°C for Silicon Revision 2.0 for the MCIMX31.

Table 14. Current Consumption for 0°C to 70°C^{1, 2} for Silicon Revision 2.0

Mode	Conditions		/CC oheral)	QVCC1 (ARM)		QVCC4 (L2)		FVCC, +MVCC, +SVCC, +UVCC (PLL)		Unit
		Тур	Max	Тур	Max	Тур	Max	Тур	Max	
Deep Sleep	 QVCC = 0.95 V ARM and L2 caches are power gated (QVCC1 2= QVCC4 = 0 V) All PLLs are off, VCC = 1.4 V ARM is in well bias FPM is off 32 kHz input is on CKIH input is off CAMP is off TCK input is off All modules are off No external resistive loads RNGA oscillator is off 	0.16	2.50	_	_	_	_	0.02	0.10	mA
State Retention	 QVCC and QVCC1 = 0.95 V L2 caches are power gated (QVCC4 = 0 V) All PLLs are off, VCC = 1.4 V ARM is in well bias FPM is off 32 kHz input is on CKIH input is off CAMP is off TCK input is off All modules are off No external resistive loads RNGA oscillator is off 	0.16	2.50	0.07	1.60	_	_	0.02	0.10	mA
Wait	 QVCC, QVCC1, and QVCC4 = 1.22 V ARM is in wait for interrupt mode MAX is active L2 cache is stopped but powered MCU PLL is on (532 MHz), VCC = 1.4 V USB PLL and SPLL are off, VCC = 1.4 V FPM is on CKIH input is on CAMP is on 32 kHz input is on All clocks are gated off All modules are off (by programming CGR[2:0] registers) RNGA oscillator is off No external resistive loads 	6.00	13.00	2.20	16.00	0.03	0.17	3.60	4.40	mA

¹ Typical column: TA = 25°C

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² Maximum column: $TA = 70^{\circ}C$

4.2 Supply Power-Up/Power-Down Requirements and Restrictions

Any MCIMX31 board design must comply with the power-up and power-down sequence guidelines as described in this section to guarantee reliable operation of the device. Any deviation from these sequences may result in any or all of the following situations:

- Cause excessive current during power up phase
- Prevent the device from booting
- Cause irreversible damage to the MCIMX31 (worst-case scenario)

4.2.1 Powering Up

The Power On Reset (\overline{POR}) pin must be kept asserted (low) throughout the power up sequence. Power up logic must guarantee that all power sources reach their target values prior to the release (de-assertion) of \overline{POR} . Figure 2 shows the power-up sequence for silicon Revisions 1.2 and previous. Figure 3 and Figure 4 show the power-up sequence for silicon Revision 2.0.

NOTE

Stages need to be performed in the order shown; however, *within* each stage, supplies can be powered up in any order. For example, supplies IOQVDD, NVCC1, and NVCC3 through NVCC10 do not need to be powered up in the order shown.

CAUTION

NVCC6 and NVCC9 must be at the same voltage potential. These supplies are connected together on-chip to optimize ESD damage immunity.

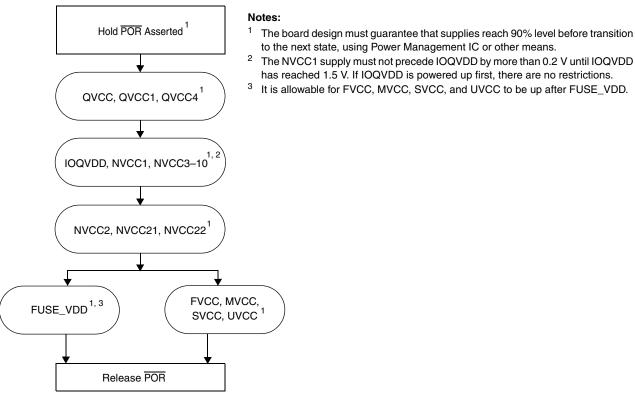


Figure 2. Power-Up Sequence for Silicon Revisions 1.2 and Previous

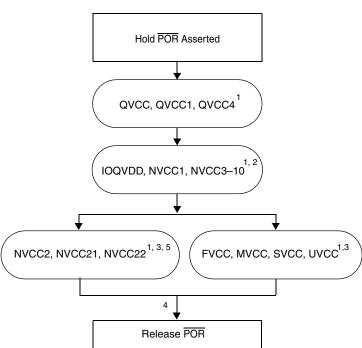
4.2.1.1 Power-Up Sequence for Silicon Revision 2

Silicon revision 2.0 offers two options for power-up sequencing. Option 1 is backwards compatible with silicon revision 1.2 and earlier versions of the IC. It should be noted that using option 1 on silicon Rev. 2.0 introduces a slight increase in current drain on IOQVDD when IOQVDD is raised before NVCC21. The expected resulting increase is in the range of 3 mA to 5 mA, which does not pose a risk to the IC.

Option 2 is an alternative power-up sequence that allows the powering up of NVCC2, NVCC21, NVCC22 with IOQVDD, NVCC1, and NVCC3-10 without producing a current drain increase on IOQVDD.

These two power-up options on the 2.0 silicon allow the user to select the optimum power-up sequence for their application.

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Notes:

- The board design must guarantee that supplies reach 90% level before transition to the next state, using Power Management IC or other means.
- The NVCC1 supply must not precede IOQVDD by more than 0.2 V until IOQVDD has reached 1.5 V. If IOQVDD is powered up first, there are no restrictions.
- The parallel paths in the flow indicate that supply group NVCC2, NVCC21, and NVCC22, and supply group FVCC, MVCC, SVCC, and UVCC ramp-ups are independent. Note that this power-up sequence is backward compatible to Silicon Revs. 1.15 and 1.2, because NVCC2x ramp-up proceeding PLL supplies is allowed.
- Unlike the power-up sequence for Silicon Revision 1.2, FUSE_VDD should not be driven on power-up for Silicon Revision 2.0. This supply is dedicated for fuse burning (programming), and should not be driven upon boot-up.
 - Raising IOQVDD before NVCC21 produces a slight increase in current drain on IOQVDD of approximately 3–5 mA. The current increase will not damage the IC. Refer to Errata ID TLSbo91750 for details.

Figure 3. Option 1 Power-Up Sequence (Silicon Revision 2.0)

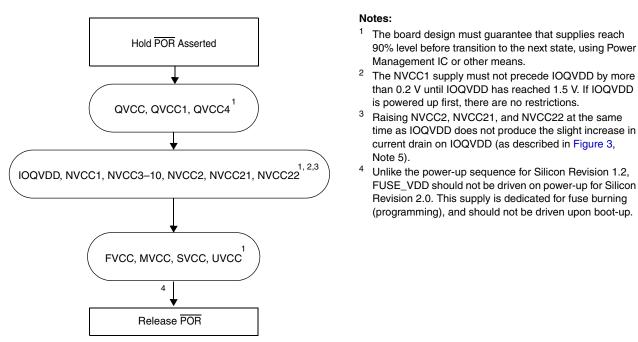


Figure 4. Option 2 Power-Up Sequence (Silicon Revision 2.0)

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4.2.2 Powering Down

The power-down sequence prior to silicon Revision 2.0 should be completed as follows:

- 1. Lower the FUSE_VDD supply (when in write mode).
- 2. Lower the remaining supplies.

For silicon revisions beginning with Revision 2.0 there is no special requirements for power down sequence.

4.3 Module-Level Electrical Specifications

This section contains the MCIMX31 electrical information including timing specifications, arranged in alphabetical order by module name.

4.3.1 I/O Pad (PADIO) Electrical Specifications

This section specifies the AC/DC characterization of functional I/O of the MCIMX31. There are two main types of I/O: regular and DDR. In this document, the "Regular" type is referred to as GPIO.

4.3.1.1 DC Electrical Characteristics

The MCIMX31 I/O parameters appear in Table 15 for GPIO. See Table 8 for temperature and supply voltage ranges.

NOTE

The term NVCC in this section refers to the associated supply rail of an input or output. The association is shown in the Signal Multiplexing chapter of the reference manual. NVCC for Table 15 refers to NVCC1 and NVCC3–10; QVCC refers to QVCC, QVCC1, and QVCC4.

Table 15. GPIO DC Electrical Parameters

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
High-level output voltage	V _{OH}	I _{OH} = -1 mA	NVCC -0.15	_	_	V
		I _{OH} = specified Drive	0.8*NVCC	_	_	V
Low-level output voltage	V _{OL}	I _{OL} = 1 mA	_	_	0.15	V
		I _{OL} = specified Drive	_	_	0.2*NVCC	V
High-level output current, slow slew rate	I _{OH_S}	V _{OH} =0.8*NVCC Std Drive High Drive Max Drive	-2 -4 -8	_	_	mA
High-level output current, fast slew rate	I _{OH_F}	V _{OH} =0.8*NVCC Std Drive High Drive Max Drive	-4 -6 -8	_	_	mA

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Table 15. GPIO DC Electrical Parameters (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Low-level output current, slow slew rate	I _{OL_S}	V _{OL} =0.2*NVCC Std Drive High Drive Max Drive	2 4 8	-	_	mA
Low-level output current, fast slew rate	I _{OL_F}	V _{OL} =0.2*NVCC Std Drive High Drive Max Drive	4 6 8	_	_	mA
High-Level DC input voltage	V _{IH}	_	0.7*NVCC	_	NVCC	٧
Low-Level DC input voltage	V _{IL}	_	0	_	0.3*QVCC	٧
Input Hysteresis	V _{HYS}	Hysteresis enabled	0.25	_	_	٧
Schmitt trigger VT+	V _T +	Hysteresis enabled	0.5*QVCC	_	_	٧
Schmitt trigger VT-	V _T –	Hysteresis enabled	_	_	0.5*QVCC	٧
Pull-up resistor (100 kΩ PU)	R _{PU}	_	_	100	_	kΩ
Pull-down resistor (100 kΩ PD)	R _{PD}	_	_	100	_	K52
Input current (no PU/PD)	I _{IN}	V _I = NVCC or GND	_	_	±1	μΑ
Input current (100 kΩ PU)	I _{IN}	$V_I = 0$ $V_I = NVCC$	_	_	25 0.1	μ Α μ Α
Input current (100 kΩ PD)	I _{IN}	V _I = 0 V _I = NVCC	_	_	0.25 28	μ Α μ Α
Tri-state leakage current	I _{OZ}	V _I = NVCC or GND I/O = High Z	_	_	±2	μΑ

The MCIMX31 I/O parameters appear in Table 16 for DDR (Double Data Rate). See Table 8, "Operating Ranges," on page 13 for temperature and supply voltage ranges.

NOTE

NVCC for Table 16 refers to NVCC2, NVCC21, and NVCC22.

Table 16. DDR (Double Data Rate) I/O DC Electrical Parameters

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
High-level output voltage	V _{OH}	$I_{OH} = -1 \text{ mA}$	NVCC -0.12	_	_	V
		I _{OH} = specified Drive	0.8*NVCC	_	_	V
Low-level output voltage	V _{OL}	I _{OL} = 1 mA	_	_	0.08	V
		I _{OL} = specified Drive	_	_	0.2*NVCC	V
High-level output current	I _{OH}	V _{OH} =0.8*NVCC Std Drive High Drive Max Drive DDR Drive ¹	-3.6 -7.2 -10.8 -14.4	_	_	mA

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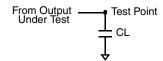
Table 16. DDR (Double Data Rate) I/O DC Electrical Parameters (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Low-level output current	I _{OL}	V _{OL} =0.2*NVCC Std Drive High Drive Max Drive DDR Drive ¹	3.6 7.2 10.8 14.4	_	Ι	mA
High-Level DC input voltage	V _{IH}	_	0.7*NVCC	NVCC	NVCC+0.3	٧
Low-Level DC input voltage	V _{IL}	_	-0.3	0	0.3*NVCC	V
Tri-state leakage current	l _{OZ}	V _I = NVCC or GND I/O = High Z	_	_	±2	μА

Use of DDR Drive can result in excessive overshoot and ringing.

4.3.2 AC Electrical Characteristics

Figure 5 depicts the load circuit for outputs. Figure 6 depicts the output transition time waveform. The range of operating conditions appears in Table 17 for slow general I/O, Table 18 for fast general I/O, and Table 19 for DDR I/O (unless otherwise noted).



CL includes package, probe and fixture capacitance

Figure 5. Load Circuit for Output

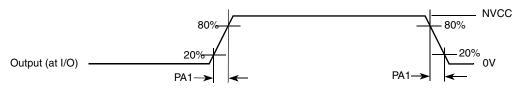


Figure 6. Output Transition Time Waveform

Table 17. AC Electrical Characteristics of Slow¹ General I/O

ID	Parameter	Symbol	Test Condition	Min	Тур	Max	Units
PA1	Output Transition Times (Max Drive)	tpr	25 pF 50 pF	0.92 1.5	1.95 2.98	3.17 4.75	ns
	Output Transition Times (High Drive)	tpr	25 pF 50 pF	1.52 2.75	_	4.81 8.42	ns
	Output Transition Times (Std Drive)	tpr	25 pF 50 pF	2.79 5.39	_	8.56 16.43	ns

¹ Fast/slow characteristic is selected per GPIO (where available) by "slew rate" control. See reference manual.

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Table 18. AC Electrical Characteristics of Fast 1 General I/O 2

ID	Parameter	Symbol	Test Condition	Min	Тур	Max	Units
PA1	Output Transition Times (Max Drive)	tpr	25 pF 50 pF	0.68 1.34	1.33 2.6	2.07 4.06	ns
	Output Transition Times (High Drive)	tpr	25 pF 50 pF	.91 1.79	1.77 3.47	2.74 5.41	ns
	Output Transition Times (Std Drive)	tpr	25 pF 50 pF	1.36 2.68	2.64 5.19	4.12 8.11	ns

¹ Fast/slow characteristic is selected per GPIO (where available) by "slew rate" control. See reference manual.

Table 19. AC Electrical Characteristics of DDR I/O

ID	Parameter	Symbol	Test Condition	Min	Тур	Max	Units
PA1	Output Transition Times (DDR Drive) ¹	tpr	25 pF 50 pF	0.51 0.97	0.82 1.58	1.28 2.46	ns
	Output Transition Times (Max Drive)	tpr	25 pF 50 pF	0.67 1.29	1.08 2.1	1.69 3.27	ns
	Output Transition Times (High Drive)	tpr	25 pF 50 pF	.99 1.93	1.61 3.13	2.51 4.89	ns
	Output Transition Times (Std Drive)	tpr	25 pF 50 pF	1.96 3.82	3.19 6.24	4.99 9.73	ns

¹ Use of DDR Drive can result in excessive overshoot and ringing.

4.3.3 Clock Amplifier Module (CAMP) Electrical Characteristics

This section outlines the Clock Amplifier Module (CAMP) specific electrical characteristics. Table 20 shows clock amplifier electrical characteristics.

Table 20. Clock Amplifier Electrical Characteristics for CKIH Input

Parameter	Min	Тур	Max	Units
Input Frequency	15	_	75	MHz
VIL (for square wave input)	0	_	0.3	V
VIH (for square wave input)	(VDD ¹ - 0.25)	_	3	V
Sinusoidal Input Amplitude	0.4 ²	_	VDD	Vp-p
Duty Cycle	45	50	55	%

¹ VDD is the supply voltage of CAMP. See reference manual.

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² Use of GPIO in fast mode with the associated NVCC > 1.95 V can result in excessive overshoot and ringing.

² This value of the sinusoidal input will be measured through characterization.

4.3.4 1-Wire Electrical Specifications

Figure 7 depicts the RPP timing, and Table 21 lists the RPP timing parameters.

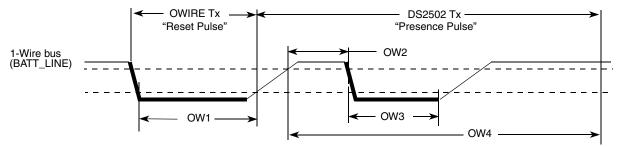


Figure 7. Reset and Presence Pulses (RPP) Timing Diagram

Table 21. RPP Sequence Delay Comparisons Timing Parameters

ID	Parameters	Symbol	Min	Тур	Max	Units
OW1	Reset Time Low	t _{RSTL}	480	511	_	μs
OW2	Presence Detect High	t _{PDH}	15		60	μs
OW3	Presence Detect Low	t _{PDL}	60	_	240	μs
OW4	Reset Time High	t _{RSTH}	480	512	_	μs

Figure 8 depicts Write 0 Sequence timing, and Table 22 lists the timing parameters.

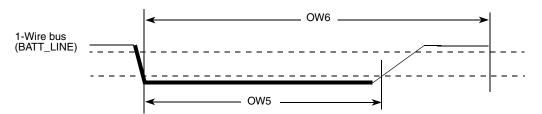


Figure 8. Write 0 Sequence Timing Diagram

Table 22. WR0 Sequence Timing Parameters

ID	Parameter	Symbol	Min	Тур	Max	Units
OW5	Write 0 Low Time	t _{WR0_low}	60	100	120	μs
OW6	Transmission Time Slot	t _{SLOT}	OW5	117	120	μs

Figure 9 depicts Write 1 Sequence timing, Figure 10 depicts the Read Sequence timing, and Table 23 lists the timing parameters.

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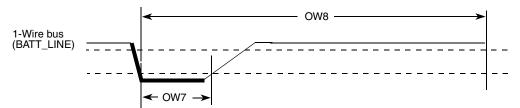


Figure 9. Write 1 Sequence Timing Diagram

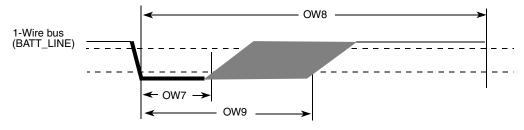


Figure 10. Read Sequence Timing Diagram

Table 23. WR1/RD Timing Parameters

ID	Parameter	Symbol	Min	Тур	Max	Units
OW7	Write 1 / Read Low Time	t _{LOW1}	1	5	15	μs
OW8	Transmission Time Slot	t _{SLOT}	60	117	120	μs
OW9	Release Time	t _{RELEASE}	15	_	45	μs

4.3.5 ATA Electrical Specifications (ATA Bus, Bus Buffers)

This section discusses ATA parameters. For a detailed description, refer to the ATA specification.

The user needs to use level shifters for 3.3 Volt or 5.0 Volt compatibility on the ATA interface.

The use of bus buffers introduces delay on the bus and introduces skew between signal lines. These factors make it difficult to operate the bus at the highest speed (UDMA-5) when bus buffers are used. If fast UDMA mode operation is needed, this may not be compatible with bus buffers.

Another area of attention is the slew rate limit imposed by the ATA specification on the ATA bus. According to this limit, any signal driven on the bus should have a slew rate between 0.4 and 1.2 V/ns with a 40 pF load. Not many vendors of bus buffers specify slew rate of the outgoing signals.

When bus buffers are used, the ata_data bus buffer is special. This is a bidirectional bus buffer, so a direction control signal is needed. This direction control signal is ata_buffer_en. When its high, the bus should drive from host to device. When its low, the bus should drive from device to host. Steering of the signal is such that contention on the host and device tri-state busses is always avoided.

4.3.5.1 Timing Parameters

In the timing equations, some timing parameters are used. These parameters depend on the implementation of the ATA interface on silicon, the bus buffer used, the cable delay and cable skew. Table 24 shows ATA timing parameters.

Table 24. ATA Timing Parameters

Name	Description	Value/ Contributing Factor ¹
Т	Bus clock period (ipg_clk_ata)	peripheral clock frequency
ti_ds	Set-up time ata_data to ata_iordy edge (UDMA-in only) UDMA0 UDMA1 UDMA2, UDMA3 UDMA4 UDMA5	15 ns 10 ns 7 ns 5 ns 4 ns
ti_dh	Hold time ata_iordy edge to ata_data (UDMA-in only) UDMA0, UDMA1, UDMA2, UDMA3, UDMA4 UDMA5	5.0 ns 4.6 ns
tco	Propagation delay bus clock L-to-H to ata_cs0, ata_cs1, ata_da2, ata_da1, ata_da0, ata_dior, ata_diow, ata_dmack, ata_data, ata_buffer_en	12.0 ns
tsu	Set-up time ata_data to bus clock L-to-H	8.5 ns
tsui	Set-up time ata_iordy to bus clock H-to-L	8.5 ns
thi	Hold time ata_iordy to bus clock H to L	2.5 ns
tskew1	Max difference in propagation delay bus clock L-to-H to any of following signals ata_cs0, ata_cs1, ata_da2, ata_da1, ata_da0, ata_dior, ata_diow, ata_dmack, ata_data (write), ata_buffer_en	7 ns
tskew2	Max difference in buffer propagation delay for any of following signals ata_cs0, ata_cs1, ata_da2, ata_da1, ata_da0, ata_dior, ata_diow, ata_dmack, ata_data (write), ata_buffer_en	transceiver
tskew3	Max difference in buffer propagation delay for any of following signals ata_iordy, ata_data (read)	transceiver
tbuf	Max buffer propagation delay	transceiver
tcable1	Cable propagation delay for ata_data	cable
tcable2	Cable propagation delay for control signals ata_dior, ata_diow, ata_iordy, ata_dmack	cable
tskew4	Max difference in cable propagation delay between ata_iordy and ata_data (read)	cable
tskew5	Max difference in cable propagation delay between (ata_dior, ata_diow, ata_dmack) and ata_cs0, ata_cs1, ata_da2, ata_da1, ata_da0, ata_data(write)	cable
tskew6	Max difference in cable propagation delay without accounting for ground bounce	cable

¹ Values provided where applicable.

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4.3.5.2 PIO Mode Timing

Figure 11 shows timing for PIO read, and Table 25 lists the timing parameters for PIO read.

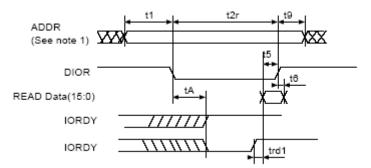


Figure 11. PIO Read Timing Diagram

Table 25. PIO Read Timing Parameters

ATA Parameter	Parameter from Figure 11	Value	Controlling Variable
t1	t1	t1 (min) = time_1 * T - (tskew1 + tskew2 + tskew5)	time_1
t2	t2r	t2 min) = time_2r * T - (tskew1 + tskew2 + tskew5)	time_2r
t9	t9	t9 (min) = time_9 * T - (tskew1 + tskew2 + tskew6)	time_3
t5	t5	t5 (min) = tco + tsu + tbuf + tbuf + tcable1 + tcable2	If not met, increase time_2
t6	t6	0	_
tA	tA	$tA (min) = (1.5 + time_ax) * T - (tco + tsui + tcable2 + tcable2 + 2*tbuf)$	time_ax
trd	trd1	$trd1 (max) = (-trd) + (tskew3 + tskew4)$ $trd1 (min) = (time_pio_rdx - 0.5)*T - (tsu + thi)$ $(time_pio_rdx - 0.5) * T > tsu + thi + tskew3 + tskew4$	time_pio_rdx
tO	_	t0 (min) = (time_1 + time_2 + time_9) * T	time_1, time_2r, time_9

Figure 12 shows timing for PIO write, and Table 26 lists the timing parameters for PIO write.

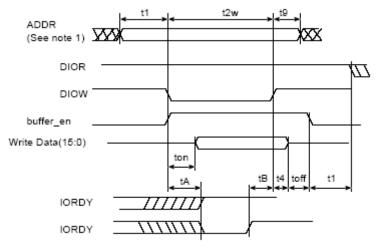


Figure 12. Multiword DMA (MDMA) Timing

Table 26. PIO Write Timing Parameters

ATA Parameter	Parameter from Figure 12	Value	Controlling Variable	
t1	t1	t1 (min) = time_1 * T - (tskew1 + tskew2 + tskew5)	time_1	
t2	t2w	t2 (min) = time_2w * T - (tskew1 + tskew2 + tskew5)	time_2w	
t9	t9	t9 (min) = time_9 * T - (tskew1 + tskew2 + tskew6)	time_9	
t3	_	t3 (min) = (time_2w - time_on)* T - (tskew1 + tskew2 +tskew5)	If not met, increase time_2w	
t4	t4	t4 (min) = time_4 * T - tskew1	time_4	
tA	tA	$tA = (1.5 + time_ax) * T - (tco + tsui + tcable2 + tcable2 + 2*tbuf)$	time_ax	
tO	_	t0(min) = (time_1 + time_2 + time_9) * T	time_1, time_2r, time_9	
_	_	Avoid bus contention when switching buffer on by making ton long enough.	aking ton long enough. —	
_	_	Avoid bus contention when switching buffer off by making toff long enough.	_	

Figure 13 shows timing for MDMA read, Figure 14 shows timing for MDMA write, and Table 27 lists the timing parameters for MDMA read and write.

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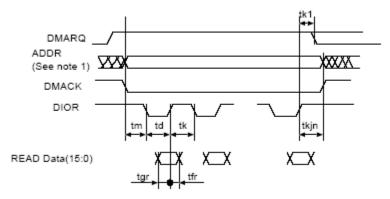


Figure 13. MDMA Read Timing Diagram

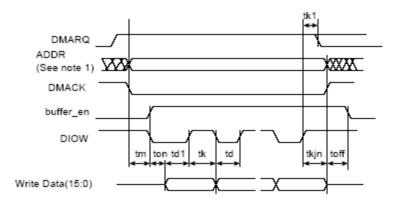


Figure 14. MDMA Write Timing Diagram

Table 27. MDMA Read and Write Timing Parameters

ATA Parameter	Parameter from Figure 13, Figure 14	Value	Controlling Variable
tm, ti	tm	tm (min) = ti (min) = time_m * T - (tskew1 + tskew2 + tskew5)	time_m
td	td, td1	td1.(min) = td (min) = time_d * T - (tskew1 + tskew2 + tskew6)	time_d
tk	tk	tk.(min) = time_k * T - (tskew1 + tskew2 + tskew6)	time_k
tO	_	t0 (min) = (time_d + time_k) * T	time_d, time_k
tg(read)	tgr	tgr (min-read) = tco + tsu + tbuf + tbuf + tcable1 + tcable2 tgr.(min-drive) = td - te(drive)	time_d
tf(read)	tfr	tfr (min-drive) = 0	_
tg(write)	_	tg (min-write) = time_d * T - (tskew1 + tskew2 + tskew5)	time_d
tf(write)	_	tf (min-write) = time_k * T - (tskew1 + tskew2 + tskew6)	time_k
tL	_	tL (max) = (time_d + time_k-2)*T - (tsu + tco + 2*tbuf + 2*tcable2)	time_d, time_k
tn, tj	tkjn	tn= tj= tkjn = (max(time_k,. time_jn) * T - (tskew1 + tskew2 + tskew6)	time_jn
_	ton toff	ton = time_on * T - tskew1 toff = time_off * T - tskew1	_

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4.3.5.3 UDMA In Timing

Figure 15 shows timing when the UDMA in transfer starts, Figure 16 shows timing when the UDMA in host terminates transfer, Figure 17 shows timing when the UDMA in device terminates transfer, and Table 28 lists the timing parameters for UDMA in burst.

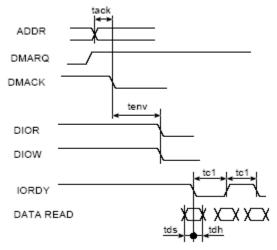


Figure 15. UDMA In Transfer Starts Timing Diagram

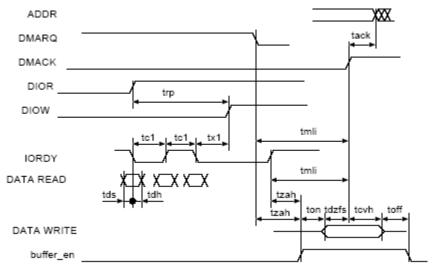


Figure 16. UDMA In Host Terminates Transfer Timing Diagram

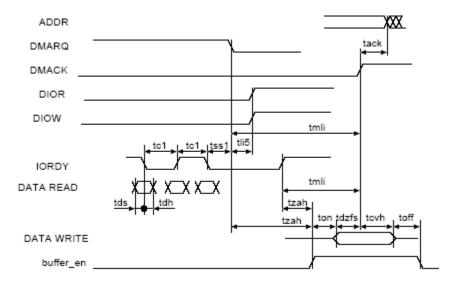


Figure 17. UDMA In Device Terminates Transfer Timing Diagram

Table 28. UDMA In Burst Timing Parameters

ATA Parameter	Parameter from Figure 15, Figure 16, Figure 17	Description	Controlling Variable
tack	tack	tack (min) = (time_ack * T) - (tskew1 + tskew2)	time_ack
tenv	tenv	tenv (min) = (time_env * T) - (tskew1 + tskew2) tenv (max) = (time_env * T) + (tskew1 + tskew2)	time_env
tds	tds1	tds - (tskew3) - ti_ds > 0	tskew3, ti_ds, ti_dh
tdh	dh tdh1 tdh - (tskew3) - ti_dh > 0		should be low enough
tcyc	tc1	(tcyc – tskew) > T	T big enough
trp	trp	trp (min) = time_rp * T - (tskew1 + tskew2 + tskew6)	time_rp
_	tx1 ¹	(time_rp * T) - (tco + tsu + 3T + 2 *tbuf + 2*tcable2) > trfs (drive)	time_rp
tmli	tmli1	tmli1 (min) = (time_mlix + 0.4) * T	time_mlix
tzah	tzah	tzah (min) = (time_zah + 0.4) * T	time_zah
tdzfs	tdzfs	tdzfs = (time_dzfs * T) - (tskew1 + tskew2)	time_dzfs
tcvh	tcvh	tcvh = (time_cvh *T) - (tskew1 + tskew2)	time_cvh
_	ton toff	ton = time_on * T - tskew1 toff = time_off * T - tskew1	_

There is a special timing requirement in the ATA host that requires the internal DIOW to go only high 3 clocks after the last active edge on the DSTROBE signal. The equation given on this line tries to capture this constraint.

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^{2.} Make ton and toff big enough to avoid bus contention

4.3.5.4 UDMA Out Timing

Figure 18 shows timing when the UDMA out transfer starts, Figure 19 shows timing when the UDMA out host terminates transfer, Figure 20 shows timing when the UDMA out device terminates transfer, and Table 29 lists the timing parameters for UDMA out burst.

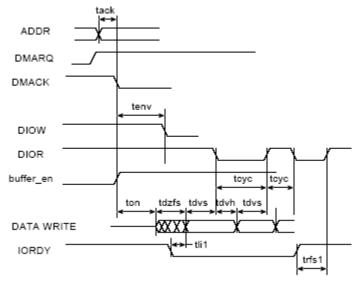


Figure 18. UDMA Out Transfer Starts Timing Diagram

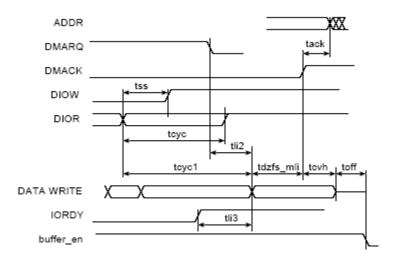


Figure 19. UDMA Out Host Terminates Transfer Timing Diagram

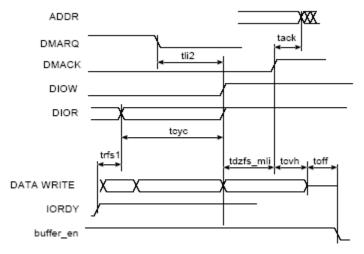


Figure 20. UDMA Out Device Terminates Transfer Timing Diagram

Table 29. UDMA Out Burst Timing Parameters

ATA Parameter	Parameter from Figure 18, Figure 19, Figure 20	Value	Controlling Variable
tack	tack	tack (min) = (time_ack * T) - (tskew1 + tskew2)	time_ack
tenv	tenv	tenv (min) = (time_env * T) - (tskew1 + tskew2) tenv (max) = (time_env * T) + (tskew1 + tskew2)	time_env
tdvs	tdvs	tdvs = (time_dvs * T) - (tskew1 + tskew2)	time_dvs
tdvh	tdvh	tdvs = (time_dvh * T) - (tskew1 + tskew2)	time_dvh
tcyc	tcyc	tcyc = time_cyc * T - (tskew1 + tskew2)	time_cyc
t2cyc	_	t2cyc = time_cyc * 2 * T	time_cyc
trfs1	trfs	trfs = 1.6 * T + tsui + tco + tbuf + tbuf	_
_	tdzfs	tdzfs = time_dzfs * T – (tskew1)	time_dzfs
tss	tss	tss = time_ss * T - (tskew1 + tskew2)	time_ss
tmli	tdzfs_mli	tdzfs_mli =max (time_dzfs, time_mli) * T - (tskew1 + tskew2)	_
tli	tli1	tli1 > 0	_
tli	tli2	tli2 > 0	_
tli	tli3	tli3 > 0	_
tcvh	tcvh	tcvh = (time_cvh *T) - (tskew1 + tskew2)	time_cvh
_	ton toff	ton = time_on * T - tskew1 toff = time_off * T - tskew1	_

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4.3.6 AUDMUX Electrical Specifications

The AUDMUX provides a programmable interconnect logic for voice, audio and data routing between internal serial interfaces (SSI) and external serial interfaces (audio and voice codecs). The AC timing of AUDMUX external pins is hence governed by the SSI module. Please refer to their respective electrical specifications.

4.3.7 CSPI Electrical Specifications

This section describes the electrical information of the CSPI.

4.3.7.1 CSPI Timing

Figure 21 and Figure 22 depict the master mode and slave mode timings of CSPI, and Table 30 lists the timing parameters.

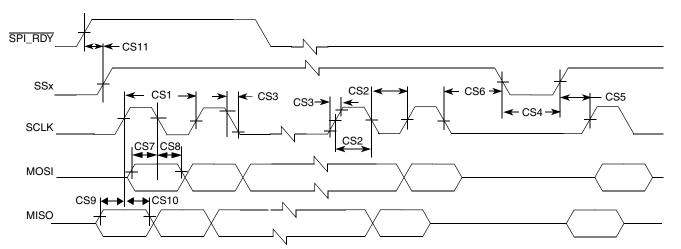


Figure 21. CSPI Master Mode Timing Diagram

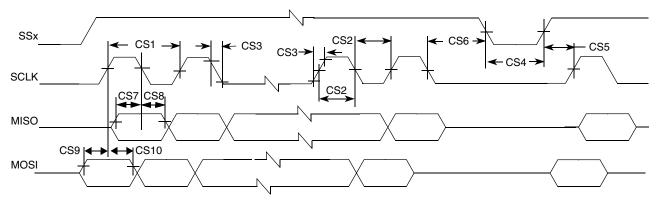


Figure 22. CSPI Slave Mode Timing Diagram

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ns

		•			
ID	Parameter	Symbol	Min	Max	Units
CS1	SCLK Cycle Time	t _{clk}	60	_	ns
CS2	SCLK High or Low Time	t _{SW}	30	_	ns
CS3	SCLK Rise or Fall	t _{RISE/FALL}	_	7.6	ns
CS4	SSx pulse width	t _{CSLH}	25	_	ns
CS5	SSx Lead Time (CS setup time)	t _{SCS}	25	_	ns
CS6	SSx Lag Time (CS hold time)	t _{HCS}	25	_	ns
CS7	Data Out Setup Time	t _{Smosi}	5	_	ns
CS8	Data Out Hold Time	t _{Hmosi}	5	_	ns
CS9	Data In Setup Time	t _{Smiso}	6	_	ns
CS10	Data In Hold Time	t _{Hmiso}	5	_	ns

Table 30. CSPI Interface Timing Parameters

4.3.8 DPLL Electrical Specifications

The three PLL's of the MCIMX31 (MCU, USB, and Serial PLL) are all based on same DPLL design. The characteristics provided herein apply to all of them, except where noted explicitly. The PLL characteristics are provided based on measurements done for both sources—external clock source (CKIH), and FPM (Frequency Pre-Multiplier) source.

 t_{SRDY}

4.3.8.1 Electrical Specifications

SPI RDY Setup Time¹

CS11

Table 31 lists the DPLL specification.

Table 31. DPLL Specifications

Parameter	Min	Тур	Max	Unit	Comments
CKIH frequency	15	26 ¹	75 ²	MHz	_
CKIL frequency (Frequency Pre-multiplier (FPM) enable mode)		32; 32.768, 38.4	_	kHz	FPM lock time $\approx 480~\mu s$.
Predivision factor (PD bits)	1	_	16	_	_
PLL reference frequency range after Predivider	15	_	35	MHz	$15 \leq \text{CKIH frequency/PD} \leq 35 \text{ MHz}$ $15 \leq \text{FPM output/PD} \leq 35 \text{ MHz}$
PLL output frequency range: MPLL and SPLL UPLL	52 190	_	532 240	MHz	_
Maximum allowed reference clock phase noise.	_	_	± 100	ps	_
Frequency lock time (FOL mode or non-integer MF)	_	_	398	_	Cycles of divided reference clock.

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SPI_RDY is sampled internally by ipg_clk and is asynchronous to all other CSPI signals.

Table 31.	DPLL S	pecifications ((continued)
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Parameter	Min	Тур	Max	Unit	Comments
Phase lock time	_	_	100	μs	In addition to the frequency
Maximum allowed PLL supply voltage ripple	_	_	25	mV	F _{modulation} < 50 kHz
Maximum allowed PLL supply voltage ripple	_	_	20	mV	50 kHz < F _{modulation} < 300 kHz
Maximum allowed PLL supply voltage ripple	_	_	25	mV	F _{modulation} > 300 kHz
PLL output clock phase jitter	_	_	5.2	ns	Measured on CLKO pin
PLL output clock period jitter	_	_	420	ps	Measured on CLKO pin

¹ The user or board designer must take into account that the use of a frequency other than 26 MHz would require adjustment to the DPTC–DVFS table, which is incorporated into operating system code.

4.3.9 EMI Electrical Specifications

This section provides electrical parametrics and timings for EMI module.

4.3.9.1 NAND Flash Controller Interface (NFC)

The NFC supports normal timing mode, using two flash clock cycles for one access of $\overline{\text{RE}}$ and $\overline{\text{WE}}$. AC timings are provided as multiplications of the clock cycle and fixed delay. Figure 23, Figure 24, Figure 25, and Figure 26 depict the relative timing requirements among different signals of the NFC at module level, for normal mode, and Table 32 lists the timing parameters.

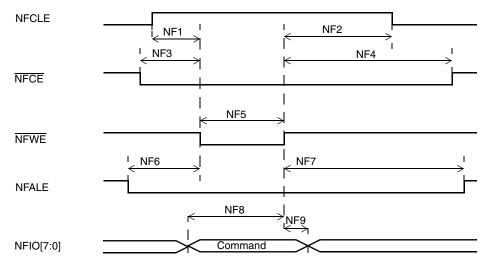


Figure 23. Command Latch Cycle Timing Dlagram

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² The PLL reference frequency must be ≤ 35 MHz. Therefore, for frequencies between 35 MHz and 70 MHz, program the predivider to divide by 2 or more. If the CKIH frequency is above 70 MHz, program the predivider to 3 or more. For PD bit description, see the reference manual.

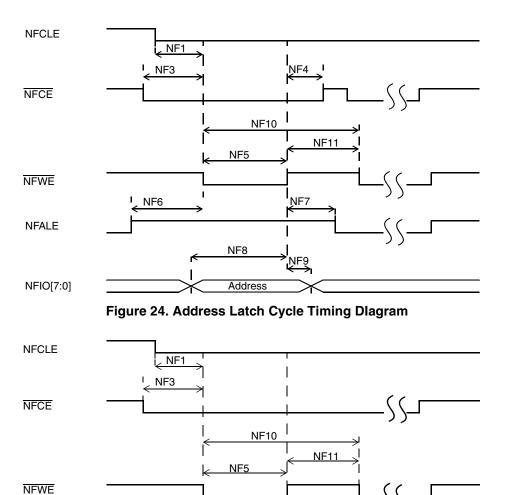


Figure 25. Write Data Latch Cycle Timing Dlagram

NF8

Data to NF

NF7

NF6

NFALE

NFIO[15:0]

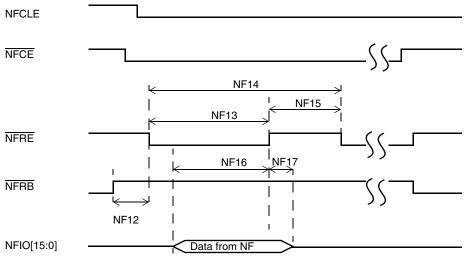


Figure 26. Read Data Latch Cycle Timing Dlagram

Table 32. NFC Timing Parameters¹

ID	Parameter	Symbol		ming Clock Cycle ²	Example Tir NFC Clock ≈ T = 30	33 MHz	Unit
			Min	Max	Min	Max	
NF1	NFCLE Setup Time	tCLS	T-1.0 ns	_	29	_	ns
NF2	NFCLE Hold Time	tCLH	T-2.0 ns		28	_	ns
NF3	NFCE Setup Time	tCS	T-1.0 ns		29	_	ns
NF4	NFCE Hold Time	tCH	T-2.0 ns		28	_	ns
NF5	NF_WP Pulse Width	tWP	T–1.5 ns		28.5		ns
NF6	NFALE Setup Time	tALS	Т	_	30	_	ns
NF7	NFALE Hold Time	tALH	T-3.0 ns	_	27	_	ns
NF8	Data Setup Time	tDS	Т	_	30	_	ns
NF9	Data Hold Time	tDH	T-5.0 ns	_	25	_	ns
NF10	Write Cycle Time	tWC	:	2T 60			ns
NF11	NFWE Hold Time	tWH	T-2	T–2.5 ns 27.5		j	ns
NF12	Ready to NFRE Low	tRR	6T	_	180	_	ns
NF13	NFRE Pulse Width	tRP	1.5T	_	45	_	ns
NF14	READ Cycle Time	tRC	2T	_	60	_	ns
NF15	NFRE High Hold Time	tREH	0.5T–2.5 ns		12.5	_	ns
NF16	Data Setup on READ	tDSR	١	N/A	10	_	ns
NF17	Data Hold on READ	tDHR	١	N/A	0	_	ns

¹ The flash clock maximum frequency is 50 MHz.

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² Subject to DPLL jitter specification on Table 31, "DPLL Specifications," on page 37.

NOTE

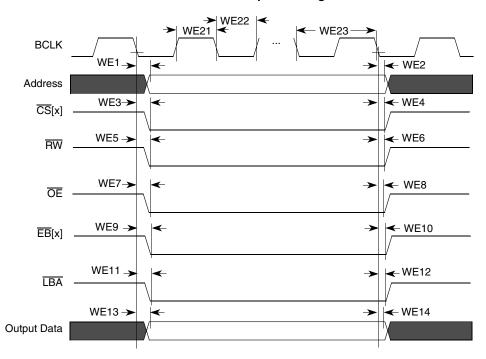
High is defined as 80% of signal value and low is defined as 20% of signal value.

Timing for HCLK is 133 MHz and internal NFC clock (flash clock) is approximately 33 MHz (30 ns). All timings are listed according to this NFC clock frequency (multiples of NFC clock phases), except NF16 and NF17, which are not NFC clock related.

4.3.9.2 Wireless External Interface Module (WEIM)

All WEIM output control signals may be asserted and deasserted by internal clock related to BCLK rising edge or falling edge according to corresponding assertion/negation control fields. Address always begins related to BCLK falling edge but may be ended both on rising and falling edge in muxed mode according to control register configuration. Output data begins related to BCLK rising edge except in muxed mode where both rising and falling edge may be used according to control register configuration. Input data, ECB and DTACK all captured according to BCLK rising edge time. Figure 27 depicts the timing of the WEIM module, and Table 33 lists the timing parameters.

WEIM Outputs Timing



WEIM Inputs Timing

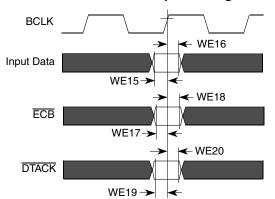


Figure 27. WEIM Bus Timing Diagram

Table 33. WEIM Bus Timing Parameters

ID	Parameter	Min	Max	Unit
WE1	Clock fall to Address Valid	-0.5	2.5	ns
WE2	Clock rise/fall to Address Invalid	-0.5	5	ns
WE3	Clock rise/fall to CS[x] Valid	-3	3	ns
WE4	Clock rise/fall to CS[x] Invalid	-3	3	ns
WE5	Clock rise/fall to RW Valid	-3	3	ns
WE6	Clock rise/fall to RW Invalid	-3	3	ns
WE7	Clock rise/fall to OE Valid	-3	3	ns

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Table 33. WEIM Bus Timing Parameters (continued)

ID	Parameter	Min	Max	Unit
WE8	Clock rise/fall to OE Invalid	-3	3	ns
WE9	Clock rise/fall to EB[x] Valid	-3	3	ns
WE10	Clock rise/fall to EB[x] Invalid	-3	3	ns
WE11	Clock rise/fall to LBA Valid	-3	3	ns
WE12	Clock rise/fall to LBA Invalid	-3	3	ns
WE13	Clock rise/fall to Output Data Valid	-2.5	4	ns
WE14	Clock rise to Output Data Invalid	-2.5	4	ns
WE15	Input Data Valid to Clock rise, FCE=0 FCE=1	8 2.5	_	ns
WE16	Clock rise to Input Data Invalid, FCE=0 FCE=1	-2 -2	_	ns
WE17	ECB setup time, FCE=0 FCE=1	6.5 3.5	_	ns
WE18	ECB hold time, FCE=0 FCE=1	-2 2	_	ns
WE19	DTACK setup time ¹	0	_	ns
WE20	DTACK hold time ¹	4.5	_	ns
WE21	BCLK High Level Width ^{2, 3}	_	T/2 - 3	ns
WE22	BCLK Low Level Width ^{2, 3}	_	T/2 - 3	ns
WE23	BCLK Cycle time ²	15	_	ns

¹ Applies to rising edge timing

NOTE

High is defined as 80% of signal value and low is defined as 20% of signal value.

Test conditions: load capacitance, 25 pF. Recommended drive strength for all controls, address, and BCLK is Max drive.

Figure 28, Figure 29, Figure 30, Figure 31, Figure 32, and Figure 33 depict some examples of basic WEIM accesses to external memory devices with the timing parameters mentioned in Table 33 for specific control parameter settings.

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² BCLK parameters are being measured from the 50% VDD.

³ The actual cycle time is derived from the AHB bus clock frequency.

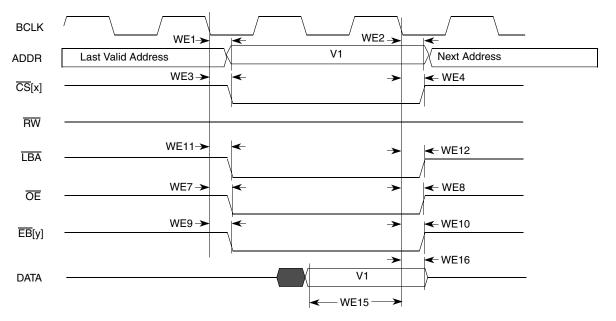


Figure 28. Asynchronous Memory Timing Diagram for Read Access—WSC=1

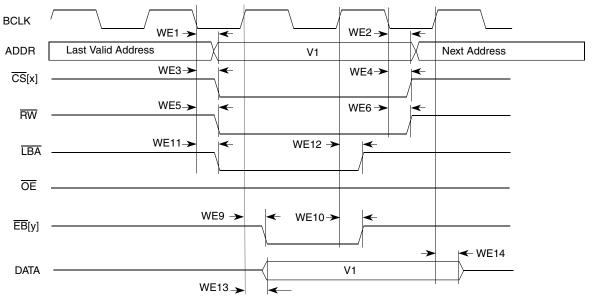


Figure 29. Asynchronous Memory Timing Diagram for Write Access— WSC=1, EBWA=1, EBWN=1, LBN=1

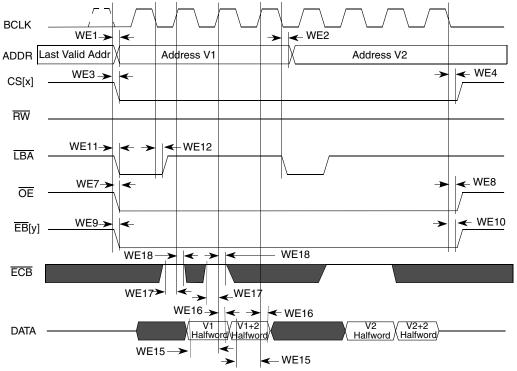


Figure 30. Synchronous Memory Timing Diagram for Two Non-Sequential Read Accesses—WSC=2, SYNC=1, DOL=0

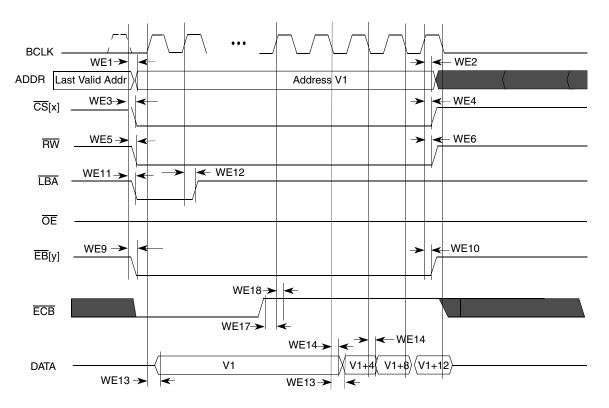


Figure 31. Synchronous Memory TIming Diagram for Burst Write Access—BCS=1, WSC=4, SYNC=1, DOL=0, PSR=1

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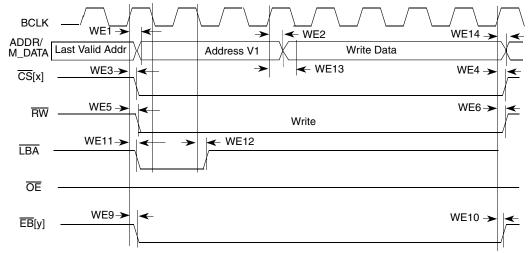


Figure 32. Muxed A/D Mode Timing Diagram for Asynchronous Write Access—WSC=7, LBA=1, LBN=1, LAH=1

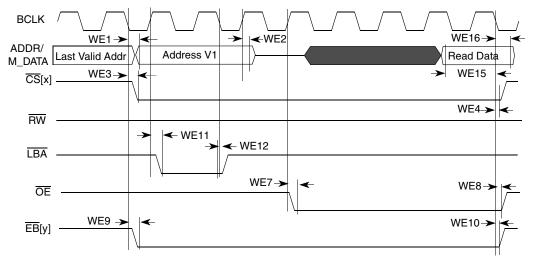


Figure 33. Muxed A/D Mode Timing Diagram for Asynchronous Read Access—WSC=7, LBA=1, LBN=1, LAH=1, OEA=7

4.3.9.3 ESDCTL Electrical Specifications

Figure 34, Figure 35, Figure 36, Figure 37, Figure 38, and Figure 39 depict the timings pertaining to the ESDCTL module, which interfaces Mobile DDR or SDR SDRAM. Table 34, Table 35, Table 36, Table 37, Table 38, and Table 39 list the timing parameters.

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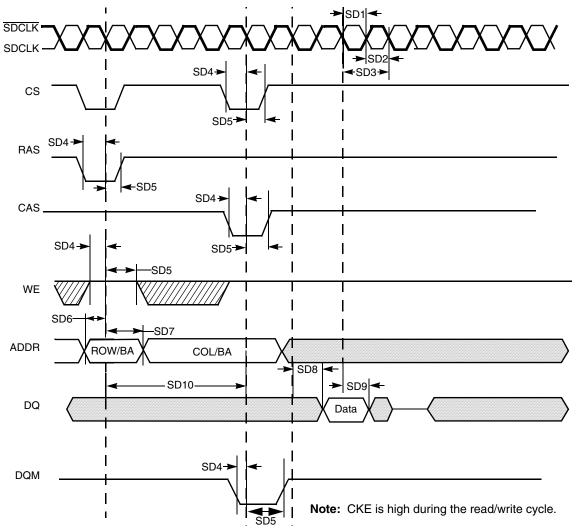


Figure 34. SDRAM Read Cycle Timing Diagram

Table 34. DDR/SDR SDRAM Read Cycle Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
SD1	SDRAM clock high-level width	tCH	3.4	4.1	ns
SD2	SDRAM clock low-level width	tCL	3.4	4.1	ns
SD3	SDRAM clock cycle time	tCK	7.5	_	ns
SD4	CS, RAS, CAS, WE, DQM, CKE setup time	tCMS	2.0	_	ns
SD5	CS, RAS, CAS, WE, DQM, CKE hold time	tCMH	1.8	_	ns
SD6	Address setup time	tAS	2.0	_	ns
SD7	Address hold time	tAH	1.8	_	ns
SD8	SDRAM access time	tAC	_	6.47	ns

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Table 34. DDR/SDR SDRAM Read Cycle Timing Parameters (continued)

ID	Parameter	Symbol	Min	Max	Unit
SD9	Data out hold time ¹	tOH	1.8	_	ns
SD10	Active to read/write command period	tRC	10		clock

Timing parameters are relevant only to SDR SDRAM. For the specific DDR SDRAM data related timing parameters, see Table 38 and Table 39.

NOTE

SDR SDRAM CLK parameters are being measured from the 50% point—that is, high is defined as 50% of signal value and low is defined as 50% of signal value. SD1 + SD2 does not exceed 7.5 ns for 133 MHz.

The timing parameters are similar to the ones used in SDRAM data sheets—that is, Table 34 indicates SDRAM requirements. All output signals are driven by the ESDCTL at the negative edge of SDCLK and the parameters are measured at maximum memory frequency.

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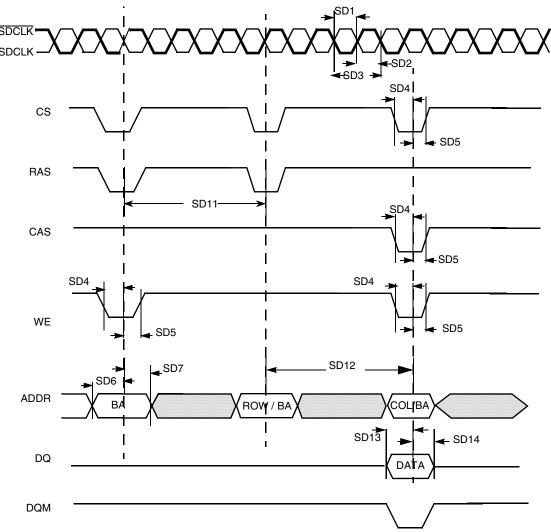


Figure 35. SDR SDRAM Write Cycle Timing Diagram

Table 35. SDR SDRAM Write Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
SD1	SDRAM clock high-level width	tCH	3.4	4.1	ns
SD2	SDRAM clock low-level width	tCL	3.4	4.1	ns
SD3	SDRAM clock cycle time	tCK	7.5	_	ns
SD4	CS, RAS, CAS, WE, DQM, CKE setup time	tCMS	2.0	_	ns
SD5	CS, RAS, CAS, WE, DQM, CKE hold time	tCMH	1.8	_	ns
SD6	Address setup time	tAS	2.0	_	ns
SD7	Address hold time	tAH	1.8	_	ns
SD11	Precharge cycle period ¹	tRP	1	4	clock
SD12	Active to read/write command delay ¹	tRCD	1	8	clock

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Table 35. SDR SDRAM Write Timing Parameters (continued)

ID	Parameter	Symbol	Min	Max	Unit
SD13	Data setup time	tDS	2.0	_	ns
SD14	Data hold time	tDH	1.3	_	ns

¹ SD11 and SD12 are determined by SDRAM controller register settings.

NOTE

SDR SDRAM CLK parameters are being measured from the 50% point—that is, high is defined as 50% of signal value and low is defined as 50% of signal value.

The timing parameters are similar to the ones used in SDRAM data sheets—that is, Table 35 indicates SDRAM requirements. All output signals are driven by the ESDCTL at the negative edge of SDCLK and the parameters are measured at maximum memory frequency.

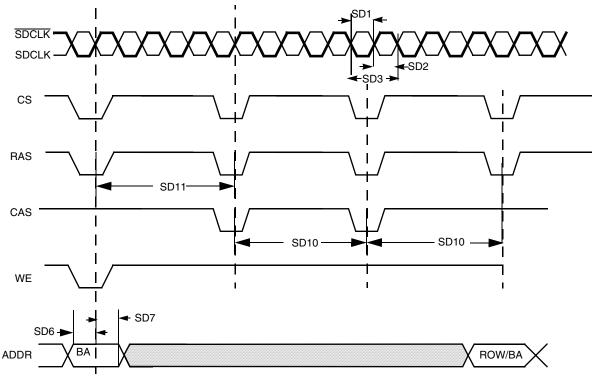


Figure 36. SDRAM Refresh Timing Diagram

Table 36. SDRAM Refresh Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
SD1	SDRAM clock high-level width	tCH	3.4	4.1	ns
SD2	SDRAM clock low-level width	tCL	3.4	4.1	ns

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Table 36. SDRAM Refresh Timing Parameters (continued)

ID	Parameter	Symbol	Min	Max	Unit
SD3	SDRAM clock cycle time	tCK	7.5	_	ns
SD6	Address setup time	tAS	1.8	_	ns
SD7	Address hold time	tAH	1.8	_	ns
SD10	Precharge cycle period ¹	tRP	1	4	clock
SD11	Auto precharge command period ¹	tRC	2	20	clock

¹ SD10 and SD11 are determined by SDRAM controller register settings.

NOTE

SDR SDRAM CLK parameters are being measured from the 50% point—that is, high is defined as 50% of signal value and low is defined as 50% of signal value.

The timing parameters are similar to the ones used in SDRAM data sheets—that is, Table 36 indicates SDRAM requirements. All output signals are driven by the ESDCTL at the negative edge of SDCLK and the parameters are measured at maximum memory frequency.

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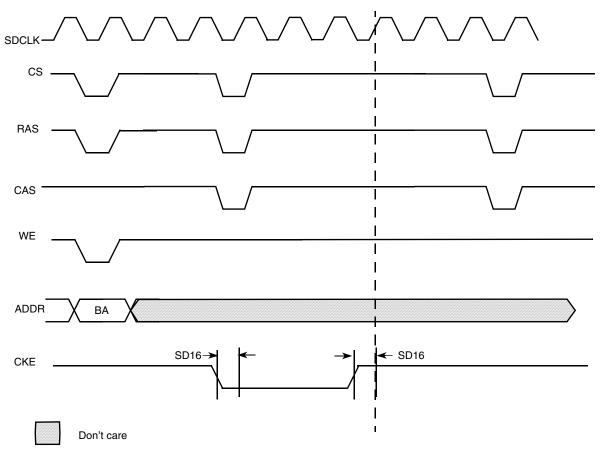


Figure 37. SDRAM Self-Refresh Cycle Timing Diagram

NOTE

The clock will continue to run unless both CKEs are low. Then the clock will be stopped in low state.

Table 37. SDRAM Self-Refresh Cycle Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
SD16	CKE output delay time	tCKS	1.8	_	ns

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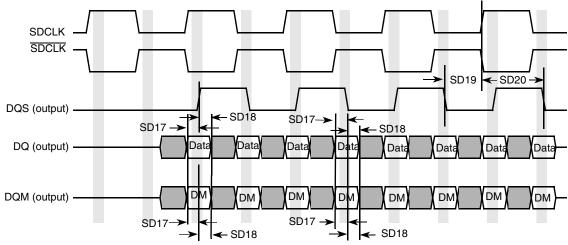


Figure 38. Mobile DDR SDRAM Write Cycle Timing Diagram

Table 38. Mobile DDR SDRAM Write Cycle Timing Parameters¹

ID	Parameter	Symbol	Min	Max	Unit
SD17	DQ and DQM setup time to DQS	tDS	0.95	_	ns
SD18	DQ and DQM hold time to DQS	tDH	0.95	_	ns
SD19	Write cycle DQS falling edge to SDCLK output delay time.	tDSS	1.8	_	ns
SD20	Write cycle DQS falling edge to SDCLK output hold time.	tDSH	1.8	_	ns

¹ Test condition: Measured using delay line 5 programmed as follows: ESDCDLY5[15:0] = 0x0703.

NOTE

SDRAM CLK and DQS related parameters are being measured from the 50% point—that is, high is defined as 50% of signal value and low is defined as 50% of signal value.

The timing parameters are similar to the ones used in SDRAM data sheets—that is, Table 38 indicates SDRAM requirements. All output signals are driven by the ESDCTL at the negative edge of SDCLK and the parameters are measured at maximum memory frequency.

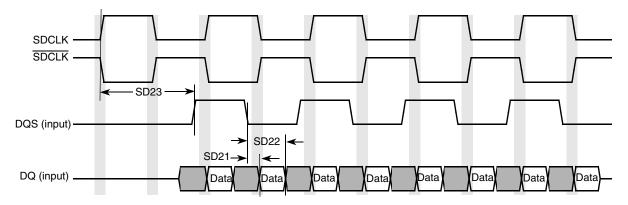


Figure 39. Mobile DDR SDRAM DQ versus DQS and SDCLK Read Cycle Timing Diagram

Table 39. Mobile DDR SDRAM Read Cycle Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
SD21	DQS – DQ Skew (defines the Data valid window in read cycles related to DQS).	tDQSQ	_	0.85	ns
SD22	DQS DQ HOLD time from DQS	tQH	2.3	_	ns
SD23	DQS output access time from SDCLK posedge	tDQSCK	_	6.7	ns

NOTE

SDRAM CLK and DQS related parameters are being measured from the 50% point—that is, high is defined as 50% of signal value and low is defined as 50% of signal value.

The timing parameters are similar to the ones used in SDRAM data sheets—that is, Table 39 indicates SDRAM requirements. All output signals are driven by the ESDCTL at the negative edge of SDCLK and the parameters are measured at maximum memory frequency.

4.3.10 ETM Electrical Specifications

ETM is an ARM protocol. The timing specifications in this section are given as a guide for a TPA that supports TRACECLK frequencies up to 133 MHz.

Figure 40 depicts the TRACECLK timings of ETM, and Table 40 lists the timing parameters.

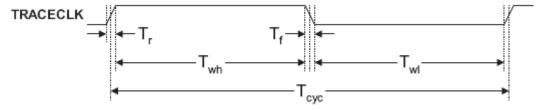


Figure 40. ETM TRACECLK Timing Diagram

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ID	Parameter	Min	Max	Unit
T _{cyc}	Clock period	Frequency dependent	_	ns
T _{wl}	Low pulse width	2	_	ns
T _{wh}	High pulse width	2	_	ns
T _r	Clock and data rise time	_	3	ns
T _f	Clock and data fall time	_	3	ns

Table 40. ETM TRACECLK Timing Parameters

Figure 41 depicts the setup and hold requirements of the trace data pins with respect to TRACECLK, and Table 41 lists the timing parameters.

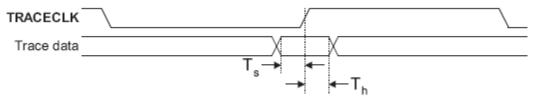


Figure 41. Trace Data Timing Diagram

Table 41. ETM Trace Data Timing Parameters

ID	Parameter	Min	Max	Unit
T _s	Data setup	2	_	ns
T _h	Data hold	1		ns

4.3.10.1 Half-Rate Clocking Mode

When half-rate clocking is used, the trace data signals are sampled by the TPA on both the rising and falling edges of TRACECLK, where TRACECLK is half the frequency of the clock shown in Figure 41.

4.3.11 FIR Electrical Specifications

FIR implements asynchronous infrared protocols (FIR, MIR) that are defined by IrDA[®] (Infrared Data Association). Refer to http://www.IrDA.org for details on FIR and MIR protocols.

4.3.12 Fusebox Electrical Specifications

Table 42. Fusebox Timing Characteristics

Ref. Num	Description	Symbol	Minimum	Typical	Maximum	Units
1	Program time for eFuse ¹	t _{program}	125		_	μs

The program length is defined by the value defined in the epm_pgm_length[2:0] bits of the IIM module. The value to program is based on a 32 kHz clock source ($4 * 1/32 \text{ kHz} = 125 \mu \text{s}$).

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4.3.13 I²C Electrical Specifications

This section describes the electrical information of the I²C Module.

4.3.13.1 I²C Module Timing

Figure 42 depicts the timing of I^2C module. Table 43 lists the I^2C module timing parameters where the I/O supply is 2.7 V. 1

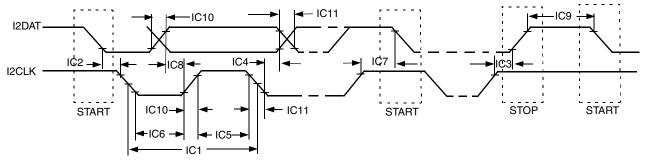


Figure 42. I²C Bus Timing Diagram

Table 43. I²C Module Timing Parameters—I²C Pin I/O Supply=2.7 V

ID	Parameter	Standard	d Mode	Fast M	Fast Mode	
טו	Parameter	Min	Max	Min	Max	Unit
IC1	I2CLK cycle time	10	_	2.5	_	μS
IC2	Hold time (repeated) START condition	4.0	_	0.6	_	μS
IC3	Set-up time for STOP condition	4.0	_	0.6	_	μS
IC4	Data hold time	01	3.45 ²	0 ¹	0.9 ²	μS
IC5	HIGH Period of I2CLK Clock	4.0	_	0.6	_	μS
IC6	LOW Period of the I2CLK Clock	4.7	_	1.3	_	μS
IC7	Set-up time for a repeated START condition	4.7	_	0.6	_	μS
IC8	Data set-up time	250	_	100 ³	_	ns
IC9	Bus free time between a STOP and START condition	4.7	_	1.3	_	μS
IC10	Rise time of both I2DAT and I2CLK signals	_	1000	20+0.1C _b ⁴	300	ns
IC11	Fall time of both I2DAT and I2CLK signals	_	300	20+0.1C _b ⁴	300	ns
IC12	Capacitive load for each bus line (C _b)	_	400	_	400	pF

¹ A device must internally provide a hold time of at least 300 ns for I2DAT signal in order to bridge the undefined region of the falling edge of I2CLK.

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² The maximum hold time has to be met only if the device does not stretch the LOW period (ID IC6) of the I2CLK signal.

A Fast-mode I²C-bus device can be used in a standard-mode I²C-bus system, but the requirement of set-up time (ID IC7) of 250 ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the I2CLK signal. If such a device does stretch the LOW period of the I2CLK signal, it must output the next data bit to the I2DAT line max_rise_time (ID No IC10) + data_setup_time (ID No IC8) = 1000 + 250 = 1250 ns (according to the Standard-mode I²C-bus specification) before the I2CLK line is released.

 $^{^4}$ $C_b = total$ capacitance of one bus line in pF.

4.3.14 IPU—Sensor Interfaces

4.3.14.1 Supported Camera Sensors

Table 44 lists the known supported camera sensors at the time of publication.

Table 44. Supported Camera Sensors¹

Vendor	Model
Conexant	CX11646, CX20490 ² , CX20450 ²
Agilant	HDCP-2010, ADCS-1021 ² , ADCS-1021 ²
Toshiba	TC90A70
ICMedia	ICM202A, ICM102 ²
iMagic	IM8801
Transchip	TC5600, TC5600J, TC5640, TC5700, TC6000
Fujitsu	MB86S02A
Micron	MI-SOC-0133
Matsushita	MN39980
STMicro	W6411, W6500, W6501 ² , W6600 ² , W6552 ² , STV0974 ²
OmniVision	OV7620, OV6630
Sharp	LZ0P3714 (CCD)
Motorola	MC30300 (Python) ² , SCM20014 ² , SCM20114 ² , SCM22114 ² , SCM20027 ²
National Semiconductor	LM9618 ²

Freescale Semiconductor does not recommend one supplier over another and in no way suggests that these are the only camera suppliers.

4.3.14.2 Functional Description

There are three timing modes supported by the IPU.

4.3.14.2.1 Pseudo BT.656 Video Mode

Smart camera sensors, which include imaging processing, usually support video mode transfer. They use an embedded timing syntax to replace the SENSB_VSYNC and SENSB_HSYNC signals. The timing syntax is defined by the BT.656 standard.

This operation mode follows the recommendations of ITU BT.656 specifications. The only control signal used is SENSB_PIX_CLK. Start-of-frame and active-line signals are embedded in the data stream. An active line starts with a SAV code and ends with a EAV code. In some cases, digital blanking is inserted in between EAV and SAV code. The CSI decodes and filters out the timing-coding from the data stream, thus recovering SENSB_VSYNC and SENSB_HSYNC signals for internal use.

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² These sensors not validated at time of publication.

4.3.14.2.2 Gated Clock Mode

The SENSB_VSYNC, SENSB_HSYNC, and SENSB_PIX_CLK signals are used in this mode. See Figure 43.

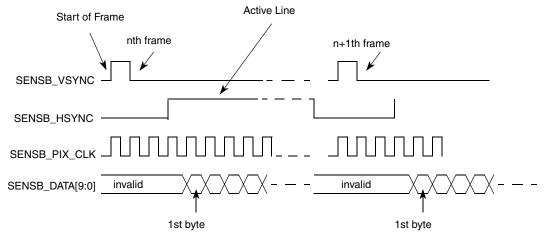


Figure 43. Gated Clock Mode Timing Diagram

A frame starts with a rising edge on SENSB_VSYNC (all the timings correspond to straight polarity of the corresponding signals). Then SENSB_HSYNC goes to high and hold for the entire line. Pixel clock is valid as long as SENSB_HSYNC is high. Data is latched at the rising edge of the valid pixel clocks. SENSB_HSYNC goes to low at the end of line. Pixel clocks then become invalid and the CSI stops receiving data from the stream. For next line the SENSB_HSYNC timing repeats. For next frame the SENSB_VSYNC timing repeats.

4.3.14.2.3 Non-Gated Clock Mode

The timing is the same as the gated-clock mode (described in Section 4.3.14.2.2, "Gated Clock Mode"), except for the SENSB_HSYNC signal, which is not used. See Figure 44. All incoming pixel clocks are valid and will cause data to be latched into the input FIFO. The SENSB_PIX_CLK signal is inactive (states low) until valid data is going to be transmitted over the bus.

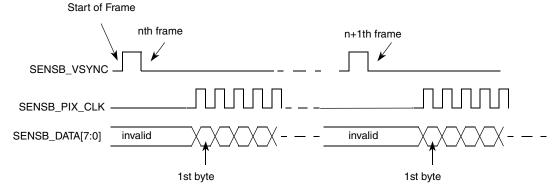


Figure 44. Non-Gated Clock Mode Timing Diagram

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The timing described in Figure 44 is that of a Motorola sensor. Some other sensors may have a slightly different timing. The CSI can be programmed to support rising/falling-edge triggered SENSB_VSYNC; active-high/low SENSB_HSYNC; and rising/falling-edge triggered SENSB_PIX_CLK.

4.3.14.3 Electrical Characteristics

Figure 45 depicts the sensor interface timing, and Table 45 lists the timing parameters.

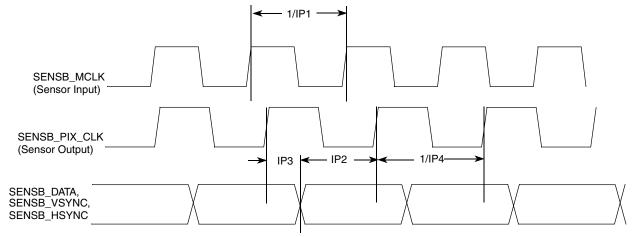


Figure 45. Sensor Interface Timing Diagram

Table 45. Sensor Interface Timing Parameters¹

ID	Parameter	Symbol	Min.	Max.	Units
IP1	Sensor input clock frequency	Fmck	0.01	133	MHz
IP2	Data and control setup time	Tsu	5	_	ns
IP3	Data and control holdup time	Thd	3	_	ns
IP4	Sensor output (pixel) clock frequency	Fpck	0.01	133	MHz

The timing specifications for Figure 45 are referenced to the rising edge of SENS_PIX_CLK when the SENS_PIX_CLK_POL bit in the CSI_SENS_CONF register is cleared. When the SENS_PIX_CLK_POL is set, the clock is inverted and all timing specifications will remain the same but are referenced to the falling edge of the clock.

4.3.15 IPU—Display Interfaces

4.3.15.1 Supported Display Components

Table 46 lists the known supported display components at the time of publication.

Table 46. Supported Display Components¹

Туре	Vendor	Model			
TFT displays (memory-less)	Sharp (HR-TFT Super Mobile LCD family)	LQ035Q7 DB02, LM019LC1Sxx			
	Samsung (QCIF and QVGA TFT modules for mobile phones)	LTS180S1-HF1, LTS180S3-HF1, LTS350Q1-PE1, LTS350Q1-PD1, LTS220Q1-HE1 ²			
	Toshiba (LTM series)	LTM022P806 ² , LTM04C380K ² , LTM018A02A ² , LTM020P332 ² , LTM021P337 ² , LTM019P334 ² , LTM022A783 ² , LTM022A05ZZ ²			
	NEC	NL6448BC20-08E, NL8060BC31-27			
Display controllers	Epson	S1D15xxx series, S1D19xxx series, S1D13713, S1D13715			
	Solomon Systech	SSD1301 (OLED), SSD1828 (LDCD)			
	Hitachi	HD66766, HD66772			
	ATI	W2300			
Smart display modules	Epson	L1F10043 T ² , L1F10044 T ² , L1F10045 T ² , L2D22002 ² , L2D20014 ² , L2F50032 ² , L2D25001 T ²			
	Hitachi	120 160 65K/4096 C-STN (#3284 LTD-1398-2) based on HD 66766 controller			
	Densitron Europe LTD	All displays with MPU 80/68K series interface and serial peripheral interface			
	Sharp	LM019LC1Sxx			
	Sony	ACX506AKM			
Digital video encoders	Analog Devices	ADV7174/7179			
(for TV)	Crystal (Cirrus Logic)	CS49xx series			
	Focus	FS453/4			

Freescale Semiconductor does not recommend one supplier over another and in no way suggests that these are the only display component suppliers.

4.3.15.2 Synchronous Interfaces

4.3.15.2.1 Interface to Active Matrix TFT LCD Panels, Functional Description

Figure 46 depicts the LCD interface timing for a generic active matrix color TFT panel. In this figure signals are shown with negative polarity. The sequence of events for active matrix interface timing is:

- DISPB_D3_CLK latches data into the panel on its negative edge (when positive polarity is selected). In active mode, DISPB_D3_CLK runs continuously.
- DISPB_D3_HSYNC causes the panel to start a new line.
- DISPB_D3_VSYNC causes the panel to start a new frame. It always encompasses at least one HSYNC pulse.

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² These display components not validated at time of publication.

• DISPB_D3_DRDY acts like an output enable signal to the CRT display. This output enables the data to be shifted onto the display. When disabled, the data is invalid and the trace is off.

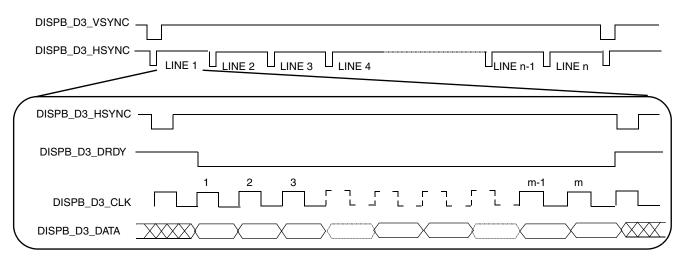


Figure 46. Interface Timing Diagram for TFT (Active Matrix) Panels

4.3.15.2.2 Interface to Active Matrix TFT LCD Panels, Electrical Characteristics

Figure 47 depicts the horizontal timing (timing of one line), including both the horizontal sync pulse and the data. All figure parameters shown are programmable. The timing images correspond to inverse polarity of the DISPB_D3_CLK signal and active-low polarity of the DISPB_D3_HSYNC, DISPB_D3_VSYNC and DISPB_D3_DRDY signals.

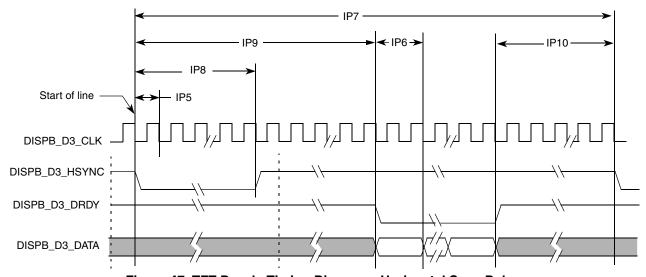


Figure 47. TFT Panels Timing Diagram—Horizontal Sync Pulse

Figure 48 depicts the vertical timing (timing of one frame). All figure parameters shown are programmable.

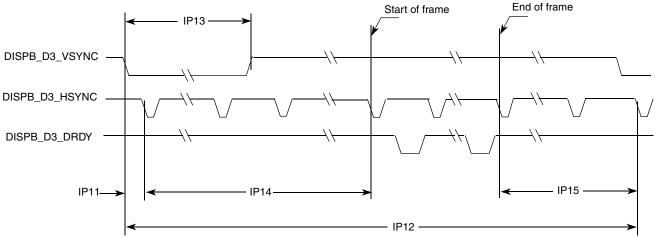


Figure 48. TFT Panels Timing Diagram—Vertical Sync Pulse

Table 47 shows timing parameters of signals presented in Figure 47 and Figure 48.

Table 47. Synchronous Display Interface Timing Parameters—Pixel Level

ID	Parameter	Symbol	Value	Units
IP5	Display interface clock period	Tdicp	Tdicp ¹	ns
IP6	Display pixel clock period	Tdpcp	(DISP3_IF_CLK_CNT_D+1) * Tdicp	ns
IP7	Screen width	Tsw	(SCREEN_WIDTH+1) * Tdpcp	ns
IP8	HSYNC width	Thsw	(H_SYNC_WIDTH+1) * Tdpcp	ns
IP9	Horizontal blank interval 1	Thbi1	BGXP * Tdpcp	ns
IP10	Horizontal blank interval 2	Thbi2	(SCREEN_WIDTH - BGXP - FW) * Tdpcp	ns
IP11	HSYNC delay	Thsd	H_SYNC_DELAY * Tdpcp	ns
IP12	Screen height	Tsh	(SCREEN_HEIGHT+1) * Tsw	ns
IP13	VSYNC width	Tvsw	if V_SYNC_WIDTH_L = 0 than (V_SYNC_WIDTH+1) * Tdpcp else (V_SYNC_WIDTH+1) * Tsw	ns
IP14	Vertical blank interval 1	Tvbi1	BGYP * Tsw	ns
IP15	Vertical blank interval 2	Tvbi2	(SCREEN_HEIGHT – BGYP – FH) * Tsw	ns

Display interface clock period immediate value.

$$Tdicp = \begin{cases} T_{\mbox{HSP_CLK}} \cdot \frac{\mbox{DISP3_IF_CLK_PER_WR}}{\mbox{HSP_CLK_PERIOD}}, & \mbox{for integer} & \frac{\mbox{DISP3_IF_CLK_PER_WR}}{\mbox{HSP_CLK_PERIOD}} \\ T_{\mbox{HSP_CLK}} \cdot \left(\mbox{floor} \left[\frac{\mbox{DISP3_IF_CLK_PER_WR}}{\mbox{HSP_CLK_PERIOD}} \right] + 0.5 \pm 0.5 \right), & \mbox{for fractional} & \frac{\mbox{DISP3_IF_CLK_PER_WR}}{\mbox{HSP_CLK_PERIOD}} \end{cases}$$

Display interface clock period average value.

$$\overline{T}$$
dicp = $T_{HSP_CLK} \cdot \frac{DISP3_IF_CLK_PER_WR}{HSP_CLK_PERIOD}$

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NOTE

HSP_CLK is the High-Speed Port Clock, which is the input to the Image Processing Unit (IPU). Its frequency is controlled by the Clock Control Module (CCM) settings. The HSP_CLK frequency must be greater than or equal to the AHB clock frequency.

The SCREEN_WIDTH, SCREEN_HEIGHT, H_SYNC_WIDTH, V_SYNC_WIDTH, BGXP, BGYP and V_SYNC_WIDTH_L parameters are programmed via the SDC_HOR_CONF, SDC_VER_CONF, SDC_BG_POS Registers. The FW and FH parameters are programmed for the corresponding DMA channel. The DISP3_IF_CLK_PER_WR, HSP_CLK_PERIOD and DISP3_IF_CLK_CNT_D parameters are programmed via the DI_DISP3_TIME_CONF, DI_HSP_CLK_PER and DI_DISP_ACC_CC Registers.

Figure 49 depicts the synchronous display interface timing for access level, and Table 48 lists the timing parameters. The DISP3_IF_CLK_DOWN_WR and DISP3_IF_CLK_UP_WR parameters are set via the DI_DISP3_TIME_CONF Register.

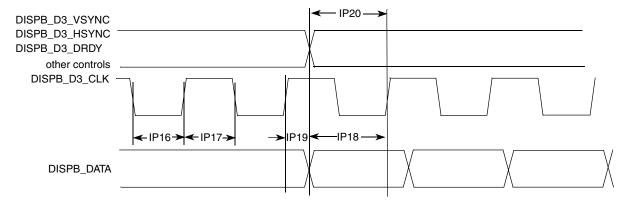


Figure 49. Synchronous Display Interface Timing Diagram—Access Level

Table 48. Synchronous Display Interface Timing Parameters—Access Level

ID	Parameter	Symbol	Min	Typ ¹	Max	Units
IP16	Display interface clock low time	Tckl	Tdicd-Tdicu-1.5	Tdicd ² -Tdicu ³	Tdicd-Tdicu+1.5	ns
IP17	Display interface clock high time	Tckh	Tdicp-Tdicd+Tdicu-1.5	Tdicp-Tdicd+Tdicu	Tdicp-Tdicd+Tdicu+1.5	ns
IP18	Data setup time	Tdsu	Tdicd-3.5	Tdicu	_	ns
IP19	Data holdup time	Tdhd	Tdicp-Tdicd-3.5	Tdicp-Tdicu	_	ns
IP20	Control signals setup time to display interface clock	Tcsu	Tdicd-3.5	Tdicu	_	ns

The exact conditions have not been finalized, but will likely match the current customer requirement for their specific display. These conditions may be device specific.

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Display interface clock down time

$$\label{eq:dicd} \text{'dicd} = \frac{1}{2} T_{\text{HSP_CLK}} \cdot \text{ceil} \bigg[\frac{2 \cdot \text{DISP3_IF_CLK_DOWN_WR}}{\text{HSP_CLK_PERIOD}} \bigg]$$

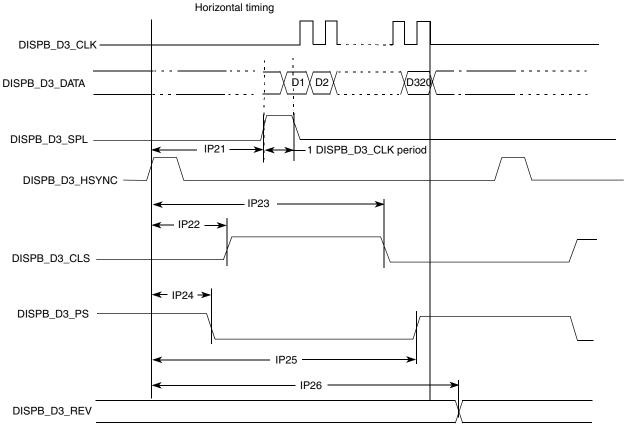
3 Display interface clock up time

$$Tdicu = \frac{1}{2}T_{\text{HSP_CLK}} \cdot ceil \left[\frac{2 \cdot \text{DISP3_IF_CLK_UP_WR}}{\text{HSP_CLK_PERIOD}} \right]$$

where CEIL(X) rounds the elements of X to the nearest integers towards infinity.

4.3.15.3 Interface to Sharp HR-TFT Panels

Figure 50 depicts the Sharp HR-TFT panel interface timing, and Table 49 lists the timing parameters. The CLS_RISE_DELAY, CLS_FALL_DELAY, PS_FALL_DELAY, PS_RISE_DELAY, REV_TOGGLE_DELAY parameters are defined in the SDC_SHARP_CONF_1 and SDC_SHARP_CONF_2 registers. For other Sharp interface timing characteristics, refer to Section 4.3.15.2.2, "Interface to Active Matrix TFT LCD Panels, Electrical Characteristics." The timing images correspond to straight polarity of the Sharp signals.



Example is drawn with FW+1=320 pixel/line, FH+1=240 lines. SPL pulse width is fixed and aligned to the first data of the line. REV toggles every HSYNC period.

Figure 50. Sharp HR-TFT Panel Interface Timing Diagram—Pixel Level

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ID **Units Parameter Symbol** Value IP21 SPL rise time Tsplr (BGXP - 1) * Tdpcp ns CLS_RISE_DELAY * Tdpcp IP22 CLS rise time Tclsr ns IP23 CLS fall time Tclsf CLS_FALL_DELAY * Tdpcp ns IP24 CLS rise and PS fall time Tpsf PS_FALL_DELAY * Tdpcp ns IP25 PS rise time PS_RISE_DELAY * Tdpcp **Tpsr** ns IP26 REV toggle time Trev REV_TOGGLE_DELAY * Tdpcp ns

Table 49. Sharp Synchronous Display Interface Timing Parameters—Pixel Level

4.3.15.4 Synchronous Interface to Dual-Port Smart Displays

Functionality and electrical characteristics of the synchronous interface to dual-port smart displays are identical to parameters of the synchronous interface. See Section 4.3.15.2.2, "Interface to Active Matrix TFT LCD Panels, Electrical Characteristics."

4.3.15.4.1 Interface to a TV Encoder, Functional Description

The interface has an 8-bit data bus, transferring a single 8-bit value (Y/U/V) in each cycle. The bits D7–D0 of the value are mapped to bits LD17–LD10 of the data bus, respectively. Figure 51 depicts the interface timing,

- The frequency of the clock DISPB_D3_CLK is 27 MHz (within 10%).
- The DISPB_D3_HSYNC, DISPB_D3_VSYNC and DISPB_D3_DRDY signals are active low.
- The transition to the next row is marked by the negative edge of the DISPB_D3_HSYNC signal. It remains low for a single clock cycle.
- The transition to the next field/frame is marked by the negative edge of the DISPB_D3_VSYNC signal. It remains low for at least one clock cycle.
 - At a transition to an odd field (of the next frame), the negative edges of DISPB_D3_VSYNC and DISPB_D3_HSYNC coincide.
 - At a transition to an even field (of the same frame), they do not coincide.
- The active intervals—during which data is transferred—are marked by the DISPB_D3_HSYNC signal being high.

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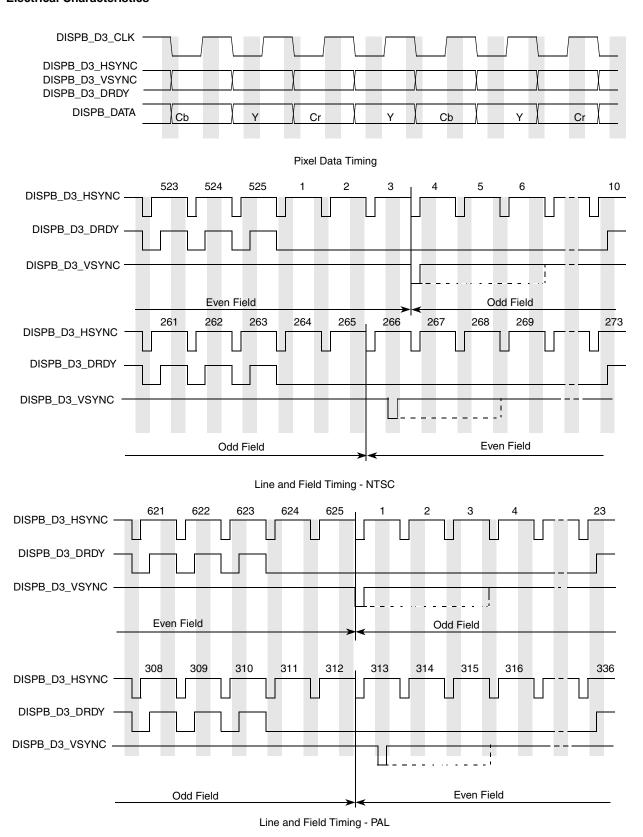


Figure 51. TV Encoder Interface Timing Diagram

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4.3.15.4.2 Interface to a TV Encoder, Electrical Characteristics

The timing characteristics of the TV encoder interface are identical to the synchronous display characteristics. See Section 4.3.15.2.2, "Interface to Active Matrix TFT LCD Panels, Electrical Characteristics."

4.3.15.5 Asynchronous Interfaces

4.3.15.5.1 Parallel Interfaces, Functional Description

The IPU supports the following asynchronous parallel interfaces:

- System 80 interface
 - Type 1 (sampling with the chip select signal) with and without byte enable signals.
 - Type 2 (sampling with the read and write signals) with and without byte enable signals.
- System 68k interface
 - Type 1 (sampling with the chip select signal) with or without byte enable signals.
 - Type 2 (sampling with the read and write signals) with or without byte enable signals.

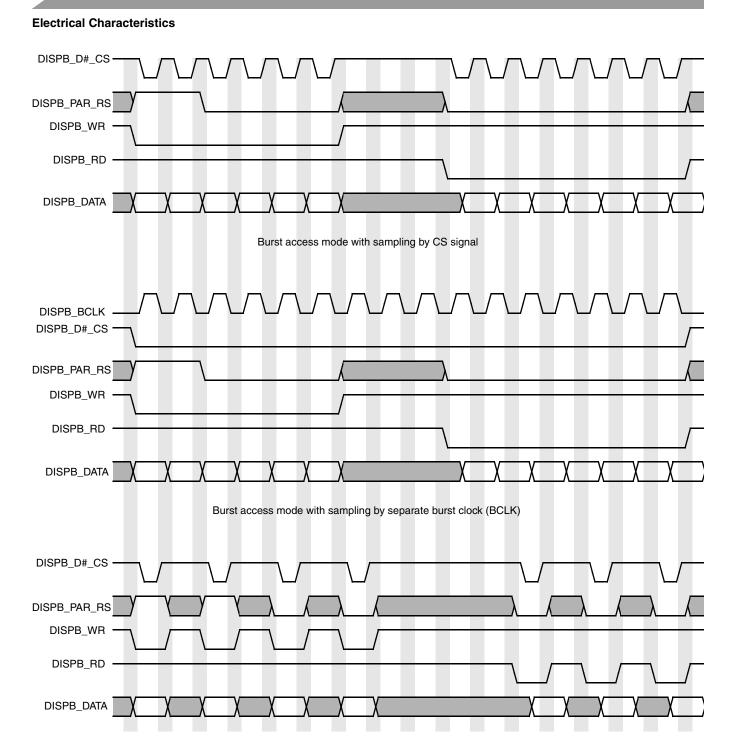
For each of four system interfaces, there are three burst modes:

- 1. Burst mode without a separate clock. The burst length is defined by the corresponding parameters of the IDMAC (when data is transferred from the system memory) of by the HBURST signal (when the MCU directly accesses the display via the slave AHB bus). For system 80 and system 68k type 1 interfaces, data is sampled by the CS signal and other control signals changes only when transfer direction is changed during the burst. For type 2 interfaces, data is sampled by the WR/RD signals (system 80) or by the ENABLE signal (system 68k) and the CS signal stays active during the whole burst.
- 2. Burst mode with the separate clock DISPB_BCLK. In this mode, data is sampled with the DISPB_BCLK clock. The CS signal stays active during whole burst transfer. Other controls are changed simultaneously with data when the bus state (read, write or wait) is altered. The CS signals and other controls move to non-active state after burst has been completed.
- 3. Single access mode. In this mode, slave AHB and DMA burst are broken to single accesses. The data is sampled with CS or other controls according the interface type as described above. All controls (including CS) become non-active for one display interface clock after each access. This mode corresponds to the ATI single access mode.

Both system 80 and system 68k interfaces are supported for all described modes as depicted in Figure 52, Figure 53, Figure 54, and Figure 55. These timing images correspond to active-low DISPB_D#_CS, DISPB_D#_WR and DISPB_D#_RD signals.

Additionally, the IPU allows a programmable pause between two burst. The pause is defined in the HSP_CLK cycles. It allows to avoid timing violation between two sequential bursts or two accesses to different displays. The range of this pause is from 4 to 19 HSP_CLK cycles.

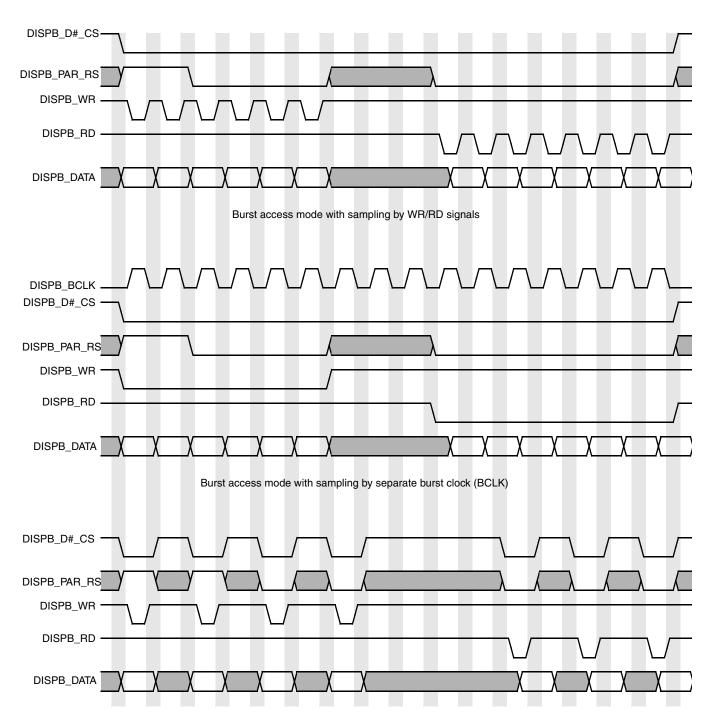
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Single access mode (all control signals are not active for one display interface clock after each display access)

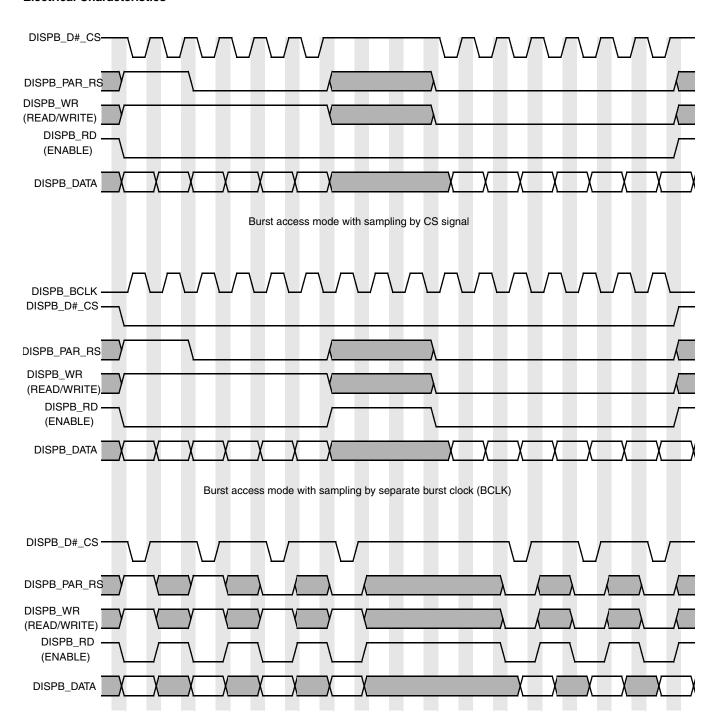
Figure 52. Asynchronous Parallel System 80 Interface (Type 1) Burst Mode Timing Diagram

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Single access mode (all control signals are not active for one display interface clock after each display access)

Figure 53. Asynchronous Parallel System 80 Interface (Type 2) Burst Mode Timing Diagram

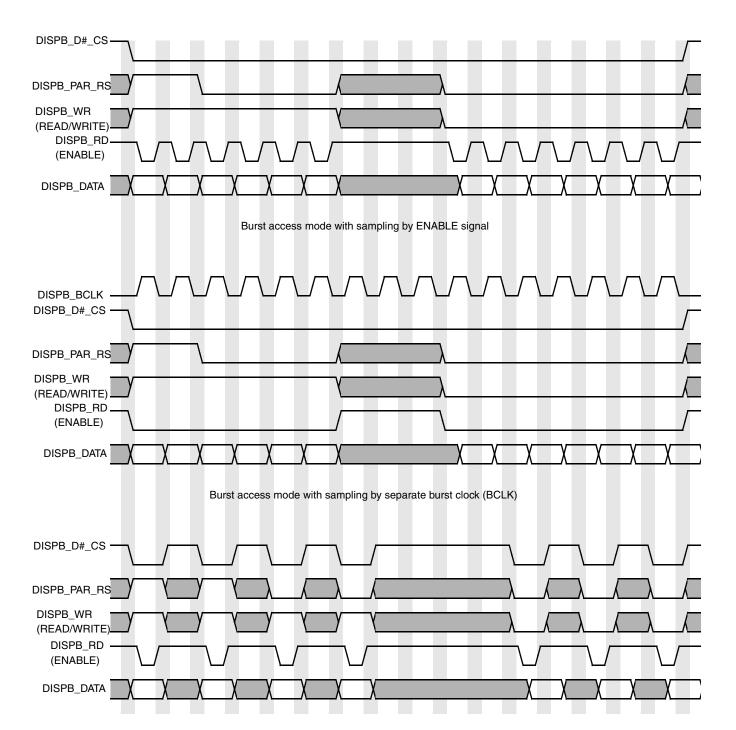


Single access mode (all control signals are not active for one display interface clock after each display access)

Figure 54. Asynchronous Parallel System 68k Interface (Type 1) Burst Mode Timing Diagram

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Single access mode (all control signals are not active for one display interface clock after each display access)

Figure 55. Asynchronous Parallel System 68k Interface (Type 2) Burst Mode Tlming Diagram

Display read operation can be performed with wait states when each read access takes up to four display interface clock cycles according to the DISP0_RD_WAIT_ST parameter in the DI_DISP0_TIME_CONF_3, DI_DISP1_TIME_CONF_3, DI_DISP2_TIME_CONF_3 Registers. Figure 56 shows timing of the parallel interface with read wait states.

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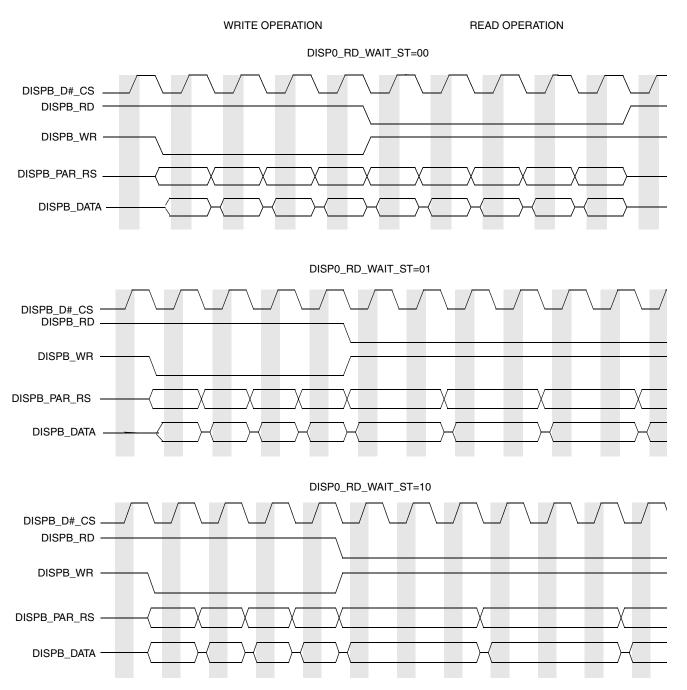


Figure 56. Parallel Interface Timing Diagram—Read Wait States

4.3.15.5.2 Parallel Interfaces, Electrical Characteristics

Figure 57, Figure 59, Figure 58, and Figure 60 depict timing of asynchronous parallel interfaces based on the system 80 and system 68k interfaces. Table 50 lists the timing parameters at display access level. All timing images are based on active low control signals (signals polarity is controlled via the DI_DISP_SIG_POL Register).

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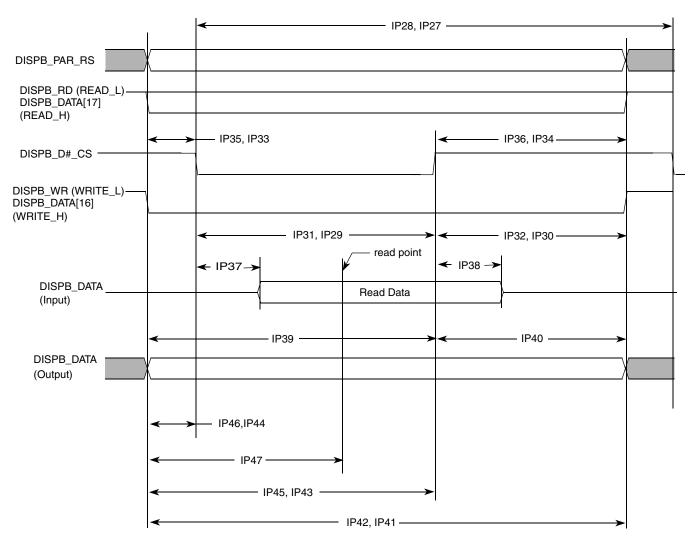


Figure 57. Asynchronous Parallel System 80 Interface (Type 1) Timing Diagram

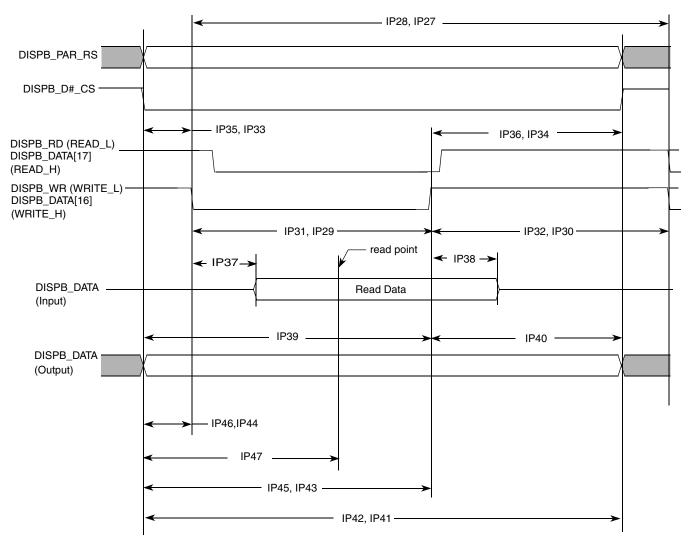


Figure 58. Asynchronous Parallel System 80 Interface (Type 2) Timing Diagram

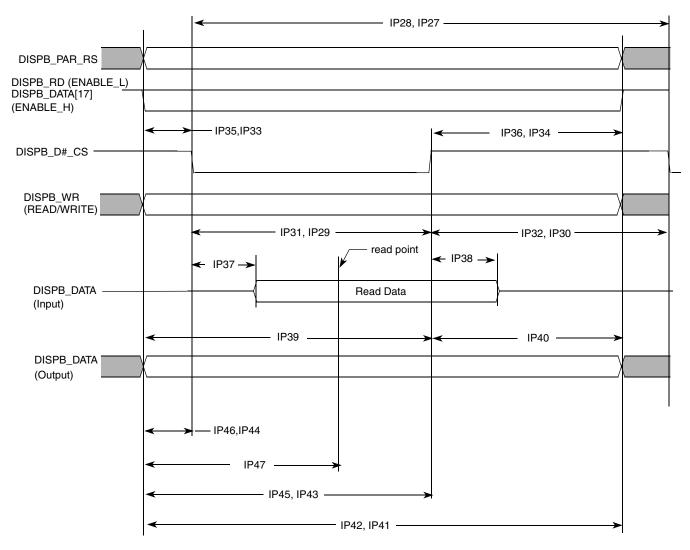


Figure 59. Asynchronous Parallel System 68k Interface (Type 1) Timing Diagram

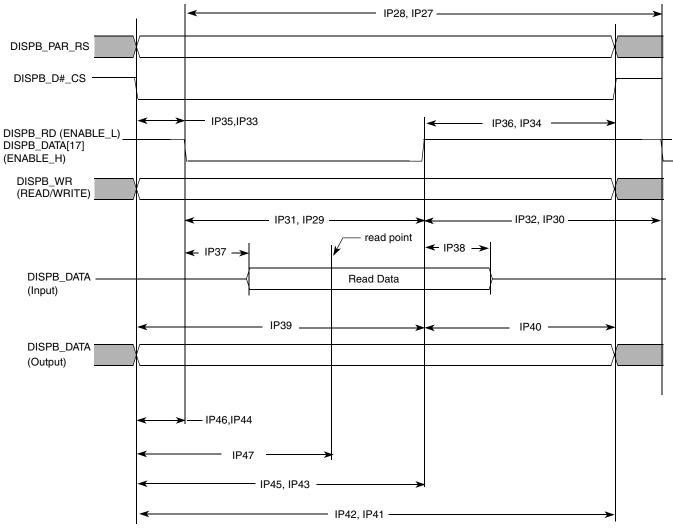


Figure 60. Asynchronous Parallel System 68k Interface (Type 2) Timing Diagram

Table 50. Asynchronous Parallel Interface Timing Parameters—Access Level

ID	Parameter	Symbol	Min.	Typ. ¹	Max.	Units
IP27	Read system cycle time	Tcycr	Tdicpr-1.5	Tdicpr ²	Tdicpr+1.5	ns
IP28	Write system cycle time	Tcycw	Tdicpw-1.5	Tdicpw ³	Tdicpw+1.5	ns
IP29	Read low pulse width	Trl	Tdicdr–Tdicur–1.5	Tdicdr ⁴ –Tdicur ⁵	Tdicdr–Tdicur+1.5	ns
IP30	Read high pulse width	Trh	Tdicpr–Tdicdr+Tdicur–1.5	Tdicpr–Tdicdr+ Tdicur	Tdicpr–Tdicdr+Tdicur+1.5	ns
IP31	Write low pulse width	Twl	Tdicdw-Tdicuw-1.5	Tdicdw ⁶ –Tdicuw ⁷	Tdicdw-Tdicuw+1.5	ns
IP32	Write high pulse width	Twh	Tdicpw-Tdicdw+ Tdicuw-1.5	Tdicpw-Tdicdw+ Tdicuw	Tdicpw-Tdicdw+ Tdicuw+1.5	ns
IP33	Controls setup time for read	Tdcsr	Tdicur-1.5	Tdicur	_	ns
IP34	Controls hold time for read	Tdchr	Tdicpr–Tdicdr–1.5	Tdicpr–Tdicdr	_	ns
IP35	Controls setup time for write	Tdcsw	Tdicuw-1.5	Tdicuw	_	ns

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Table 50. Asynchronous Parallel Interface Timing Parameters—Access Level (continued)

ID	Parameter	Symbol	Min.	Typ. ¹	Max.	Units
IP36	Controls hold time for write	Tdchw	Tdicpw-Tdicdw-1.5	Tdicpw-Tdicdw	_	ns
IP37	Slave device data delay ⁸	Tracc	0	_	Tdrp ⁹ –Tlbd ¹⁰ –Tdicur–1.5	ns
IP38	Slave device data hold time ⁸	Troh	Tdrp-Tlbd-Tdicdr+1.5	_	Tdicpr–Tdicdr–1.5	ns
IP39	Write data setup time	Tds	Tdicdw-1.5	Tdicdw	_	ns
IP40	Write data hold time	Tdh	Tdicpw-Tdicdw-1.5	Tdicpw-Tdicdw	_	ns
IP41	Read period ²	Tdicpr	Tdicpr-1.5	Tdicpr	Tdicpr+1.5	ns
IP42	Write period ³	Tdicpw	Tdicpw-1.5	Tdicpw	Tdicpw+1.5	ns
IP43	Read down time ⁴	Tdicdr	Tdicdr-1.5	Tdicdr	Tdicdr+1.5	ns
IP44	Read up time ⁵	Tdicur	Tdicur-1.5	Tdicur	Tdicur+1.5	ns
IP45	Write down time ⁶	Tdicdw	Tdicdw-1.5	Tdicdw	Tdicdw+1.5	ns
IP46	Write up time ⁷	Tdicuw	Tdicuw-1.5	Tdicuw	Tdicuw+1.5	ns
IP47	Read time point ⁹	Tdrp	Tdrp-1.5	Tdrp	Tdrp+1.5	ns

¹The exact conditions have not been finalized, but will likely match the current customer requirement for their specific display. These conditions may be device specific.

Display interface clock period value for read:

$$\Gamma dicpr = T_{\mbox{HSP_CLK}} \cdot ceil \left[\frac{\mbox{DISP\#_IF_CLK_PER_RD}}{\mbox{HSP_CLK_PERIOD}} \right]$$

$$\begin{array}{l} 3 \quad \text{Display interface clock period value for write:} \\ \Gamma \text{dicpw} = \text{T}_{HSP_CLK} \cdot \text{ceil} \bigg[\frac{\text{DISP\#_IF_CLK_PER_WR}}{\text{HSP_CLK_PERIOD}} \bigg] \end{array}$$

Display interface clock down time for read:

$$\label{eq:dicdr} \text{Idicdr} = \frac{1}{2} T_{\mbox{HSP_CLK}} \cdot \mbox{ceil} \Big[\frac{2 \cdot \mbox{DISP\#_IF_CLK_DOWN_RD}}{\mbox{HSP_CLK_PERIOD}} \Big]$$

Display interface clock up time for read:

$$\Gamma \text{dicur} = \frac{1}{2} \text{T}_{\text{HSP_CLK}} \cdot \text{ceil} \left[\frac{2 \cdot \text{DISP\#_IF_CLK_UP_RD}}{\text{HSP_CLK_PERIOD}} \right]$$

Display interface clock down time for write:

$$Tdicdw = \frac{1}{2}T_{HSP_CLK} \cdot ceil \begin{bmatrix} \frac{2 \cdot DISP\#_IF_CLK_DOWN_WR}{HSP_CLK_PERIOD} \end{bmatrix}$$

Display interface clock up time for write:

$$\label{eq:dicuw} {\tt Idicuw} = \frac{1}{2} {\tt T}_{\mbox{HSP_CLK}} \cdot {\tt ceil} \Big[\frac{2 \cdot {\tt DISP\#_IF_CLK_UP_WR}^-}{\mbox{HSP_CLK_PERIOD}} \Big]$$

- This parameter is a requirement to the display connected to the IPU
- Data read point

$$\Gamma drp = T_{HSP_CLK} \cdot ceil \left[\frac{DISP\#_READ_EN}{HSP_CLK_PERIOD} \right]$$

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¹⁰ Loopback delay Tlbd is the cumulative propagation delay of read controls and read data. It includes an IPU output delay, a device-level output delay, board delays, a device-level input delay, an IPU input delay. This value is device specific.

The DISP#_IF_CLK_PER_WR, DISP#_IF_CLK_PER_RD, HSP_CLK_PERIOD, DISP#_IF_CLK_DOWN_WR, DISP#_IF_CLK_UP_WR, DISP#_IF_CLK_DOWN_RD, DISP#_IF_CLK_UP_RD and DISP#_READ_EN parameters are programmed via the DI_DISP#_TIME_CONF_1, DI_DISP#_TIME_CONF_2 and DI_HSP_CLK_PER Registers.

4.3.15.5.3 Serial Interfaces, Functional Description

The IPU supports the following types of asynchronous serial interfaces:

- 3-wire (with bidirectional data line)
- 4-wire (with separate data input and output lines)
- 5-wire type 1 (with sampling RS by the serial clock)
- 5-wire type 2 (with sampling RS by the chip select signal)

Figure 61 depicts timing of the 3-wire serial interface. The timing images correspond to active-low DISPB_D#_CS signal and the straight polarity of the DISPB_SD_D_CLK signal.

For this interface, a bidirectional data line is used outside the device. The IPU still uses separate input and output data lines (IPP_IND_DISPB_SD_D and IPP_DO_DISPB_SD_D). The I/O mux should provide joining the internal data lines to the bidirectional external line according to the IPP_OBE_DISPB_SD_D signal provided by the IPU.

Each data transfer can be preceded by an optional preamble with programmable length and contents. The preamble is followed by read/write (RW) and address (RS) bits. The order of the these bits is programmable. The RW bit can be disabled. The following data can consist of one word or of a whole burst. The interface parameters are controlled by the DI_SER_DISP1_CONF and DI_SER_DISP2_CONF Registers.

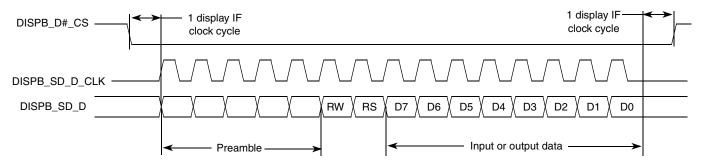
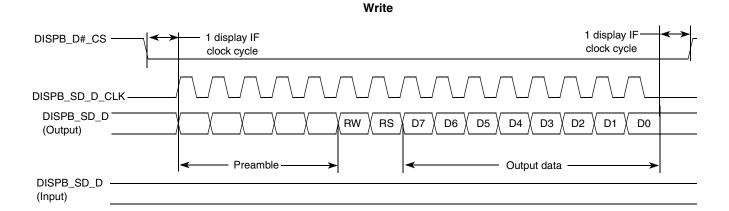


Figure 61. 3-Wire Serial Interface Timing Diagram

Figure 62 depicts timing of the 4-wire serial interface. For this interface, there are separate input and output data lines both inside and outside the device.

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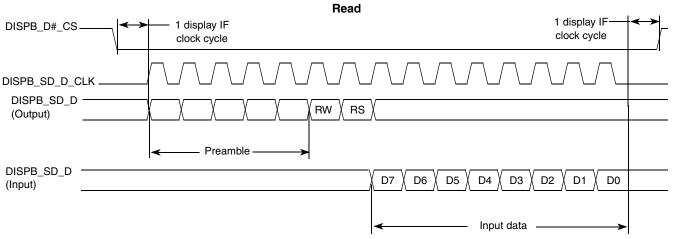


Figure 62. 4-Wire Serial Interface Timing Diagram

Figure 63 depicts timing of the 5-wire serial interface (Type 1). For this interface, a separate RS line is added. When a burst is transmitted within single active chip select interval, the RS can be changed at boundaries of words.

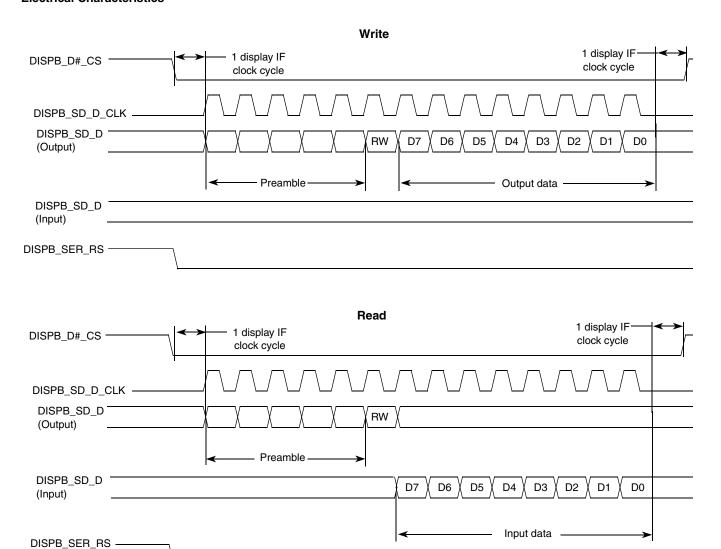


Figure 63. 5-Wire Serial Interface (Type 1) Timing Diagram

Figure 64 depicts timing of the 5-wire serial interface (Type 2). For this interface, a separate RS line is added. When a burst is transmitted within single active chip select interval, the RS can be changed at boundaries of words.

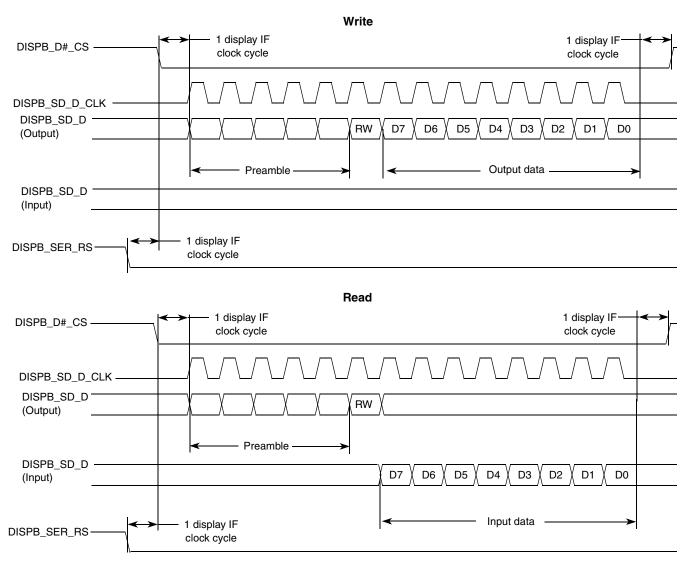


Figure 64. 5-Wire Serial Interface (Type 2) Timing Diagram

4.3.15.5.4 Serial Interfaces, Electrical Characteristics

Figure 65 depicts timing of the serial interface. Table 51 lists the timing parameters at display access level.

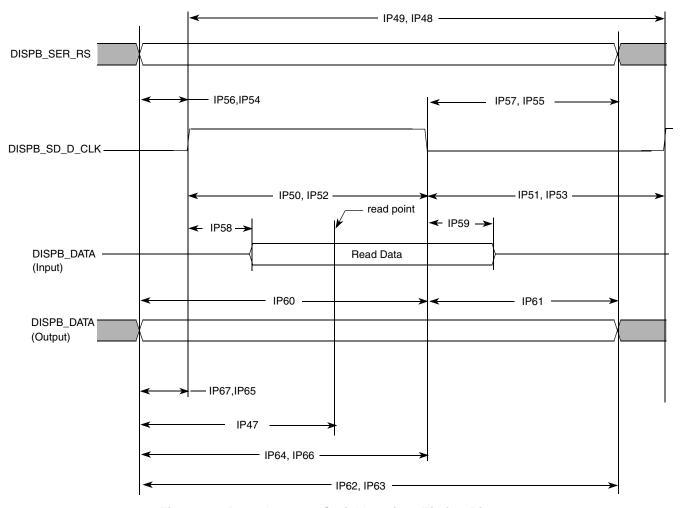


Figure 65. Asynchronous Serial Interface Timing Diagram

Table 51. Asynchronous Serial Interface Timing Parameters—Access Level

ID	Parameter	Symbol	Min.	Typ. ¹	Max.	Units
IP48	Read system cycle time	Tcycr	Tdicpr–1.5	Tdicpr ²	Tdicpr+1.5	ns
IP49	Write system cycle time	Tcycw	Tdicpw-1.5	Tdicpw ³	Tdicpw+1.5	ns
IP50	Read clock low pulse width	Trl	Tdicdr-Tdicur-1.5	Tdicdr ⁴ –Tdicur ⁵	Tdicdr–Tdicur+1.5	ns
IP51	Read clock high pulse width	Trh	Tdicpr–Tdicdr+Tdicur–1.5	Tdicpr–Tdicdr+ Tdicur	Tdicpr–Tdicdr+Tdicur+1.5	ns
IP52	Write clock low pulse width	Twl	Tdicdw-Tdicuw-1.5	Tdicdw ⁶ –Tdicuw ⁷	Tdicdw-Tdicuw+1.5	ns
IP53	Write clock high pulse width	Twh	Tdicpw-Tdicdw+ Tdicuw-1.5	Tdicpw-Tdicdw+ Tdicuw	Tdicpw-Tdicdw+ Tdicuw+1.5	ns
IP54	Controls setup time for read	Tdcsr	Tdicur-1.5	Tdicur	_	ns
IP55	Controls hold time for read	Tdchr	Tdicpr–Tdicdr–1.5	Tdicpr-Tdicdr	_	ns

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Table 51. Asynchronous Serial Interface Timing Parameters—Access Level (continued)

ID	Parameter	Symbol	Min.	Typ. ¹	Max.	Units
IP56	Controls setup time for write	Tdcsw	Tdicuw-1.5	Tdicuw	_	ns
IP57	Controls hold time for write	Tdchw	Tdicpw-Tdicdw-1.5	Tdicpw-Tdicdw	_	ns
IP58	Slave device data delay ⁸	Tracc	0	_	Tdrp ⁹ –Tlbd ¹⁰ –Tdicur–1.5	ns
IP59	Slave device data hold time ⁸	Troh	Tdrp-Tlbd-Tdicdr+1.5	_	Tdicpr–Tdicdr–1.5	ns
IP60	Write data setup time	Tds	Tdicdw-1.5	Tdicdw	_	ns
IP61	Write data hold time	Tdh	Tdicpw-Tdicdw-1.5	Tdicpw-Tdicdw	_	ns
IP62	Read period ²	Tdicpr	Tdicpr–1.5	Tdicpr	Tdicpr+1.5	ns
IP63	Write period ³	Tdicpw	Tdicpw-1.5	Tdicpw	Tdicpw+1.5	ns
IP64	Read down time ⁴	Tdicdr	Tdicdr-1.5	Tdicdr	Tdicdr+1.5	ns
IP65	Read up time ⁵	Tdicur	Tdicur-1.5	Tdicur	Tdicur+1.5	ns
IP66	Write down time ⁶	Tdicdw	Tdicdw-1.5	Tdicdw	Tdicdw+1.5	ns
IP67	Write up time ⁷	Tdicuw	Tdicuw-1.5	Tdicuw	Tdicuw+1.5	ns
IP68	Read time point ⁹	Tdrp	Tdrp-1.5	Tdrp	Tdrp+1.5	ns

¹ The exact conditions have not been finalized, but will likely match the current customer requirement for their specific display. These conditions may be device specific.

² Display interface clock period value for read:

$$Tdicpr = T_{\color{BSP_CLK}} \cdot ceil \left[\frac{DISP\#_IF_CLK_PER_RD}{HSP_CLK_PERIOD} \right]$$

Display interface clock period value for write:

$$Tdicpw = T_{\color{BSP_CLK}} \cdot ceil \left[\frac{DISP\#_IF_CLK_PER_WR}{HSP_CLK_PERIOD} \right]$$

⁴ Display interface clock down time for read:

$$Tdicdr = \frac{1}{2}T_{\mbox{HSP_CLK}} \cdot ceil \left[\frac{2 \cdot \mbox{DISP\#_IF_CLK_DOWN_RD}}{\mbox{HSP_CLK_PERIOD}} \right]$$

⁵ Display interface clock up time for read:

$$Tdicur = \frac{1}{2}T_{\mbox{HSP_CLK}} \cdot ceil \left[\frac{2 \cdot \mbox{DISP\#_IF_CLK_UP_RD}}{\mbox{HSP_CLK_PERIOD}} \right]$$

⁶ Display interface clock down time for write:

⁷ Display interface clock up time for write:

$$\label{eq:dicuw} \mbox{'dicuw} = \frac{1}{2} \mbox{T}_{\mbox{HSP_CLK}} \cdot \mbox{ceil} \bigg[\frac{2 \cdot \mbox{DISP\#_IF_CLK_UP_WR}}{\mbox{HSP_CLK_PERIOD}} \bigg]$$

- ⁸ This parameter is a requirement to the display connected to the IPU.
- ⁹ Data read point:

$$'drp = T_{HSP_CLK} \cdot ceil \left[\frac{DISP\#_READ_EN}{HSP_CLK_PERIOD} \right]$$

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¹⁰ Loopback delay Tlbd is the cumulative propagation delay of read controls and read data. It includes an IPU output delay, a device-level output delay, board delays, a device-level input delay, an IPU input delay. This value is device specific.

The DISP#_IF_CLK_PER_WR, DISP#_IF_CLK_PER_RD, HSP_CLK_PERIOD, DISP#_IF_CLK_DOWN_WR, DISP#_IF_CLK_UP_WR, DISP#_IF_CLK_DOWN_RD, DISP#_IF_CLK_UP_RD and DISP#_READ_EN parameters are programmed via the DI_DISP#_TIME_CONF_1, DI_DISP#_TIME_CONF_2 and DI_HSP_CLK_PER Registers.

4.3.16 Memory Stick Host Controller (MSHC)

Figure 66, Figure 67, and Figure 68 depict the MSHC timings, and Table 52 and Table 53 list the timing parameters.

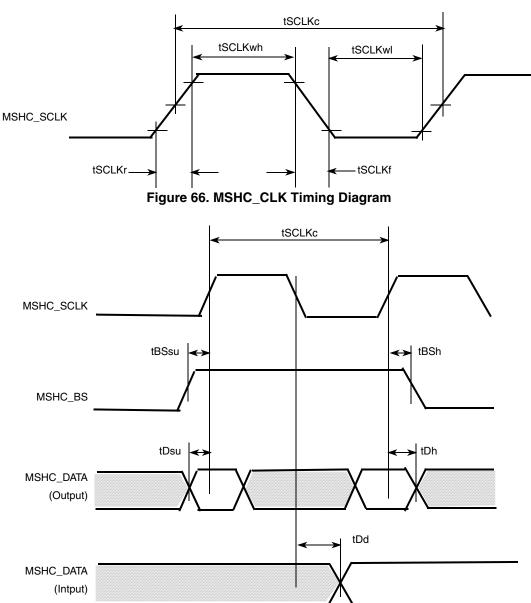


Figure 67. Transfer Operation Timing Diagram (Serial)

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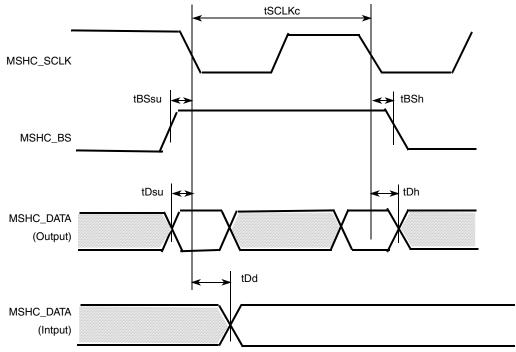


Figure 68. Transfer Operation Timing Diagram (Parallel)

NOTE

The Memory Stick Host Controller is designed to meet the timing requirements per Sony's *Memory Stick Pro Format Specifications* document. Tables in this section details the specifications requirements for parallel and serial modes, and not the MCIMX31 timing.

Table 52. Serial Interface Timing Parameters¹

Signal	Parameter	Symbol	Stand	ards	Unit
Signal	Parameter	Symbol	Min.	Max.	Offic
	Cycle	tSCLKc	50	_	ns
	H pulse length	tSCLKwh	15	_	ns
MSHC_SCLK	L pulse length	tSCLKwl	15	_	ns
	Rise time	tSCLKr	_	10	ns
	Fall time	tSCLKf	_	10	ns
MSHC_BS	Setup time	tBSsu	5	_	ns
WISHC_B3	Hold time	tBSh	5	_	ns
	Setup time	tDsu	5	_	ns
MSHC_DATA	Hold time	tDh	5	_	ns
	Output delay time	tDd	_	15	ns

Timing is guaranteed for NVCC from 2.7 through 3.1 V and up to a maximum overdrive NVCC of 3.3 V. See NVCC restrictions described in Table 8, "Operating Ranges," on page 13.

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Table 53. Parallel Interface Timing Parameters¹

Signal	Parameter	Symbol	Stand	ards	Unit
Signal	rarameter	Symbol	Min	Max	Offic
	Cycle	tSCLKc	25	_	ns
	H pulse length	tSCLKwh	5	_	ns
MSHC_SCLK	L pulse length	tSCLKwl	5	_	ns
	Rise time	tSCLKr	_	10	ns
	Fall time	tSCLKf	_	10	ns
MSHC_BS	Setup time	tBSsu	8	_	ns
WIGHTO_BG	Hold time	tBSh	1	_	ns
	Setup time	tDsu	8	1	ns
MSHC_DATA	Hold time	tDh	1	_	ns
	Output delay time	tDd	_	15	ns

¹ Timing is guaranteed for NVCC from 2.7 through 3.1 V and up to a maximum overdrive NVCC of 3.3 V. See NVCC restrictions described in Table 8, "Operating Ranges," on page 13.

4.3.17 Personal Computer Memory Card International Association (PCMCIA)

Figure 69 and Figure 70 depict the timings pertaining to the PCMCIA module, each of which is an example of one clock of strobe set-up time and one clock of strobe hold time. Table 54 lists the timing parameters.

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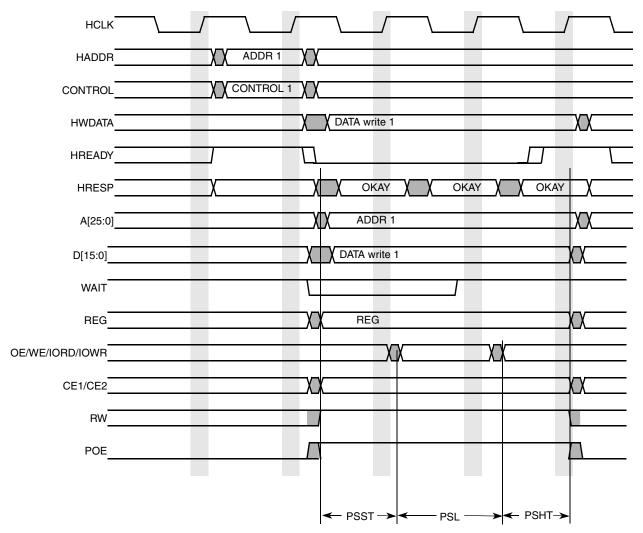


Figure 69. Write Accesses Timing Diagram—PSHT=1, PSST=1

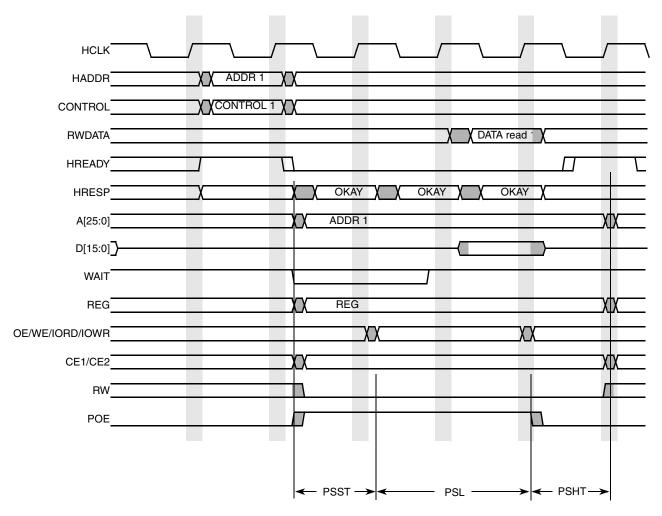


Figure 70. Read Accesses Timing Diagram—PSHT=1, PSST=1

Table 54. PCMCIA Write and Read Timing Parameters

Symbol	Parameter	Min	Max	Unit
PSHT	PCMCIA strobe hold time	0	63	clock
PSST	PCMCIA strobe set up time	1	63	clock
PSL	PCMCIA strobe length	1	128	clock

4.3.18 PWM Electrical Specifications

This section describes the electrical information of the PWM. The PWM can be programmed to select one of three clock signals as its source frequency. The selected clock signal is passed through a prescaler before being input to the counter. The output is available at the pulse-width modulator output (PWMO) external pin.

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4.3.18.1 **PWM Timing**

Figure 71 depicts the timing of the PWM, and Table 55 lists the PWM timing characteristics.

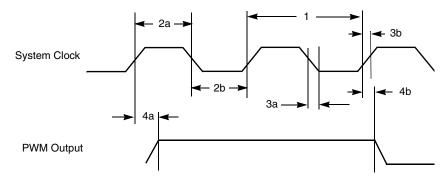


Figure 71. PWM Timing

Table 55. PWM Output Timing Parameters

ID	Parameter	Min	Max	Unit
1	System CLK frequency ¹	0	ipg_clk	MHz
2a	Clock high time	12.29	_	ns
2b	Clock low time	9.91	_	ns
3a	Clock fall time	_	0.5	ns
3b	Clock rise time	_	0.5	ns
4a	Output delay time	_	9.37	ns
4b	Output setup time	8.71	_	ns

¹ CL of PWMO = 30 pF

4.3.19 SDHC Electrical Specifications

This section describes the electrical information of the SDHC.

4.3.19.1 SDHC Timing

Figure 72 depicts the timings of the SDHC, and Table 56 lists the timing parameters.

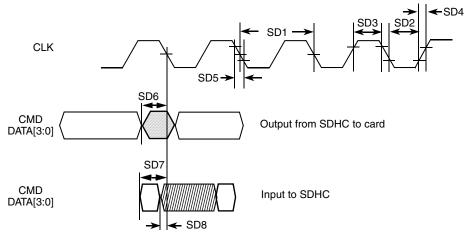


Figure 72. SDHC Timing Diagram

Table 56. SDHC Interface Timing Parameters

ID	Parameter	Symbol	Min	Max	Unit
Card Inp	ut Clock		1		•
SD1	Clock Frequency (Low Speed)	f _{PP} ¹	0	400	kHz
	Clock Frequency (SD/SDIO Full Speed)	f _{PP} ²	0	25	MHz
	Clock Frequency (MMC Full Speed)	f _{PP} ³	0	20	MHz
	Clock Frequency (Identification Mode)	f _{OD} ⁴	100	400	kHz
SD2	Clock Low Time	t _{WL}	10	_	ns
SD3	Clock High Time	t _{WH}	10	_	ns
SD4	Clock Rise Time	t _{TLH}	_	10	ns
SD5	Clock Fall Time	t _{THL}	_	10	ns
SDHC O	utput/Card Inputs CMD, DAT (Reference to CLK)				
SD6	SDHC output delay	t _{ODL}	-6.5	3	ns
SDHC In	put/Card Outputs CMD, DAT (Reference to CLK)				
SD7	SDHC input setup	t _{IS}	_	18.5	ns
SD8	SDHC input hold	t _{IH}		-11.5	ns

¹ In low speed mode, card clock must be lower than 400 kHz, voltage ranges from 2.7 V-3.3 V.

4.3.20 SIM Electrical Specifications

Each SIM card interface consist of a total of 12 pins (for 2 separate ports of 6 pins each. Mostly one port with 5 pins is used).

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² In normal data transfer mode for SD/SDIO card, clock frequency can be any value between 0 MHz-25 MHz.

³ In normal data transfer mode for MMC card, clock frequency can be any value between 0 MHz–20 MHz.

⁴ In card identification mode, card clock must be 100 kHz-400 kHz, voltage ranges from 2.7 V-3.3 V.

The interface is meant to be used with synchronous SIM cards. This means that the SIM module provides a clock for the SIM card to use. The frequency of this clock is normally 372 times the data rate on the TX/RX pins, however SIM module can work with CLK equal to 16 times the data rate on TX/RX pins.

There is no timing relationship between the clock and the data. The clock that the SIM module provides to the aim card will be used by the SIM card to recover the clock from the data much like a standard UART. All six (or 5 in case bi-directional TXRX is used) of the pins for each half of the SIM module are asynchronous to each other.

There are no required timing relationships between the signals in normal mode, but there are some in two specific cases: reset and power down sequences.

4.3.20.1 General Timing Requirements

Figure 73 shows the timing of the SIM module, and Figure 57 lists the timing parameters.

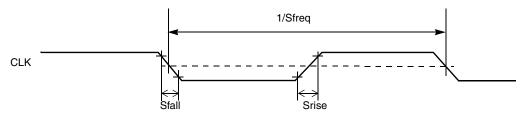


Figure 73. SIM Clock Timing Diagram

Table 57. SIM Timing Specification—High Drive Strength

Num	Description	Symbol	Min	Max	Unit
1	SIM Clock Frequency (CLK) ¹	S _{freq}	0.01	5 (Some new cards may reach 10)	MHz
2	SIM CLK Rise Time ²	S _{rise}	_	20	ns
3	SIM CLK Fall Time ³	S _{fall}	_	20	ns
4	SIM Input Transition Time (RX, SIMPD)	S _{trans}	_	25	ns

^{1 50%} duty cycle clock

4.3.20.2 Reset Sequence

4.3.20.2.1 Cards with Internal Reset

The sequence of reset for this kind of SIM Cards is as follows (see Figure 74):

- After powerup, the clock signal is enabled on SGCLK (time T0)
- After 200 clock cycles, RX must be high.
- The card must send a response on RX acknowledging the reset between 400 and 40000 clock cycles after T0.

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 $^{^2}$ With C = 50pF

 $^{^3}$ With C = 50pF

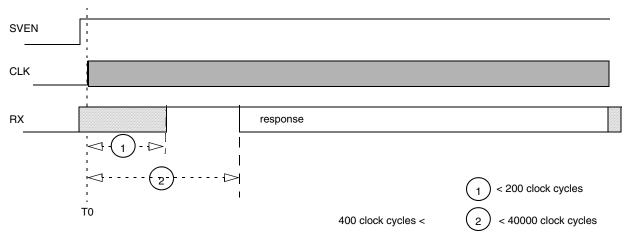


Figure 74. Internal-Reset Card Reset Sequence

4.3.20.2.2 Cards with Active Low Reset

The sequence of reset for this kind of card is as follows (see Figure 75):

- 1. After powerup, the clock signal is enabled on CLK (time T0)
- 2. After 200 clock cycles, RX must be high.
- 3. RST must remain Low for at least 40000 clock cycles after T0 (no response is to be received on RX during those 40000 clock cycles)
- 4. RST is set High (time T1)
- 5. RST must remain High for at least 40000 clock cycles after T1 and a response must be received on RX between 400 and 40000 clock cycles after T1.

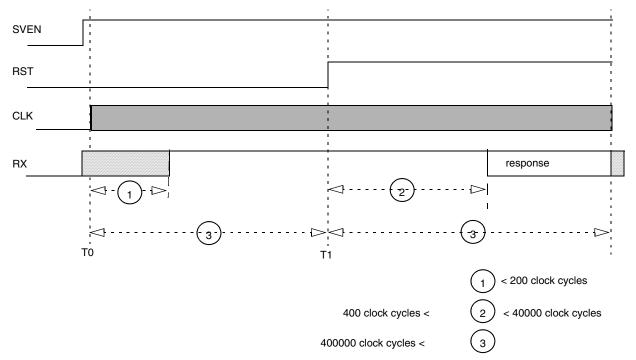


Figure 75. Active-Low-Reset Card Reset Sequence

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4.3.20.3 Power Down Sequence

Power down sequence for SIM interface is as follows:

- 1. SIMPD port detects the removal of the SIM Card
- 2. RST goes Low
- 3. CLK goes Low
- 4. TX goes Low
- 5. VEN goes Low

Each of this steps is done in one CKIL period (usually 32 kHz). Power down can be started because of a SIM Card removal detection or launched by the processor. Figure 76 and Table 58 show the usual timing requirements for this sequence, with Fckil = CKIL frequency value.

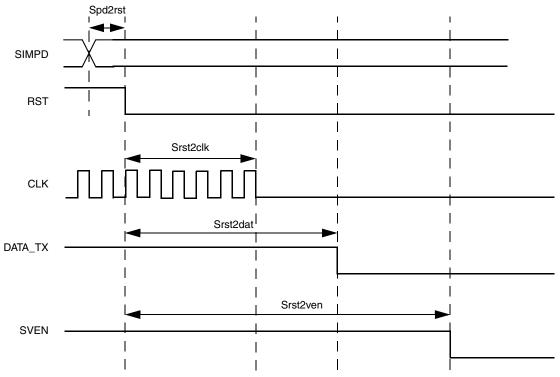


Figure 76. SmartCard Interface Power Down AC Timing

Table 58. Timing Requirements for Power Down Sequence

Num	Description	Symbol	Min	Max	Unit
1	SIM reset to SIM clock stop	S _{rst2clk}	0.9*1/FCKIL	0.8	μs
2	SIM reset to SIM TX data low	S _{rst2dat}	1.8*1/FCKIL	1.2	μs
3	SIM reset to SIM Voltage Enable Low	S _{rst2ven}	2.7*1/FCKIL	1.8	μs
4	SIM Presence Detect to SIM reset Low	S _{pd2rst}	0.9*1/FCKIL	25	ns

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4.3.21 SJC Electrical Specifications

This section details the electrical characteristics for the SJC module. Figure 77 depicts the SJC test clock input timing. Figure 78 depicts the SJC boundary scan timing, Figure 79 depicts the SJC test access port, Figure 80 depicts the SJC TRST timing, and Table 59 lists the SJC timing parameters.

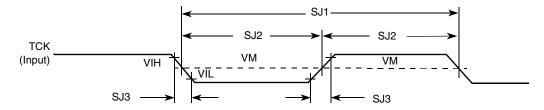


Figure 77. Test Clock Input Timing Diagram

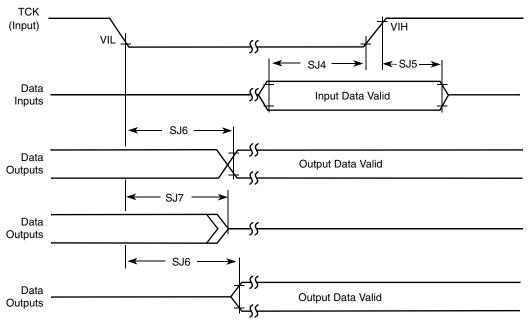


Figure 78. Boundary Scan (JTAG) Timing Diagram

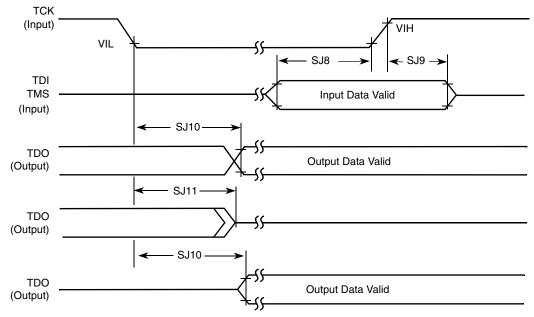


Figure 79. Test Access Port Timing Diagram

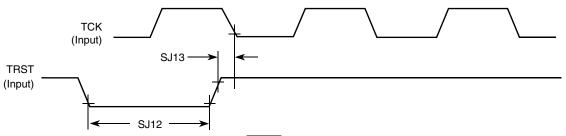


Figure 80. TRST Timing Diagram

Table 59. SJC Timing Parameters

ID	Parameter	All Freq	Unit	
	raiametei	Min	Max	Oilit
SJ1	TCK cycle time	100 ¹	_	ns
SJ2	TCK clock pulse width measured at V _M ²	40	_	ns
SJ3	TCK rise and fall times	_	3	ns
SJ4	Boundary scan input data set-up time	10	_	ns
SJ5	Boundary scan input data hold time	50	_	ns
SJ6	TCK low to output data valid	_	50	ns
SJ7	TCK low to output high impedance	_	50	ns
SJ8	TMS, TDI data set-up time	10	_	ns
SJ9	TMS, TDI data hold time	50	_	ns
SJ10	TCK low to TDO data valid	_	44	ns

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Table 59. SJC Timing Parameters (continued)

ID	ID Parameter	All Freq	Unit	
	raiametei	Min	Max	Oilit
SJ11	TCK low to TDO high impedance	_	44	ns
SJ12	TRST assert time	100	_	ns
SJ13	TRST set-up time to TCK low	40	_	ns

On cases where SDMA TAP is put in the chain, the max TCK frequency is limited by max ratio of 1:8 of SDMA core frequency to TCK limitation. This implies max frequency of 8.25 MHz (or 121.2 ns) for 66 MHz IPG clock.

4.3.22 SSI Electrical Specifications

This section describes the electrical information of SSI. Note the following pertaining to timing information:

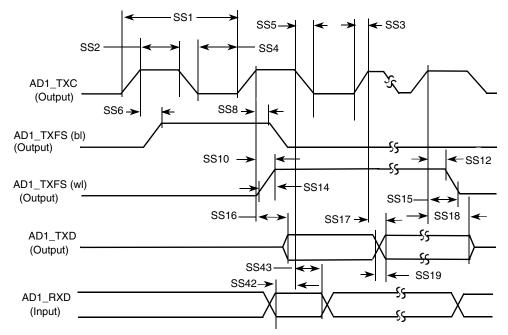
- All the timings for the SSI are given for a non-inverted serial clock polarity (TSCKP/RSCKP = 0) and a non-inverted frame sync (TFSI/RFSI = 0). If the polarity of the clock and/or the frame sync have been inverted, all the timing remains valid by inverting the clock signal STCK/SRCK and/or the frame sync STFS/SRFS shown in the tables and in the figures.
- All timings are on AUDMUX signals when SSI is being used for data transfer.
- "Tx" and "Rx" refer to the Transmit and Receive sections of the SSI.
- For internal Frame Sync operation using external clock, the FS timing will be same as that of Tx Data (for example, during AC97 mode of operation).

4.3.22.1 SSI Transmitter Timing with Internal Clock

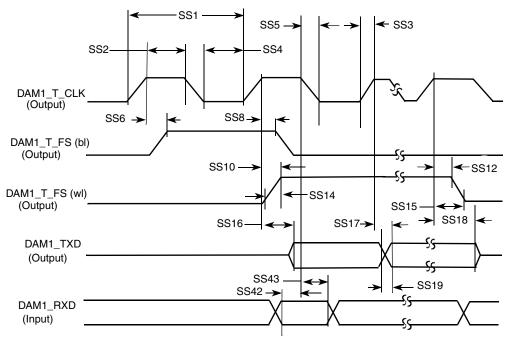
Figure 81 depicts the SSI transmitter timing with internal clock, and Table 60 lists the timing parameters.

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² V_M mid point voltage



Note: SRXD Input in Synchronous mode only



Note: SRXD Input in Synchronous mode only

Figure 81. SSI Transmitter with Internal Clock Timing Diagram

Table 60. SSI Transmitter with Internal Clock Timing Parameters

ID	Parameter	Min	Max	Unit	
Internal Cl	Internal Clock Operation				
SS1	(Tx/Rx) CK clock period	81.4	_	ns	
SS2	(Tx/Rx) CK clock high period	36.0	_	ns	
SS3	(Tx/Rx) CK clock rise time	_	6	ns	
SS4	(Tx/Rx) CK clock low period	36.0	_	ns	
SS5	(Tx/Rx) CK clock fall time	_	6	ns	
SS6	(Tx) CK high to FS (bl) high	_	15.0	ns	
SS8	(Tx) CK high to FS (bl) low	_	15.0	ns	
SS10	(Tx) CK high to FS (wl) high	_	15.0	ns	
SS12	(Tx) CK high to FS (wl) low	_	15.0	ns	
SS14	(Tx/Rx) Internal FS rise time	_	6	ns	
SS15	(Tx/Rx) Internal FS fall time	_	6	ns	
SS16	(Tx) CK high to STXD valid from high impedance	_	15.0	ns	
SS17	(Tx) CK high to STXD high/low	_	15.0	ns	
SS18	(Tx) CK high to STXD high impedance	_	15.0	ns	
SS19	STXD rise/fall time	_	6	ns	
Synchrono	Synchronous Internal Clock Operation				
SS42	SRXD setup before (Tx) CK falling	10.0	_	ns	
SS43	SRXD hold after (Tx) CK falling	0	_	ns	
SS52	Loading	_	25	pF	

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4.3.22.2 SSI Receiver Timing with Internal Clock

Figure 82 depicts the SSI receiver timing with internal clock, and Table 61 lists the timing parameters.

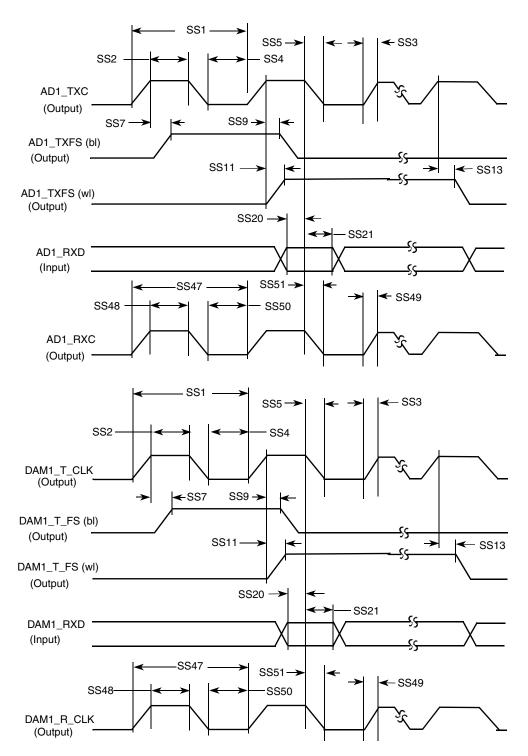


Figure 82. SSI Receiver with Internal Clock Timing Diagram

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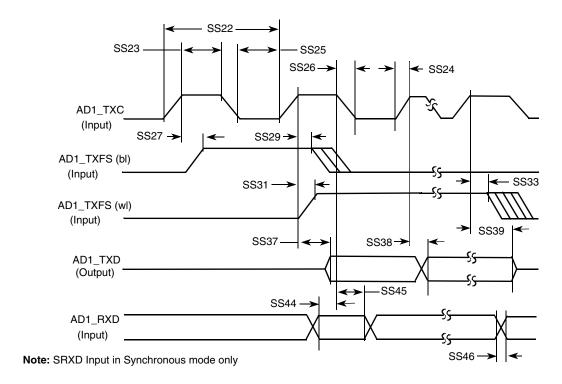
Table 61. SSI Receiver with Internal Clock Timing Parameters

ID	Parameter	Min	Max	Unit		
Internal	Internal Clock Operation					
SS1	(Tx/Rx) CK clock period	81.4	_	ns		
SS2	(Tx/Rx) CK clock high period	36.0	_	ns		
SS3	(Tx/Rx) CK clock rise time	_	6	ns		
SS4	(Tx/Rx) CK clock low period	36.0	_	ns		
SS5	(Tx/Rx) CK clock fall time	_	6	ns		
SS7	(Rx) CK high to FS (bl) high	_	15.0	ns		
SS9	(Rx) CK high to FS (bl) low	_	15.0	ns		
SS11	(Rx) CK high to FS (wl) high	_	15.0	ns		
SS13	(Rx) CK high to FS (wl) low	_	15.0	ns		
SS20	SRXD setup time before (Rx) CK low	10.0	_	ns		
SS21	SRXD hold time after (Rx) CK low	0	_	ns		
Oversan	npling Clock Operation					
SS47	Oversampling clock period	15.04	_	ns		
SS48	Oversampling clock high period	6	_	ns		
SS49	Oversampling clock rise time	_	3	ns		
SS50	Oversampling clock low period	6	_	ns		
SS51	Oversampling clock fall time	_	3	ns		

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4.3.22.3 SSI Transmitter Timing with External Clock

Figure 83 depicts the SSI transmitter timing with external clock, and Table 62 lists the timing parameters.



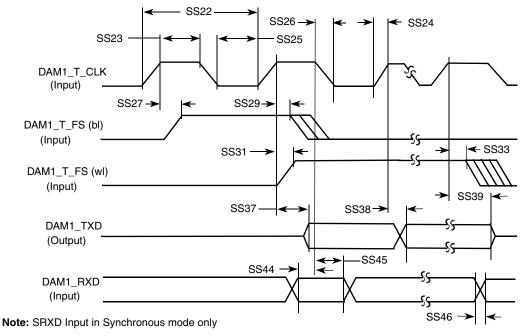


Figure 83. SSI Transmitter with External Clock Timing Diagram

Table 62. SSI Transmitter with External Clock Timing Parameters

ID	Parameter	Min	Max	Unit
External	Clock Operation	1		
SS22	(Tx/Rx) CK clock period	81.4	_	ns
SS23	(Tx/Rx) CK clock high period	36.0	_	ns
SS24	(Tx/Rx) CK clock rise time	_	6.0	ns
SS25	(Tx/Rx) CK clock low period	36.0	_	ns
SS26	(Tx/Rx) CK clock fall time	_	6.0	ns
SS27	(Tx) CK high to FS (bl) high	-10.0	15.0	ns
SS29	(Tx) CK high to FS (bl) low	10.0	_	ns
SS31	(Tx) CK high to FS (wl) high	-10.0	15.0	ns
SS33	(Tx) CK high to FS (wl) low	10.0	_	ns
SS37	(Tx) CK high to STXD valid from high impedance	_	15.0	ns
SS38	(Tx) CK high to STXD high/low	_	15.0	ns
SS39	(Tx) CK high to STXD high impedance	_	15.0	ns
Synchro	Synchronous External Clock Operation			
SS44	SRXD setup before (Tx) CK falling	10.0	_	ns
SS45	SRXD hold after (Tx) CK falling	2.0		ns
SS46	SRXD rise/fall time	_	6.0	ns

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4.3.22.4 SSI Receiver Timing with External Clock

Figure 84 depicts the SSI receiver timing with external clock, and Table 63 lists the timing parameters.

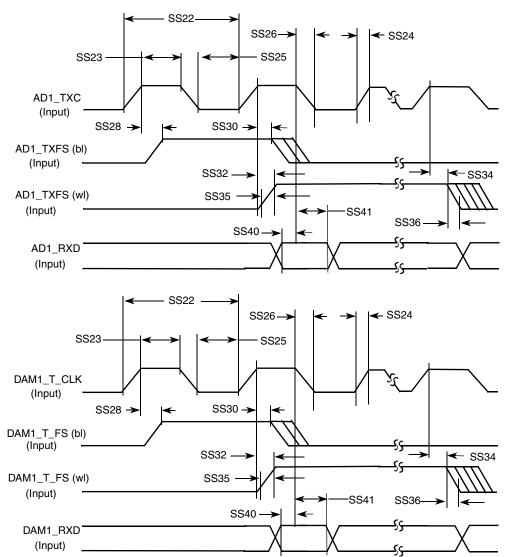


Figure 84. SSI Receiver with External Clock Timing Diagram

Table 63. SSI Receiver with External Clock Timing Parameters

ID	Parameter	Min	Max	Unit	
External	External Clock Operation				
SS22	(Tx/Rx) CK clock period	81.4	_	ns	
SS23	(Tx/Rx) CK clock high period	36.0	_	ns	
SS24	(Tx/Rx) CK clock rise time	_	6.0	ns	
SS25	(Tx/Rx) CK clock low period	36.0	_	ns	
SS26	(Tx/Rx) CK clock fall time	_	6.0	ns	

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ID	Parameter	Min	Max	Unit
SS28	(Rx) CK high to FS (bl) high	-10.0	15.0	ns
SS30	(Rx) CK high to FS (bl) low	10.0	_	ns
SS32	(Rx) CK high to FS (wl) high	-10.0	15.0	ns
SS34	(Rx) CK high to FS (wl) low	10.0	_	ns
SS35	(Tx/Rx) External FS rise time	_	6.0	ns
SS36	(Tx/Rx) External FS fall time	_	6.0	ns
SS40	SRXD setup time before (Rx) CK low	10.0	_	ns
SS41	SRXD hold time after (Rx) CK low	2.0	_	ns

4.3.23 USB Electrical Specifications

This section describes the electrical information of the USBOTG port. The OTG port supports both serial and parallel interfaces.

The high speed (HS) interface is supported via the ULPI (Ultra Low Pin Count Interface). Figure 85 depicts the USB ULPI timing diagram, and Table 64 lists the timing parameters.

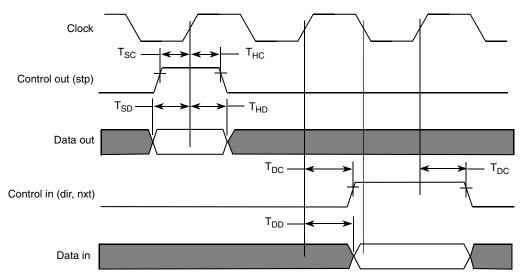


Figure 85. USB ULPI Interface Timing Diagram

Table 64. USB ULPI Interface Timing Specification¹

Parameter	Symbol	Min	Max	Units
Setup time (control in, 8-bit data in)	Tsc, Tsd	6	_	ns
Hold time (control in, 8-bit data in)	THC, THD	0	_	ns
Output delay (control out, 8-bit data out)	TDC, TDD	_	9	ns

¹ Timing parameters are given as viewed by transceiver side.

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5 Package Information and Pinout

This section includes the contact assignment information and mechanical package drawing for the MCIMX31.

5.1 MAPBGA Production Package—457 14 x 14 mm, 0.5 mm Pitch

This section contains the outline drawing, signal assignment map (see Section 8, "Revision History," Table 70 for the $0.5 \text{ mm } 14 \times 14 \text{ MAPBGA}$ signal assignments), and MAPBGA ground/power ID by ball grid location for the $457 14 \times 14 \text{ mm}$, 0.5 mm pitch package.

5.1.1 Production Package Outline Drawing–14 x 14 mm 0.5 mm

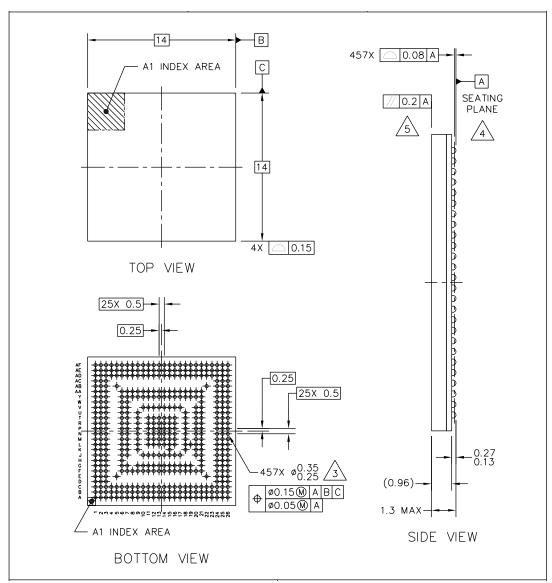


Figure 86. Production Package: Case 1581-0.5 mm Pitch

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5.1.2 MAPBGA Signal Assignment–14 × 14 mm 0.5 mm

See Section 8, "Revision History," Figure 70 for the 0.5 mm 14 × 14 MAPBGA signal assignments.

5.1.3 Connection Tables-14 x 14 mm 0.5 mm

Table 65 shows the device connection list for power and ground, alpha-sorted. Table 66 shows the device connection list for signals.

5.1.3.1 Ground and Power ID Locations-14 x 14 mm 0.5 mm

Table 65. 14 x 14 MAPBGA Ground/Power ID by Ball Grid Location

GND/PWR ID	Ball Location
FGND	AB24
FUSE_VDD	AC24
FVCC	AA24
GND	A1, A2, A25, A26, B1, B2, B25, B26, C1, C2, C24, C25, C26, D1, D25, E22, E24, F21, L12, M11, M12, M13, M14, M15, M16, N12, N13, N14, N15, N16, P12, P13, P14, P15, P16, R12, R13, R14, R15, R16, T12, T13, V17, AC2, AC26, AD1, AD2, AD24, AD25, AD26, AE1, AE2, AE24, AE25, AE26, AF1, AF2, AF25, AF26
IOQVDD	Y6
MGND	T15
MVCC	V15
NVCC1	G19, G21, K18
NVCC2	Y17, Y18, Y19, Y20
NVCC3	L9, M9, N11
NVCC4	L18, L19
NVCC5	E5, F6, G7
NVCC6	J15, J16, K15
NVCC7	N18, P18, R18, T18
NVCC8	J12, J13
NVCC9	J17
NVCC10	P9, P11, R11, T11
NVCC21	Y14, Y15, Y16
NVCC22	W7, Y7, Y8, Y9, Y10, Y11, Y12, Y13, AA6
QVCC	J14, L13, L14, L15, L16, M18, U18, V10, V11, V12, V13
QVCC1	J10, J11, K9, L11
QVCC4	N9, R9, T9, U9
SGND	T14
SVCC	V14
UVCC	V16
UGND	T16

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5.1.3.2 BGA Signal ID by Ball Grid Location-14 x 14 0.5 mm

Table 66 shows the device connection list for signals only, alpha-sorted by signal identification.

Table 66. 14 x 14 BGA Signal ID by Ball Grid Location

Signal ID	Ball Location		
A0	AD6		
A1	AF5		
A10	AF18		
A11	AC3		
A12	AD3		
A13	AD4		
A14	AF17		
A15	AF16		
A16	AF15		
A17	AF14		
A18	AF13		
A19	AF12		
A2	AB5		
A20	AF11		
A21	AF10		
A22	AF9		
A23	AF8		
A24	AF7		
A25	AF6		
A3	AE4		
A4	AA3		
A5	AF4		
A6	AB3		
A7	AE3		
A8	AD5		
A9	AF3		
ATA_CS0	J6		
ATA_CS1	F2		
ATA_DIOR	E2		
ATA_DIOW	H6		
ATA_DMACK	F1		
ATA_RESET	H3		
BATT_LINE	F7		
BCLK	AB26		
BOOT_MODE0	F20		
BOOT_MODE1	C21		
BOOT_MODE2	D24		
BOOT_MODE3	C22		
BOOT_MODE4	D26		
CAPTURE	A22		
CAS	AD20		
CE_CONTROL	A14		
CKIH	F24		

Signal ID	Ball Location
CKIL	H21
CLKO	C23
CLKSS	G26
COMPARE	G18
CONTRAST	R24
CS0	AE23
CS1	AF23
CS2	AE21
CS3	AD22
CS4	AF24
CS5	AF22
CSI_D10	M24
CSI_D11	L26
CSI_D12	M21
CSI_D13	M25
CSI_D14	M20
CSI_D15	M26
CSI_D4	L21
CSI_D5	K25
CSI_D6	L24
CSI_D7	K26
CSI_D8	L20
CSI_D9	L25
CSI_HSYNC	K20
CSI_MCLK	K24
CSI_PIXCLK	J26
CSI_VSYNC	J25
CSPI1_MISO	P7
CSPI1_MOSI	P2
CSPI1_SCLK	N2
CSPI1_SPI_RDY	N3
CSPI1_SS0	P3
CSPI1_SS1	P1
CSPI1_SS2	P6
CSPI2_MISO	A4
CSPI2_MOSI	E3
CSPI2_SCLK	C7
CSPI2_SPI_RDY	B6
CSPI2_SS0	B5
CSPI2_SS1	C6
CSPI2_SS2	A5
CSPI3_MISO	G3
CSPI3 MOSI	D2

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Table 66. 14 x 14 BGA Signal ID by Ball Grid Location (continued)

Signal ID	Ball Location
CSPI3_SCLK	E1
CSPI3_SPI_RDY	G6
CTS1	B11
CTS2	G13
D0	AB2
D1	Y3
D10	Y1
D11	U7
D12	W2
D13	V3
D14	W1
D15	U6
D2	AB1
D3	W6
D3_CLS	R20
D3_REV	T26
D3_SPL	U25
D4	AA2
D5	V7
D6	AA1
D7	W3
D8	Y2
D9	V6
DCD_DCE1	B12
DCD_DTE1	B13
DE	C18
DQM0	AE19
DQM1	AD19
DQM2	AA20
DQM3	AE18
DRDY0	N26
DSR_DCE1	A11
DSR_DTE1	A12
DTR_DCE1	C11
DTR_DCE2	F12
DTR_DTE1	C12
DVFS0	E25
DVFS1	G24
EB0	W21
EB1	Y24
ECB	AD23
FPSHIFT	N21
GPIO1_0	F18
GPIO1_1	B23
GPIO1_2	C20
LD7	W25

Signal ID	Ball Location
GPIO1_3	F25
GPIO1_4	F19
GPIO1_5 (PWR RDY)	B24
GPIO1_6	A23
GPIO3_0	K21
GPIO3_1	H26
HSYNC	N25
I2C_CLK	J24
I2C_DAT	H25
IOIS16	J3
KEY_COL0	C15
KEY_COL1	B17
KEY_COL2	G15
KEY_COL3	A17
KEY_COL4	C16
KEY_COL5	B18
KEY_COL6	F15
KEY_COL7	A18
KEY_ROW0	F13
KEY_ROW1	B15
KEY_ROW2	C14
KEY_ROW3	A15
KEY_ROW4	G14
KEY_ROW5	B16
KEY_ROW6	F14
KEY_ROW7	A16
L2PG	See VPG1
LBA	AE22
LCS0	P26
LCS1	P21
LD0	T24
LD1	U26
LD10	V24
LD11	Y25
LD12	Y26
LD13	V21
LD14	AA25
LD15	W24
LD16	AA26
LD17	V20
LD2	T21
LD3	V25
LD4	T20
LD5	V26
LD6	U24
SCK6	T2

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Table 66. 14 x 14 BGA Signal ID by Ball Grid Location (continued)

Signal ID	Ball Location
LD8	U21
LD9	W26
M_GRANT	Y21
M_REQUEST	AC25
MA10	AC1
MCUPG	See VPG0
NFALE	V1
NFCE	T6
NFCLE	U3
NFRB	U1
NFRE	V2
NFWE	T7
NFWP	U2
OE	AB25
PAR_RS	R21
PC_BVD1	H2
PC_BVD2	K6
PC_CD1	L7
PC_CD2	K1
PC_POE	J7
PC_PWRON	K3
PC_READY	J2
PC_RST	H1
PC_RW	G2
PC_VS1	J1
PC_VS2	K7
PC_WAIT	L6
POR	H24
POWER_FAIL	E26
PWMO	G1
RAS	AF19
READ	P20
RESET_IN	J21
RI_DCE1	F11
RI_DTE1	G12
RTCK	C17
RTS1	G11
RTS2	B14
RW	AB22
RXD1	A10
RXD2	A13
SCK3	R2
SCK4	C4
SCK5	D3
SDCKE0	AD21
SDCKE1	AF21

Signal ID	Ball Location
SCLK0	B22
SD_D_CLK	P24
SD_D_I	N20
SD_D_IO	P25
SD0	AD18
SD1	AE17
SD1_CLK	M7
SD1_CMD	L2
SD1_DATA0	M6
SD1_DATA1	L1
SD1_DATA2	L3
SD1_DATA3	K2
SD10	AE15
SD11	AE14
SD12	AD14
SD13	AA14
SD14	AE13
SD15	AD13
SD16	AA13
SD17	AD12
SD18	AA12
SD19	AE11
SD2	AA19
SD20	AE10
SD21	AA11
SD22	AE9
SD23	AA10
SD24	AE8
SD25	AD10
SD26	AE7
SD27	AA9
SD28	AA8
SD29	AD9
SD3	AA18
SD30	AE6
SD31	AA7
SD4	AD17
SD5	AA17
SD6	AE16
SD7	AA16
SD8	AD15
SD9	AA15
SDBA0	AD7
SDBA1	AE5
TRSTB	B20
TTM_PAD	U20

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Table 66. 14 x 14 BGA Signal ID by Ball Grid Location (continued)

	-
Signal ID	Ball Location
SDCLK	AA21
SDCLK	AE20
SDQS0	AD16
SDQS1	AE12
SDQS2	AD11
SDQS3	AD8
SDWE	AF20
SER_RS	T25
SFS3	R6
SFS4	F3
SFS5	A3
SFS6	T3
SIMPD0	G17
SJC_MOD	A20
SRST0	C19
SRX0	B21
SRXD3	R3
SRXD4	C3
SRXD5	B4
SRXD6	R7
STX0	F17
STXD3	R1
STXD4	B3
STXD5	C5
STXD6	T1
SVEN0	A21
TCK	B19
TDI	F16
TDO	A19
TMS	G16

Signal ID	Ball Location
TXD1	F10
TXD2	C13
USB_BYP	A9
USB_OC	C10
USB_PWR	B10
USBH2_CLK	N1
USBH2_DATA0	M1
USBH2_DATA1	M3
USBH2_DIR	N7
USBH2_NXT	N6
USBH2_STP	M2
USBOTG_CLK	G10
USBOTG_DATA0	F9
USBOTG_DATA1	B8
USBOTG_DATA2	G9
USBOTG_DATA3	A7
USBOTG_DATA4	C8
USBOTG_DATA5	B7
USBOTG_DATA6	F8
USBOTG_DATA7	A6
USBOTG_DIR	B9
USBOTG_NXT	A8
USBOTG_STP	C9
VPG0	G25
VPG1	J20
VSTBY	F26
VSYNC0	N24
VSYNC3	R26
WATCHDOG_RST	A24
WRITE	R25

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5.2 MAPBGA Production Package—473 19 x 19 mm, 0.8 mm Pitch

This section contains the outline drawing, signal assignment map (see Section 8, "Revision History," Table 71 for the 19 x 19 mm, 0.8 mm pitch signal assignments), and MAPBGA ground/power ID by ball grid location for the 473 19 x 19 mm, 0.8 mm pitch package.

5.2.1 Production Package Outline Drawing-19 x 19 mm 0.8 mm

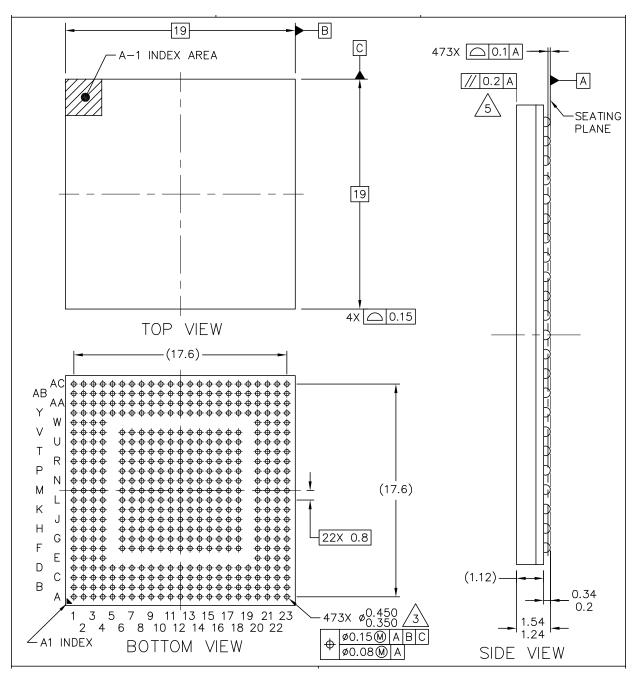


Figure 87. Production Package: Case 1931—0.8 mm Pitch

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5.2.2 MAPBGA Signal Assignment–19 × 19 mm 0.8 mm

See Table 71 for the 19×19 mm, 0.8 mm pitch signal assignments/ball map.

5.2.3 Connection Tables-19 x 19 mm 0.8 mm

Table 67 shows the device connection list for power and ground, alpha-sorted followed by Table 68, which shows the no-connects. Table 69 shows the device connection list for signals.

5.2.3.1 Ground and Power ID Locations—19 x 19 mm 0.8 mm

Table 67. 19 x 19 BGA Ground/Power ID by Ball Grid Location

GND/PWR ID	Ball Location
FGND	U16
FUSE_VDD	T15
FVCC	T16
GND	A1, A2, A3, A21, A22, A23, B1, B2, B22, B23, C1, C2, C22, C23, D22, D23, J12, J13, K10, K11, K12, K13, K14, L10, L11, L12, L13, L14, M9, M10, M11, M12, M13, M14, N10, N11, N12, N13, N14, P10, P11, P12, P13, P14, R12, Y1, Y23, AA1, AA2, AA22, AA23, AB1, AB2, AB21, AB22, AB23, AC1, AC2, AC21, AC22, AC23
IOQVDD	T8
MGND	U14
MVCC	U15
NVCC1	G15, G16, H16, J17
NVCC2	N16, P16, R15, R16, T14
NVCC3	K7, K8, L7, L8
NVCC4	H14, J15, K15
NVCC5	G9, G10, H8, H9
NVCC6	G11, G12, G13, H12
NVCC7	H15, J16, K16, L16, M16
NVCC8	H10, H11, J11
NVCC9	G14
NVCC10	P8, R7, R8, R9, T9
NVCC21	T11, T12, T13, U11
NVCC22	T10, U7, U8, U9, U10, V6, V7, V8, V9, V10
QVCC	H13, J14, L15, M15, N9, N15, P9, P15, R10, R11, R13, R14
QVCC1	J8, J9, J10, K9
QVCC4	L9, M7, M8, N8
SGND	U13
SVCC	U12
UVCC	P18
UGND	P17

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Table 68. 19 x 19 BGA No Connects¹

Signal	Ball Location
NC	N7
NC	P7
NC	U21

These contacts are not used and must be floated by the user.

5.2.3.2 BGA Signal ID by Ball Grid Location—19 x 19 0.8 mm

Table 69. 19 x 19 BGA Signal ID by Ball Grid Location

Signal ID	Ball Location
A0	Y6
A1	AC5
A10	V15
A11	AB3
A12	AA3
A13	Y3
A14	Y15
A15	Y14
A16	V14
A17	Y13
A18	V13
A19	Y12
A2	AB5
A20	V12
A21	Y11
A22	V11
A23	Y10
A24	Y9
A25	Y8
A3	AA5
A4	Y5
A5	AC4
A6	AB4
A7	AA4
A8	Y4
A9	AC3
ATA_CS0	E1
ATA_CS1	G4
ATA_DIOR	E3
ATA_DIOW	H6
ATA_DMACK	E2
ATA_RESET	F3
BATT_LINE	F6
BCLK	W20
BOOT_MODE0	F17
BOOT_MODE1	C21

Signal ID	Ball Location
CKIL	E21
CLKO	C20
CLKSS	H17
COMPARE	A20
CONTRAST	N21
CS0	U17
CS1	Y22
CS2	Y18
CS3	Y19
CS4	Y20
CS5	AA21
CSI_D10	K21
CSI_D11	K22
CSI_D12	K23
CSI_D13	L20
CSI_D14	L18
CSI_D15	L21
CSI_D4	J20
CSI_D5	J21
CSI_D6	L17
CSI_D7	J22
CSI_D8	J23
CSI_D9	K20
CSI_HSYNC	H22
CSI_MCLK	H20
CSI_PIXCLK	H23
CSI_VSYNC	H21
CSPI1_MISO	N2
CSPI1_MOSI	N1
CSPI1_SCLK	M4
CSPI1_SPI_RDY	M1
CSPI1_SS0	M2
CSPI1_SS1	N6
CSPI1_SS2	M3
CSPI2_MISO	B4
CSPI2_MOSI	D5

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Table 69. 19 x 19 BGA Signal ID by Ball Grid Location (continued)

Signal ID	Ball Location
BOOT_MODE2	D20
BOOT_MODE3	F18
BOOT_MODE4	E20
CAPTURE	D18
CAS	AA20
CE_CONTROL	D12
CKIH	F23
CSPI3_SCLK	H7
CSPI3_SPI_RDY	F4
CTS1	A9
CTS2	C12
D0	U6
D1	W4
D10	V1
D11	U4
D12	U3
D13	R6
D14	U2
D15	U1
D2	W3
D3	V4
D3_CLS	P20
D3_REV	P21
 D3_SPL	N17
 D4	T7
D5	W2
D6	V3
D7	W1
D8	T6
D9	V2
DCD_DCE1	C10
DCD_DTE1	D11
 DE	D16
DQM0	AB19
DQM1	Y16
DQM2	AA18
DQM3	AB18
DRDY0	M17
DSR_DCE1	B10
DSR_DTE1	A11
DTR_DCE1	F10
DTR_DCE2	C11
DTR_DTE1	A10
DVFS0	E22
DVFS1	E23
EB0	W22

Signal ID	Ball Location
CSPI2_SCLK	B5
CSPI2_SPI_RDY	D6
CSPI2_SS0	C5
CSPI2_SS1	A4
CSPI2_SS2	F7
CSPI3_MISO	D2
CSPI3_MOSI	E4
GPIO1_3	G20
GPIO1_4	D21
GPIO1_5 (PWR RDY)	D19
GPIO1_6	G18
GPIO3_0	G23
GPIO3_1	K17
HSYNC	L23
I2C_CLK	J18
I2C_DAT	K18
IOIS16	J7
KEY_COL0	A15
KEY_COL1	B15
KEY_COL2	D14
KEY_COL3	C15
KEY_COL4	F13
KEY_COL5	A16
KEY_COL6	B16
KEY_COL7	A17
KEY_ROW0	A13
KEY_ROW1	B13
KEY_ROW2	C13
KEY_ROW3	A14
KEY_ROW4	F12
KEY_ROW5	D13
KEY_ROW6	B14
KEY_ROW7	C14
L2PG	See VPG1
LBA	V17
LCS0	M22
LCS1	N23
LD0	R23
LD1	R22
LD10	U22
LD11	R18
LD12	U20
LD13	V23
LD14	V22
LD15	V21
LD16	V20

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Table 69. 19 x 19 BGA Signal ID by Ball Grid Location (continued)

Signal ID	Ball Location
EB1	W21
ECB	Y21
FPSHIFT	M23
GPIO1_0	C19
GPIO1_1	G17
GPIO1_2	B20
LD7	T20
LD8	R17
LD9	U23
M_GRANT	U18
M_REQUEST	T17
MA10	Y2
MCUPG	See VPG0
NFALE	T2
NFCE	R4
NFCLE	T1
NFRB	R3
NFRE	T4
NFWE	T3
NFWP	P6
OE	T18
PAR_RS	P22
PC_BVD1	G2
PC_BVD2	H4
PC_CD1	J3
PC_CD2	H1
PC_POE	J6
PC_PWRON	K6
PC_READY	H2
PC_RST	F1
PC_RW	G3
PC_VS1	H3
PC_VS2	G1
PC_WAIT	J4
POR	F21
POWER_FAIL	F20
PWMO	F2
RAS	AA19
READ	N18
RESET_IN	F22
RI_DCE1	D10
RI_DTE1	B11
RTCK	D15
RTS1	B9
RTS2	B12
RW	V18
ITAA	V 10

Signal ID	Ball Location
LD17	W23
LD2	R21
LD3	R20
LD4	T23
LD5	T22
LD6	T21
SCK6	R2
SCLK0	B19
SD_D_CLK	M21
SD_D_I	M20
SD_D_IO	M18
SD0	AC18
SD1	AA17
SD1_CLK	K2
SD1_CMD	K3
SD1_DATA0	K4
SD1_DATA1	J1
SD1_DATA2	J2
SD1_DATA3	L6
SD10	AB14
SD11	AC14
SD12	AA13
SD13	AB13
SD14	AC13
SD15	AA12
SD16	AC12
SD17	AA11
SD18	AB11
SD19	AC11
SD2	AB17
SD20	AA10
SD21	AB10
SD22	AC10
SD23	AC9
SD24	AA9
SD25	AC8
SD26	AB8
SD27	AC7
SD28	AA8
SD29	AB7
SD3	AC17
SD30	AA7
SD31	AC6
SD4	AA16
SD5	AC16

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Table 69. 19 x 19 BGA Signal ID by Ball Grid Location (continued)

Signal ID	Ball Location
RXD1	C9
RXD2	A12
SCK3	P1
SCK4	G6
SCK5	D4
SDCKE0	Y17
SDCKE1	V16
SDCLK	AC20
SDCLK	AC19
SDQS0	AB16
SDQS1	AB12
SDQS2	AB9
SDQS3	AB6
SDWE	AB20
SER_RS	P23
SFS3	P2
SFS4	D3
SFS5	G7
SFS6	P4
SIMPD0	B18
SJC_MOD	C17
SRST0	C18
SRX0	A19
SRXD3	N3
SRXD4	C3
SRXD5	C4
SRXD6	R1
STX0	F16
STXD3	N4
STXD4	B3
STXD5	D1
STXD6	P3
SVEN0	D17
TCK	F14
TDI	A18
TDO	B17
TMS	C16

SD7 SD8 SD9 SDBA0 SDBA1 TRSTB TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	AB15 AC15 AA14 AA6 Y7 F15 D9 F11 C8 B8 A8 L1 M6 K1 L2
SD9 SDBA0 SDBA1 TRSTB TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	AA14 AA6 Y7 F15 D9 F11 C8 B8 A8 L1 M6 K1
SDBA0 SDBA1 TRSTB TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	AA6 Y7 F15 D9 F11 C8 B8 A8 L1 M6 K1
SDBA1 TRSTB TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	Y7 F15 D9 F11 C8 B8 A8 L1 M6 K1
TRSTB TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	F15 D9 F11 C8 B8 A8 L1 M6 K1
TXD1 TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	D9 F11 C8 B8 A8 L1 M6 K1
TXD2 USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA1 USBOTG_DATA1	F11 C8 B8 A8 L1 M6 K1
USB_BYP USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1	C8 B8 A8 L1 M6 K1
USB_OC USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1	B8 A8 L1 M6 K1
USB_PWR USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA1	A8 L1 M6 K1
USBH2_CLK USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA1	L1 M6 K1
USBH2_DATA0 USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA1	M6 K1
USBH2_DATA1 USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	K1
USBH2_DIR USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	
USBH2_NXT USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	L2
USBH2_STP USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	
USBOTG_CLK USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	L4
USBOTG_DATA0 USBOTG_DATA1 USBOTG_DATA2	L3
USBOTG_DATA1 USBOTG_DATA2	D8
USBOTG_DATA2	G8
	C7
	A6
USBOTG_DATA3	F8
USBOTG_DATA4	D7
USBOTG_DATA5	B6
USBOTG_DATA6	A5
USBOTG_DATA7	C6
USBOTG_DIR	A7
USBOTG_NXT	B7
USBOTG_STP	F9
VPG0	G21
VPG1	G22
VSTBY	H18
VSYNC0	L22
VSYNC3	NICO
WATCHDOG_RST	N20
WRITE	N20 B21

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Ball Maps

5.3

Table 70. Ball Map—14 x 14 0.5 mm Pitch

	⋖	m	ပ	۵	ш	ш	σ	I	~	×	_	Σ	z	۵	œ	-	_	>	*	>	¥	AB	AC	PΡ	ĄĘ	ΑF	
90	GND	GND	GND	BOOT_ MODE4	POWER FAIL	VSTBY	CLKSS	GP103_ 1	CSI_PIX CLK	CSI_D7	CSI_D1	CSI_D1 5	DRDYO	rcs0	VSYNC 3	D3_REV	LD1	LD5	607	LD12	LD16	BCLK	GND	GND	GND	GND	56
40	GND	GND	GND	GND	DVFS0	GPIO1_ 3	VPG0	I2C_DA T	CSI_VS YNC	CSI_D5	CSI_D9	CSI_D1 3	HSYNC	SD_D_I	WRITE	SER_R S	D3_SPL	LD3	701	LD11	LD14	OE	M_REQ UEST	GND	GND	GND	25
2	ᄑᅋ	GPI01_ 5	GND	BOOT_ (MODE2	GND	OKIH	DVFS1	POR	C_CL	CSI_MC	CSI_D6	CSI_D1 (VSYNC 0	SD_D_ (CLK	CONTR A	PD0	PD9	LD10	LD15	EB1	FVCC	FGND	FUSE_V	GND		CS4	24
ç	PIO1_	GPI01_ 0	CLKO	W 2	O	0		III.	□ 포	0_	0	0.6	<i>></i> 0	0,0	04			7	7	ш	ь	Ь	<u> </u>	ECB		CS1 C	23
c	1 E	SCLK0 G	BOOT_ C MODE3		GND																	N		eso E		cse c	22
5	9	SRX0 SC	BOOT_ BC MODE1 M		ত	9	NVCC1	=	RESET_ IN	GPIO3_ 0	ı_D4	1_D1	SHIF	S1	PAR_RS	2	8	13	0	GRA	SDCLK	RW		SDCKE CS		SDCKE CS	21
C	Σ	TRSTB SR	GPIO1 BC			BOOT_ GND MODE 0	Ź	CKI	VPG1 RE	CSI_H GF SYNC 0	CSI_D8 CSI_D4	CSI_D1 CSI_D1 4	SD_D_I FPSHIF	READ LCS1	D3_CL PA S	4 LD2	TTM_P LD8 AD	LD17 LD13	EBO	NVCC2 NVCC2 M_GRA	DQM2 SD				SDCLK CS2	SDWE SD	20
Q			SRST0 GF			10	NVCC1		Α	88	NVCC4 CS	O 4	S	뿐	လ ဩ	LD4	F4	T		/CC2 NV	SD2 DC			DQM1 CAS	0	RAS SI	19
9	O _I	KEY_C TCK OL5				GPIO1 GF _0 _4	COMP N\ ARE			NVCC1	NVCC4 N	avcc	NVCC7	NVCC7	NVCC7	NVCC7	avcc			NVCC2 N	SD3 SI			SDO DC	3	A10 R/	18
<u>†</u>	O _i	KEY_C KE	RTCK DE			STX0 GI	SIMPD CC 0 AF		6000	Ź	Ź	ð	Ź	Ź	Ź	Ź	ð	GND		VCC2 N	SD5 SI			SD4 SI		A14 A	17
۳	α.	KEY_R KI OW5 O	KEY_C R OL4			IDI	IMS SMT		NVCC6 NVCC9		avcc	GND	GND	GND	GND	UGND		UVCC G		NVCC2 NVCC2	SD7 SI			SDOS0 SI		A15 A	16
- 4	α.	KEY_R K OW1 O	KEY_C K OL0 0			KEY_C TI	KEY_C TI		NVCC6 N	NVCC6	avcc a	GND G	GND	GND	GND	MGND U		MVCC U		NVCC2 N	S 60S			SD8 S)	A16 A	15
:	요ㅋ	RTS2 K	KEY_R K OW2 C			KEY_R K OW6	KEY_R K OW4		QVCC	Z	avcc c	GND G	GND	GND	GND	SGND		SVCC		NVCC2 N	SD13 S			SD12 S	1	A17 A	14
<u></u>		DCD_D F TE1	TXD2			KEY_R OW0	CTS2 K		NCC8		avcc o	GND	GND	GND	GND	GND		avcc s		NVCC2 N	SD16 S			SD15 S	4	A18 A	13
5 \$	٥	DCD_D [CE1 1	DTR_D 1 TE1			DTR_D M	RI_DT (NVCC8 NVCC8		GND	GND		GND	GND	GND		avcc (NVCC2 N	SD18			SD17	S	A19 /	12
	\Box	CTS1	DTR_D CE1			RI_DC [RTS1 F		QVCC1 N		avcc1 (GND	NVCC3 GND	NVCC1 (0	NVCC1 0	NVCC1 0		avcc (NCC2	SD21			spasz s	6	A20 /	11
Ş		USB_P (USB_O			TXD1	JSBOT 3_CLK		QVCC1		-	-						QVCC (VVCC2	SD23			SD25	0	A21 ,	10
d	1	USBOT G_DIR	USBOT G_STP			USBOT G_DAT A0	3OT			QVCC1	NVCC3	NVCC3	QVCC4	NVCC1 0	QVCC4	QVCC4	QVCC4			NVCC2	SD27			SD29	OI.	A22	6
a	USBOT G_NXT	USBOT G_DAT A1	USBOT G_DAT A4			USBOT G_DAT A6														NVCC2	SD28			SDOS3	4	A23	8
٢	USBOT G_DAT A3	USBOT G_DAT A5	CSPI2_ SCLK			NVCC5 BATT_L INE	NVCC5		PC_PO E	PC_VS 2	$\frac{PC_CD}{1}$	SD1_C LK	USBH2 _DIR	CSP11_ MISO	SRXD6	NFWE	D11	D5	NVCC2 2	NVCC2	SD31			SDBA0	(O	A24	7
u	USBOT G_DAT A7	CSPI2_ SPI_R DY	CSPI2_ SS1			NVCC5	CSPI3_ SPI_R DY	ATA_DI OW	ATA_C S0	PC_BV D2	PC_WA	SD1_D ATA0	USBH2 _NXT	CSP11_ SS2		NFCE	D15	60	D3	IOQVD D	NVCC2 2			AO	SD30	A25	9
и	CSPI2_ SS2	CSPI2_ SS0	STXD5		NVCC5																	A2		A8	BA1	A1	2
_	2 0	SRXD 5	SCK4										.0											A13	A3	A5	4
ď	SFS5	STXD4	SRXD4	SCK5	CSP12 MOSI		CSPI3_MISO	ATA_R ESET	IOIS16	PC_PW RON	SD1_D ATA2	USBH2 _DATA1	CSP11_ SPI_RD Y	CSP11_ SS0	SRXD3	SFS6	NFCLE	D13	D7	D1	A4	A6	A11	A12	A7	A9	ဇ
c	GND	GND	GND	CSPI3_ MOSI	ATA_DI	ATA_C S1	PC_RW	PC_BV D1	PC_RE ADY	SD1_D ATA3	SD1_C MD	USBH2 _STP	CSP11_ SCLK	CSP11_ MOSI	SCK3	SCK6	NFWP	NFRE	D12	D8	D4	D0	GND	GND	GND	GND	2
+	GND	GND	GND	GND	CSPI3_ SCLK	ATA_D MACK	PWMO	PC_RS T	PC_VS	$\frac{PC_CD}{2}$	SD1_D ATA1	USBH2 _DATA0	USBH2 _CLK	CSP11_ SS1	STXD3	STXD6	NFRB	NFALE	D14	D10	90	D2	MA10	GND		GND	-
	⋖	ш	O	Ω	ш	ш	Q	I	7	¥	_	Σ	z	۵	Œ	⊢	⊃	>	≥	>	¥	AB	AC	AD	ΑE	ΑF	

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Table 71. Ball Map—19 x 19 0.8 mm Pitch

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23	GND	GND	GND	GND	DVFS1	CKIT	GPIO3_0	CSI_PIX CLK	CSI_D8	CSI_ D12	HSYNC	FPSHIFT	LCS1	SER_ RS	rD0	LD4	FD9	LD13	LD17	GND	GND	GND	GND	23
23	GND	GND	GND	GND	DVFS0	RESET_ N	VPG1	SSI_HSY CSI_PIX NC CLK	CSI_D7	CSI_ D11	VSYNCO	rcs0	WRITE	PAR_ RS	LD1	FD5	LD10	LD14	EB0	CS1	GND	GND	GND	22
7	GND	WATCH DOG_RST	BOOT_ MODE1	GPIO1_4	CKIL	POR	VPG0	CSI_ VSYNC	CSI_D5	CSI_ D10	CSI_D15	SD_D_ CLK	CONTRAST	D3_ REV	LD2	9Q7	NC	LD15	EB1	ECB	CS5	GND	GND	21
20	COMPARE	GPIO1_2	ССКО	BOOT_ MODE2	BOOT_ MODE4	POWER_ FAIL	GPIO1_3	CSI_ MCLK	CSI_D4	CSI_D9	CSI_D13	SD_D_I	VSYNC3	D3_CLS	rD3	LD7	LD12	LD16	BCLK	CS4	CAS	SDWE	SDCLK	20
19	SRX0	SCLKO	GPI01 _0	GP101 _5																cs3	RAS	DQMO	SDCLK	19
8	ΙQL	SIMPDO	SRSTO	CAPTURE		BOOT_ MODE3	GPIO1_6	VSTBY	ISC_ CLK	I2C_ DAT	CSI_ D14	SD_D_ IO	READ	UVCC	LD11	OE	M_ GRANT	RW		CS2	DQM2	ромз	SD0	18
17	KEY_ COL7	ТБО	SJC_ MOD	SVENO		BOOT_ MODE0	GPI01_1	CLKSS	NVCC1	GPIO3_1	CSI_D6	DRDY0	D3_ SPL	UGND	PD8	M_ REQUEST	CS0	LBA		SDCKEO	SD1	SD2	SD3	17
16	KEY_ COL5	KEY_ COL6	TMS	<u>DE</u>		STX0	NVCC1	NVCC1	NVCC7	NVCC7	NVCC7	NVCC7	NVCC2	NVCC2	NVCC2	FVCC	FGND	SDCKE1		DQM1	SD4	SDOS0	SD5	16
15	KEY_ COL0	KEY_ COL1	KEY_ COL3	RTCK		TRSTB	NVCC1	NVCC7	NVCC4	NVCC4	QVCC	avcc	avcc	avcc	NVCC2	FUSE_ VDD	MVCC	A10		A14	SD6	SD7	SD8	15
4	KEY_ ROW3	KEY_ ROW6	KEY_ ROW7	KEY_ COL2		TCK	NVCC9	NVCC4	avcc	GND	GND	GND	GND	GND	avcc	NVCC2	MGND	A16		A15	SD9	SD10	SD11	14
13	KEY_ ROW0	KEY_ ROW1	KEY_ ROW2	KEY_ ROW5		KEY_ COL4	NVCC6	avcc	GND	GND	GND	GND	GND	GND	avcc	NVCC21	SGND	A18		A17	SD12	SD13	SD14	13
12	RXD2	RTS2	CTS2	CE_ CONTROL		KEY_ ROW4	NVCC6	NVCC6	GND	GND	GND	GND	GND	GND	GND	NVCC21	SVCC	A20		A19	SD15	SDQS1	SD16	12
-	DSR_ DTE1	RI_ DTE1	DTR_ DCE2	DCD_ DTE1		TXD2	NVCC6	NVCC8	NVCC8	GND	GND	GND	GND	GND	avcc	NVCC21 N	NVCC21	A22		A21	SD17	SD18	SD19	1
10	DTR_ DTE1	DSR_ DCE1	DCD_ DCE1	RI_ DCE1		DTR_ DCE1	NVCC5 N	NVCC8	avcc1 N	GND	GND	GND	GND	GND	avcc	NVCC22 N	NVCC22 N	NVCC22		A23	SD20	SD21	SD22	10
6	CTS1	RTS1	RXD1	TXD1		USBOT G_STP	NVCC5 P	NVCC5 P	avcc1	QVCC1	QVCC4	GND	avcc	avcc	NVCC1 0	NVCC1 N	NVCC2 N	NVCC2 N		A24	SD24	SDQS2	SD23	6
œ	USB_ PWR	USB_ OC	USB_ BYP	USBOTG_ CLK		USBOTG_ I	USBOTG_ DATA0	NVCC5 I	QVCC1	NVCC3	NVCC3	QVCC4	QVCC4	NVCC10	NVCC10	IOQVDD	NVCC22	NVCC22		A25	SD28	SD26	SD25	The contract of the contract o
7	USBOTG _DIR	USBOTG_ NXT	USBOTG_ DATA1			CSPI2_ U	SFS5 L	CSPI3_ SCLK	IOIS16	NVCC3	NVCC3	QVCC4	NC1	NC1	NVCC10	P4	NVCC22	NVCC22		SDBA1	SD30	SD29	SD27	7
9	USBOTG I	USBOTG_L DATA5	USBOTG_ DATA7	CSPI2_SPIUSBOTG_ _RDY DATA4		BATT_ LINE	SCK4	ATA_ DIOW	PC_POE	PC_ PWRON	SD1_ DATA3	USBH2_ DATA0	CSPI1_ SS1	NFWP	D13	D8	00	NVCC22		A0	SDBA0	SDQS3	SD31	9 0
rc	USBOTG_ I	CSPI2_ L SCLK	CSP12_ SS0	CSPI2_ C																44	A3	A2	P4	5 6
4	CSPI2_ U	CSPI2_ MISO	SRXD5		CSPI3_ MOSI	CSPI3_ SPI_RDY	ATA_ CS1	PC_ BVD2	PC_ WAIT	SD1_ DATA0	USBH2_ NXT	CSPI1_ SCLK	STXD3	SFS6	NFCE	NFRE	D11	D3	10	A8	A7	A6	A5	4
ဗ	GND	STXD4	SRXD4	SFS4		ATA_ RESET S	RW_	PC_ VS1	CD_ 	SD1_ CMD	USBH2_ U STP	CSPI1_ SS2	SRXD3	STXD6	NFRB	NFWE	D12	9Q	D2	A13	A12	A11	A9	3
2	GND	GND	GND	CSPI3_ MISO	ATA_ DMACK	PWMO	PC_ BVD1	PC_ READY	SD1_ DATA2	SD1_ CLK	USBH2_ L DIR	CSPI1_ SS0	CSPI1_ MISO	SFS3	SCK6	NFALE	D14	60	DS	MA10	GND	GND	GND	2
-	GND	GND	GND	STXD5	ATA_ CS0	PC_ RST	PC_VS2	PC_CD2	SD1_ DATA1		USBH2_ L CLK	CSPI1_S (CSPI1_ (SCK3	SRXD6	NFCLE	D15	D10	D7	GND	GND	GND	GND	1
	⋖	ω	ပ	٥	Ш	ш	o o	<u> </u>	7	x		2	z	۵	œ	-	_	>	>	>	A	AB	AC	, ,

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6 Product Differences

The locations that provide the differences between silicon Revision 2.0, 1.2, and previous versions are given in Table 72. The differences between the MCIMX31/MCIMX31L and the MCIMX31C/MCIMX31LC are outlined in Table 73.

Table 72. Silicon Differentiation by Location within the Data Sheet

Item	Location	Silicon 1.2 and Previous	Silicon 2.0
Ordering Information	Section 1.2, "Ordering Information	Table 1	Table 1
Feature Differences	Table 1.2.1, "Feature Differences Between Mask Sets," on page 3	N/A	Table 1.2.1
Operating Ranges	Table 4.1, "Chip-Level Conditions," on page 10	Table 8, "Operating Ranges," on page 13	Table 8, and Table 9, "Specific Operating Ranges for Silicon Revision 2.0," on page 14
Power-up Sequences	Section 4.2.1, "Powering Up	Figure 2, "Power-Up Sequence for Silicon Revisions 1.2 and Previous," on page 20	Figure 3, "Option 1 Power-Up Sequence (Silicon Revision 2.0)," on page 21
Power-down Sequences	Section 4.2.2, "Powering Down	_	_

Table 73. Product Differentiation

Item	Location	MCIMX31/MCIMX31L	MCIMX31C/MCIMX31LC
Device ordering information	Table 1, "Ordering Information," on page 3	See Table 1.	See Table 1.
Thermal simulation values	Table 6, "Thermal Resistance Data—14 × 14 mm Package," on page 11 and Table 7, "Thermal Resistance Data—19 × 19 mm Package," on page 11	See Table 6 and Table 7.	See Table 7.
Core overdrive operating voltages	Table 8, "Operating Ranges," on page 13	Capability to operate in overdrive voltages.	Not capable of overdrive operating voltages.
Fuse_VDD	Table 8, "Operating Ranges," on page 13 and Table 9, "Specific Operating Ranges for Silicon Revision 2.0," on page 14	Fusebox read Supply Voltage 1.65 min, 1.95 max.	In read mode, FUSE_VDD should be floated.
Ambient operating temperature range	Table 13, "Current Consumption for –40×C to 85×C, for Silicon Revision 2.0," on page 17, and Table 14, "Current Consumption for 0×C to 70×C, for Silicon Revision 2.0," on page 18	0°C min, 70°C max –40°C min, 85°C max	–40°C min, 85°C max
Current consumption values	Table 13, "Current Consumption for –40×C to 85×C, for Silicon Revision 2.0," on page 17	Typical value changes for State Retention, Doze, and Wait. See Table.	Typical value changes for State Retention, Doze, and Wait. See Table.
DPLL maximum output freq range	Table 31, "DPLL Specifications," on page 37	MPLL and SPLL = 532 MHz	MPLL and SPLL = 400 MHz

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Table 73. Product Differentiation (continued)

Item	Location	MCIMX31/MCIMX31L	MCIMX31C/MCIMX31LC
GPIO maximum input current (100 k Ω PU)	Table 15, "GPIO DC Electrical Parameters," on page 22	$\begin{aligned} &V_I = 0, \ I_{IN} = 25 \ \mu\text{A} \\ &V_I = \text{NVCC}, \ I_{IN} = 0.1 \ \mu\text{A} \end{aligned}$	N/A N/A
Core operating speed	Table 8, "Operating Ranges," on page 13	532 MHz	400 MHz
Package	Table 70, "Ball Map—14 x 14 0.5 mm Pitch," on page 117 and Table 71, "Ball Map—19 x 19 0.8 mm Pitch," on page 118	MAPBGA Packages 457 14 x 14 mm, 0.5 mm Pitch 473 19 x 19 mm, 0.8 mm Pitch	MAPBGA Package 473 19 x 19 mm, 0.8 mm Pitch
Pin Assignment	Table 66, "14 x 14 BGA Signal ID by Ball Grid Location," on page 107 and Table 69, "19 x 19 BGA Signal ID by Ball Grid Location," on page 113	MAPBGA Packages 457 14 x 14 mm, 0.5 mm Pitch 473 19 x 19 mm, 0.8 mm Pitch	MAPBGA Package 473 19 x 19 mm, 0.8 mm Pitch

7 Product Documentation

This Data Sheet is labeled as a particular type: Product Preview, Advance Information, or Technical Data. Definitions of these types are available at: http://www.freescale.com.

MCIMX31 Product Brief (order number MCIMX31PB)

MCIMX31 Reference Manual (order number MCIMX31RM)

MCIMX31 Chip Errata (order number MCIMX31CE)

The Freescale manuals are available on the Freescale Semiconductors Web site at http://www.freescale.com/imx. These documents may be downloaded directly from the Freescale Web site, or printed versions may be ordered. ARM Ltd. documentation is available from http://www.arm.com.

8 Revision History

Table 74 summarizes revisions to this document since the release of Rev. 3.4.

Table 74. Revision History

Rev.	Location	Revision
4	Figure 87, Table 73	Updated.
4.1	Table 1, "Ordering Information," on page 3	Added note about JTAG compliance.
4.1	Section 1.2.1/3	Updated with new operating frequencies
4.1	Table 8, "Operating Ranges," on page 13	Added new operating frequencies

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